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#### 1.1 Document overview

This document describes the features of the family and options available within the family members, and highlights important electrical and physical characteristics of the devices.

This document provides electrical specifications, pin assignments, and package diagrams for the MPC5643L series of microcontroller units (MCUs). For functional characteristics, see the MPC5643L Microcontroller Reference Manual. For use of the MPC5643Lin a fail-safe system according to safety standard ISO26262, see the Safety Application Guide for MPC5643L.

#### 1.2 Description

The MPC5643L series microcontrollers are system-on-chip devices that are built on Power Architecture technology and contain enhancements that improve the architecture's fit in embedded applications, include additional instruction support for digital signal processing (DSP) and integrate technologies such as an enhanced time processor unit, enhanced queued analog-to-digital converter, Controller Area Network, and an enhanced modular input-output system.

The MPC5643L family of 32-bit microcontrollers is the latest achievement in integrated automotive application controllers. It belongs to an expanding range of automotive-focused products designed to address electrical hydraulic power steering (EHPS), electric power steering (EPS) and airbag applications. The advanced and cost-efficient host processor core of the MPC5643L automotive controller family complies with the Power Architecture embedded category. It operates at speeds as high as 120 MHz and offers high-performance processing optimized for low power consumption. It capitalizes on the available development infrastructure of current Power Architecture devices and is supported with software drivers, operating systems and configuration code to assist with users' implementations.

## 1.3 Device comparison

Table 1. MPC5643L device summary

	Feature	MPC5643L
CPU	Туре	2 × e200z4 (in lock-step or decoupled operation)
	Architecture	Harvard
	Execution speed	0–120 MHz (+2% FM)
	DMIPS intrinsic performance	>240 MIPS
	SIMD (DSP + FPU)	Yes
	MMU	16 entry
	Instruction set PPC	Yes
	Instruction set VLE	Yes
	Instruction cache	4 KB, EDC
	MPU-16 regions	Yes, replicated module
	Semaphore unit (SEMA4)	Yes
Buses	Core bus	AHB, 32-bit address, 64-bit data
	Internal periphery bus	32-bit address, 32-bit data
Crossbar	Master × slave ports	Lock Step Mode: 4 × 3 Decoupled Parallel Mode: 6 × 3

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Table 1. MPC5643L device summary (continued)

	Feature	MPC5643L			
Memory	Flash	1 MB, ECC, RWW			
	Static RAM (SRAM)	128 KB, ECC			
Modules	Interrupt Controller (INTC)	16 interrupt levels, replicated module			
	Periodic Interrupt Timer (PIT)	1 x 4 channels			
	System Timer Module (STM)	1 x 4 channels, replicated module			
	Software Watchdog Timer (SWT)	Yes, replicated module			
	eDMA	16 channels, replicated module			
	FlexRay	1 x 64 message buffers, dual channel			
	FlexCAN	2 x 32 message buffers			
	LINFlexD (UART and LIN with DMA support)	2			
	Clock out	Yes			
	Fault Collection and Control Unit (FCCU)	Yes			
	Cross Triggering Unit (CTU)	Yes			
	eTimer	3 × 6 channels <sup>1</sup>			
	FlexPWM	2 Module 4 x (2 + 1) channels <sup>2</sup>			
	Analog-to-Digital Converter (ADC)	2 x 12-bit ADC, 16 channels per ADC (3 internal, 4 shared and 9 external)			
	Sine Wave Generator (SWG)	32 point			
Modules (cont.)	Deserial Serial Peripheral Interface (DSPI)	3 x DSPI as many as 8 chip selects			
	Cyclic Redundancy Checker (CRC) unit	Yes			
	Junction temperature sensor (TSENS)	Yes, replicated module			
	Digital I/Os	≥ 16			
Supply	Device power supply	3.3 V with integrated bypassable ballast transistor External ballast transistor not needed for bare die			
	Analog reference voltage	3.0 V – 3.6 V and 4.5 V – 5.5 V			
Clocking	Frequency-modulated phase-locked loop (FMPLL)	2			
	Internal RC oscillator	16 MHz			
	External crystal oscillator	4 – 40 MHz			
Debug	Nexus	Level 3+			



Table 1. MPC5643L device summary (continued)

	Feature	MPC5643L
Packages	LQFP	144 pins
	MAPBGA	257 MAPBGA
Temperature	Temperature range (junction)	−40 to 150 °C
	Ambient temperature range using external ballast transistor (LQFP)	-40 to 125 °C
	Ambient temperature range using external ballast transistor (BGA)	–40 to 125 °C

The third eTimer (eTimer\_2) is available with external I/O access only in the BGA package, on the LQFP package eTimer\_2 is available internally only without any external I/O access.

# 1.4 Block diagram

Figure 1 shows a top-level block diagram of the MPC5643L device.

<sup>&</sup>lt;sup>2</sup> The second FlexPWM module is available only in the BGA package.



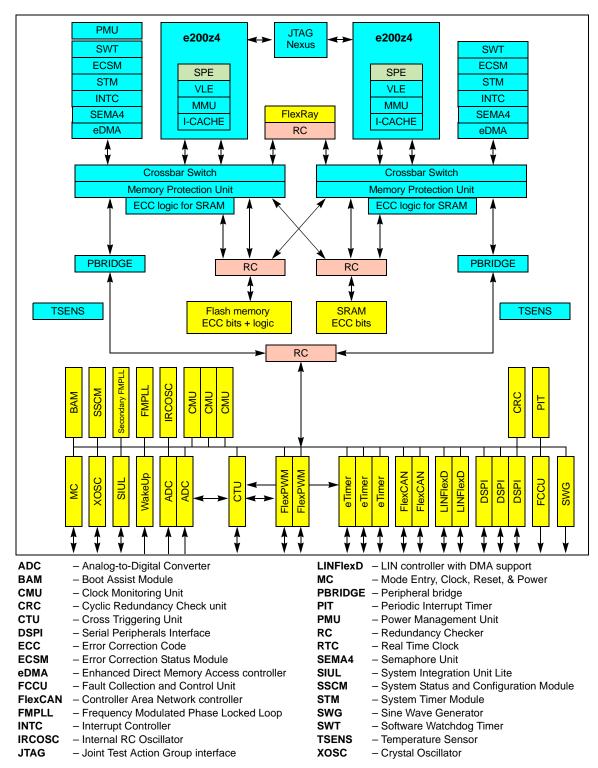


Figure 1. MPC5643L block diagram



#### 1.5 Feature details

## 1.5.1 High-performance e200z4d core

The e200z4d Power Architecture® core provides the following features:

- 2 independent execution units, both supporting fixed-point and floating-point operations
- Dual issue 32-bit Power Architecture technology compliant
  - 5-stage pipeline (IF, DEC, EX1, EX2, WB)
  - In-order execution and instruction retirement
- Full support for Power Architecture instruction set and Variable Length Encoding (VLE)
  - Mix of classic 32-bit and 16-bit instruction allowed
  - Optimization of code size possible
- Thirty-two 64-bit general purpose registers (GPRs)
- Harvard bus (32-bit address, 64-bit data)
  - I-Bus interface capable of one outstanding transaction plus one piped with no wait-on-data return
  - D-Bus interface capable of two transactions outstanding to fill AHB pipe
- I-cache and I-cache controller
  - 4 KB, 256-bit cache line (programmable for 2- or 4-way)
- · No data cache
- 16-entry MMU
- 8-entry branch table buffer
- Branch look-ahead instruction buffer to accelerate branching
- Dedicated branch address calculator
- 3 cycles worst case for missed branch
- Load/store unit
  - Fully pipelined
  - Single-cycle load latency
  - Big- and little-endian modes supported
  - Misaligned access support
  - Single stall cycle on load to use
- Single-cycle throughput (2-cycle latency) integer  $32 \times 32$  multiplication
- 4-14 cycles integer  $32 \times 32$  division (average division on various benchmark of nine cycles)
- Single precision floating-point unit
  - 1 cycle throughput (2-cycle latency) floating-point  $32 \times 32$  multiplication
  - Target 9 cycles (worst case acceptable is 12 cycles) throughput floating-point  $32 \times 32$  division
  - Special square root and min/max function implemented
- Signal processing support: APU-SPE 1.1
  - Support for vectorized mode: as many as two floating-point instructions per clock
- Vectored interrupt support
- Reservation instruction to support read-modify-write constructs
- Extensive system development and tracing support via Nexus debug port



#### 1.5.2 Crossbar switch (XBAR)

The XBAR multi-port crossbar switch supports simultaneous connections between four master ports and three slave ports. The crossbar supports a 32-bit address bus width and a 64-bit data bus width.

The crossbar allows four concurrent transactions to occur from any master port to any slave port, although one of those transfers must be an instruction fetch from internal flash memory. If a slave port is simultaneously requested by more than one master port, arbitration logic selects the higher priority master and grants it ownership of the slave port. All other masters requesting that slave port are stalled until the higher priority master completes its transactions.

The crossbar provides the following features:

- 4 masters and 3 slaves supported per each replicated crossbar
  - Masters allocation for each crossbar: e200z4d core with two independent bus interface units (BIU) for I and D access (2 masters), one eDMA, one FlexRay
  - Slaves allocation for each crossbar: a redundant flash-memory controller with 2 slave ports to guarantee maximum flexibility to handle Instruction and Data array, one redundant SRAM controller with 1 slave port each and 1 redundant peripheral bus bridge
- 32-bit address bus and 64-bit data bus
- Programmable arbitration priority
  - Requesting masters can be treated with equal priority and are granted access to a slave port in round-robin method, based upon the ID of the last master to be granted access or a priority order can be assigned by software at application run time
- Temporary dynamic priority elevation of masters

The XBAR is replicated for each processing channel.

## 1.5.3 Memory Protection Unit (MPU)

The Memory Protection Unit splits the physical memory into 16 different regions. Each master (eDMA, FlexRay, CPU) can be assigned different access rights to each region.

- 16-region MPU with concurrent checks against each master access
- 32-byte granularity for protected address region

The memory protection unit is replicated for each processing channel.

## 1.5.4 Enhanced Direct Memory Access (eDMA)

The enhanced direct memory access (eDMA) controller is a second-generation module capable of performing complex data movements via 16 programmable channels, with minimal intervention from the host processor. The hardware microarchitecture includes a DMA engine which performs source and destination address calculations, and the actual data movement operations, along with an SRAM-based memory containing the transfer control descriptors (TCD) for the channels. This implementation is used to minimize the overall block size.

The eDMA module provides the following features:

- 16 channels supporting 8-, 16-, and 32-bit value single or block transfers
- Support variable sized queues and circular buffered queue
- Source and destination address registers independently configured to post-increment or stay constant
- Support major and minor loop offset
- Support minor and major loop done signals
- DMA task initiated either by hardware requestor or by software
- Each DMA task can optionally generate an interrupt at completion and retirement of the task
- Signal to indicate closure of last minor loop



• Transfer control descriptors mapped inside the SRAM

The eDMA controller is replicated for each processing channel.

#### 1.5.5 On-chip flash memory with ECC

This device includes programmable, non-volatile flash memory. The non-volatile memory (NVM) can be used for instruction storage or data storage, or both. The flash memory module interfaces with the system bus through a dedicated flash memory array controller. It supports a 64-bit data bus width at the system bus port, and a 128-bit read data interface to flash memory. The module contains four 128-bit prefetch buffers. Prefetch buffer hits allow no-wait responses. Buffer misses incur a 3 wait state response at 120 MHz.

The flash memory module provides the following features

- 1 MB of flash memory in unique multi-partitioned hard macro
- Sectorization:  $16 \text{ KB} + 2 \times 48 \text{ KB} + 16 \text{ KB} + 2 \times 64 \text{ KB} + 2 \times 128 \text{ KB} + 2 \times 256 \text{ KB}$
- EEPROM emulation (in software) within same module but on different partition
- 16 KB test sector and 16 KB shadow block for test, censorship device and user option bits
- Wait states:
  - 3 wait states for frequencies =< 120 MHz
  - 2 wait states for frequencies =< 80 MHz
  - 1 wait state for frequencies =< 60 MHz
- Flash memory line 128-bit wide with 8-bit ECC on 64-bit word (total 144 bits)
- Accessed via a 64-bit wide bus for write and a 128-bit wide array for read operations
- 1-bit error correction, 2-bit error detection

## 1.5.6 On-chip SRAM with ECC

The MPC5643L SRAM provides a general-purpose single port memory.

ECC handling is done on a 32-bit boundary for data and it is extended to the address to have the highest possible diagnostic coverage including the array internal address decoder.

The SRAM module provides the following features:

- System SRAM: 128 KB
- ECC on 32-bit word (syndrome of 7 bits)
  - ECC covers SRAM bus address
- 1-bit error correction, 2-bit error detection
- Wait states:
  - 1 wait state for frequencies =< 120 MHz
  - 0 wait states for frequencies =< 80 MHz

# 1.5.7 Platform flash memory controller

The following list summarizes the key features of the flash memory controller:

- Single AHB port interface supports a 64-bit data bus. All AHB aligned and unaligned reads within the 32-bit container are supported. Only aligned word writes are supported.
- Array interfaces support a 128-bit read data bus and a 64-bit write data bus for each bank.
- Code flash (bank0) interface provides configurable read buffering and page prefetch support.
  - Four page-read buffers (each 128 bits wide) and a prefetch controller support speculative reading and optimized flash access.

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- Single-cycle read responses (0 AHB data-phase wait states) for hits in the buffers. The buffers implement a least-recently-used replacement algorithm to maximize performance.
- Programmable response for read-while-write sequences including support for stall-while-write, optional stall notification interrupt, optional flash operation abort , and optional abort notification interrupt.
- Separate and independent configurable access timing (on a per bank basis) to support use across a wide range of platforms and frequencies.
- Support of address-based read access timing for emulation of other memory types.
- Support for reporting of single- and multi-bit error events.
- Typical operating configuration loaded into programming model by system reset.

The platform flash controller is replicated for each processor.

## 1.5.8 Platform Static RAM Controller (SRAMC)

The SRAMC module is the platform SRAM array controller, with integrated error detection and correction.

The main features of the SRAMC provide connectivity for the following interfaces:

- XBAR Slave Port (64-bit data path)
- ECSM (ECC Error Reporting, error injection and configuration)
- SRAM array

The following functions are implemented:

- ECC encoding (32-bit boundary for data and complete address bus)
- ECC decoding (32-bit boundary and entire address)
- Address translation from the AHB protocol on the XBAR to the SRAM array

The platform SRAM controller is replicated for each processor.

# 1.5.9 Memory subsystem access time

Every memory access the CPU performs requires at least one system clock cycle for the data phase of the access. Slower memories or peripherals may require additional data phase wait states. Additional data phase wait states may also occur if the slave being accessed is not parked on the requesting master in the crossbar.

Table 2 shows the number of additional data phase wait states required for a range of memory accesses.

Table 2. Platform memory access time summary

AHB transfer	Data phase wait states	Description
e200z4d instruction fetch	0	Flash memory prefetch buffer hit (page hit)
e200z4d instruction fetch	3	Flash memory prefetch buffer miss (based on 4-cycle random flash array access time)
e200z4d data read	0–1	SRAM read
e200z4d data write	0	SRAM 32-bit write

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Table 2. Platform memory access time summary (continued)
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AHB transfer	Data phase wait states	Description
e200z4d data write	0	SRAM 64-bit write (executed as 2 x 32-bit writes)
e200z4d data write	0–2	SRAM 8-,16-bit write (Read-modify-Write for ECC)
e200z4d flash memory read	0	Flash memory prefetch buffer hit (page hit)
e200z4d flash memory read	3	Flash memory prefetch buffer miss (at 120 MHz; includes 1 cycle of program flash memory controller arbitration)

### 1.5.10 Error Correction Status Module (ECSM)

The ECSM on this device manages the ECC configuration and reporting for the platform memories (flash memory and SRAM). It does not implement the actual ECC calculation. A detected error (double error for flash memory or SRAM) is also reported to the FCCU. The following errors and indications are reported into the ECSM dedicated registers:

- ECC error status and configuration for flash memory and SRAM
- ECC error reporting for flash memory
- ECC error reporting for SRAM
- ECC error injection for SRAM

## 1.5.11 Peripheral bridge (PBRIDGE)

The PBRIDGE implements the following features:

- · Duplicated periphery
- Master access privilege level per peripheral (per master: read access enable; write access enable)
- Checker applied on PBRIDGE output toward periphery
- Byte endianess swap capability

# 1.5.12 Interrupt Controller (INTC)

The INTC provides priority-based preemptive scheduling of interrupt requests, suitable for statically scheduled hard real-time systems.

For high-priority interrupt requests, the time from the assertion of the interrupt request from the peripheral to when the processor is executing the interrupt service routine (ISR) has been minimized. The INTC provides a unique vector for each interrupt request source for quick determination of which ISR needs to be executed. It also provides an ample number of priorities so that lower priority ISRs do not delay the execution of higher priority ISRs. To allow the appropriate priorities for each source of interrupt request, the priority of each interrupt request is software configurable.

The INTC supports the priority ceiling protocol for coherent accesses. By providing a modifiable priority mask, the priority can be raised temporarily so that all tasks which share the resource can not preempt each other.

The INTC provides the following features:

- Duplicated periphery
- Unique 9-bit vector per interrupt source
- 16 priority levels with fixed hardware arbitration within priority levels for each interrupt source
- · Priority elevation for shared resource

The INTC is replicated for each processor.

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#### 1.5.13 System clocks and clock generation

The following list summarizes the system clock and clock generation on this device:

- Lock status continuously monitored by lock detect circuitry
- · Loss-of-clock (LOC) detection for reference and feedback clocks
- On-chip loop filter (for improved electromagnetic interference performance and fewer external components required)
- Programmable output clock divider of system clock  $(\div 1, \div 2, \div 4, \div 8)$
- FlexPWM module and as many as three eTimer modules running on an auxiliary clock independent from system clock (with max frequency 120 MHz)
- On-chip crystal oscillator with automatic level control
- Dedicated internal 16 MHz internal RC oscillator for rapid start-up
  - Supports automated frequency trimming by hardware during device startup and by user application
- Auxiliary clock domain for motor control periphery (FlexPWM, eTimer, CTU, ADC, and SWG)

### 1.5.14 Frequency-Modulated Phase-Locked Loop (FMPLL)

Each device has two FMPLLs.

Each FMPLL allows the user to generate high speed system clocks starting from a minimum reference of 4 MHz input clock. Further, the FMPLL supports programmable frequency modulation of the system clock. The FMPLL multiplication factor, output clock divider ratio are all software configurable. The FMPLLs have the following major features:

- Input frequency: 4–40 MHz continuous range (limited by the crystal oscillator)
- Voltage controlled oscillator (VCO) range: 256–512 MHz
- Frequency modulation via software control to reduce and control emission peaks
  - Modulation depth ±2% if centered or 0% to -4% if downshifted via software control register
  - Modulation frequency: triangular modulation with 25 kHz nominal rate
- Option to switch modulation on and off via software interface
- Output divider (ODF) for reduced frequency operation without re-lock
- 3 modes of operation
  - Bypass mode
  - Normal FMPLL mode with crystal reference (default)
  - Normal FMPLL mode with external reference
- · Lock monitor circuitry with lock status
- Loss-of-lock detection for reference and feedback clocks
- Self-clocked mode (SCM) operation
- On-chip loop filter
- Auxiliary FMPLL
  - Used for FlexRay due to precise symbol rate requirement by the protocol
  - Used for motor control periphery and connected IP (A/D digital interface CTU) to allow independent frequencies
    of operation for PWM and timers and jitter-free control
  - Option to enable/disable modulation to avoid protocol violation on jitter and/or potential unadjusted error in electric motor control loop
  - Allows to run motor control periphery at different (precisely lower, equal or higher as required) frequency than
    the system to ensure higher resolution

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#### 1.5.15 Main oscillator

The main oscillator provides these features:

- Input frequency range 4–40 MHz
- Crystal input mode
- External reference clock (3.3 V) input mode
- FMPLL reference

#### 1.5.16 Internal Reference Clock (RC) oscillator

The architecture uses constant current charging of a capacitor. The voltage at the capacitor is compared to the stable bandgap reference voltage. The RC oscillator is the device safe clock.

The RC oscillator provides these features:

- Nominal frequency 16 MHz
- $\pm 5\%$  variation over voltage and temperature after process trim
- Clock output of the RC oscillator serves as system clock source in case loss of lock or loss of clock is detected by the FMPLL
- RC oscillator is used as the default system clock during startup and can be used as back-up input source of FMPLL(s)
  in case XOSC fails

# 1.5.17 Clock, reset, power, mode and test control modules (MC\_CGM, MC\_RGM, MC\_PCU, and MC\_ME)

These modules provide the following:

- Clock gating and clock distribution control
- Halt, stop mode control
- Flexible configurable system and auxiliary clock dividers
- Various execution modes
  - HALT and STOP mode as reduced activity low power mode
  - Reset, Idle, Test, Safe
  - Various RUN modes with software selectable powered modules
  - No stand-by mode implemented (no internal switchable power domains)

## 1.5.18 Periodic Interrupt Timer Module (PIT)

The PIT module implements the following features:

- 4 general purpose interrupt timers
- 32-bit counter resolution
- Can be used for software tick or DMA trigger operation

## 1.5.19 System Timer Module (STM)

The STM implements the following features:

- Up-counter with 4 output compare registers
- OS task protection and hardware tick implementation per AUTOSAR<sup>1</sup> requirement

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The STM is replicated for each processor.

## 1.5.20 Software Watchdog Timer (SWT)

This module implements the following features:

- Fault tolerant output
- Safe internal RC oscillator as reference clock
- · Windowed watchdog
- Program flow control monitor with 16-bit pseudorandom key generation
- Allows a high level of safety (SIL3 monitor)

The SWT module is replicated for each processor.

#### 1.5.21 Fault Collection and Control Unit (FCCU)

The FCCU module has the following features:

- Redundant collection of hardware checker results
- Redundant collection of error information and latch of faults from critical modules on the device
- Collection of self-test results
- Configurable and graded fault control
  - Internal reactions (no internal reaction, IRQ, Functional Reset, Destructive Reset, or Safe mode entered)
  - External reaction (failure is reported to the external/surrounding system via configurable output pins)

## 1.5.22 System Integration Unit Lite (SIUL)

The SIUL controls MCU reset configuration, pad configuration, external interrupt, general purpose I/O (GPIO), internal peripheral multiplexing, and system reset operation. The reset configuration block contains the external pin boot configuration logic. The pad configuration block controls the static electrical characteristics of I/O pins. The GPIO block provides uniform and discrete input/output control of the I/O pins of the MCU.

The SIU provides the following features:

- Centralized pad control on a per-pin basis
  - Pin function selection
  - Configurable weak pull-up/down
  - Configurable slew rate control (slow/medium/fast)
  - Hysteresis on GPIO pins
  - Configurable automatic safe mode pad control
- Input filtering for external interrupts

# 1.5.23 Non-Maskable Interrupt (NMI)

The non-maskable interrupt with de-glitching filter supports high-priority core exceptions.

# 1.5.24 Boot Assist Module (BAM)

The BAM is a block of read-only memory with hard-coded content. The BAM program is executed only if serial booting mode is selected via boot configuration pins.

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The BAM provides the following features:

- Enables booting via serial mode (FlexCAN or LINFlex-UART)
- Supports programmable 64-bit password protection for serial boot mode
- Supports serial bootloading of either Power Architecture code (default) or Freescale VLE code
- Automatic switch to serial boot mode if internal flash memory is blank or invalid

#### 1.5.25 System Status and Configuration Module (SSCM)

The SSCM on this device features the following:

- · System configuration and status
- Debug port status and debug port enable
- Multiple boot code starting locations out of reset through implementation of search for valid Reset Configuration Half Word
- Sets up the MMU to allow user boot code to execute as either Power Architecture code (default) or as Freescale VLE code out of flash memory
- Triggering of device self-tests during reset phase of device boot

#### 1.5.26 FlexCAN

The FlexCAN module is a communication controller implementing the CAN protocol according to Bosch Specification version 2.0B. The CAN protocol was designed to be used primarily as a vehicle serial data bus, meeting the specific requirements of this field: real-time processing, reliable operation in the EMI environment of a vehicle, cost-effectiveness and required bandwidth.

The FlexCAN module provides the following features:

- Full implementation of the CAN protocol specification, version 2.0B
  - Standard data and remote frames
  - Extended data and remote frames
  - 0 to 8 bytes data length
  - Programmable bit rate as fast as 1Mbit/s
- 32 message buffers of 0 to 8 bytes data length
- · Each message buffer configurable as receive or transmit buffer, all supporting standard and extended messages
- Programmable loop-back mode supporting self-test operation
- 3 programmable mask registers
- Programmable transmit-first scheme: lowest ID or lowest buffer number
- Time stamp based on 16-bit free-running timer
- Global network time, synchronized by a specific message
- Maskable interrupts
- Independent of the transmission medium (an external transceiver is assumed)
- High immunity to EMI
- Short latency time due to an arbitration scheme for high-priority messages
- Transmit features
  - Supports configuration of multiple mailboxes to form message queues of scalable depth
  - Arbitration scheme according to message ID or message buffer number
  - Internal arbitration to guarantee no inner or outer priority inversion
  - Transmit abort procedure and notification
- Receive features

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- Individual programmable filters for each mailbox
- 8 mailboxes configurable as a 6-entry receive FIFO
- 8 programmable acceptance filters for receive FIFO
- · Programmable clock source
  - System clock
  - Direct oscillator clock to avoid FMPLL jitter

#### 1.5.27 FlexRay

The FlexRay module provides the following features:

- Full implementation of FlexRay Protocol Specification 2.1 Rev. A
- 64 configurable message buffers can be handled
- Dual channel or single channel mode of operation, each as fast as 10 Mbit/s data rate
- Message buffers configurable as transmit or receive
- Message buffer size configurable
- Message filtering for all message buffers based on Frame ID, cycle count, and message ID
- Programmable acceptance filters for receive FIFO
- Message buffer header, status, and payload data stored in system memory (SRAM)
- Internal FlexRay memories have error detection and correction

## 1.5.28 Serial communication interface module (LINFlexD)

The LINFlexD module (LINFlex with DMA support) on this device features the following:

- Supports LIN Master mode, LIN Slave mode and UART mode
- LIN state machine compliant to LIN1.3, 2.0, and 2.1 specifications
- Manages LIN frame transmission and reception without CPU intervention
- · LIN features
  - Autonomous LIN frame handling
  - Message buffer to store as many as 8 data bytes
  - Supports messages as long as 64 bytes
  - Detection and flagging of LIN errors (Sync field, delimiter, ID parity, bit framing, checksum and Time-out errors)
  - Classic or extended checksum calculation
  - Configurable break duration of up to 50-bit times
  - Programmable baud rate prescalers (13-bit mantissa, 4-bit fractional)
  - Diagnostic features (Loop back, LIN bus stuck dominant detection)
  - Interrupt driven operation with 16 interrupt sources
- LIN slave mode features
  - Autonomous LIN header handling
  - Autonomous LIN response handling
- UART mode
  - Full-duplex operation
  - Standard non return-to-zero (NRZ) mark/space format
  - Data buffers with 4-byte receive, 4-byte transmit
  - Configurable word length (8-bit, 9-bit, 16-bit, or 17-bit words)
  - Configurable parity scheme: none, odd, even, always 0
  - Speed as fast as 2 Mbit/s



- Error detection and flagging (Parity, Noise and Framing errors)
- Interrupt driven operation with four interrupt sources
- Separate transmitter and receiver CPU interrupt sources
- 16-bit programmable baud-rate modulus counter and 16-bit fractional
- Two receiver wake-up methods
- Support for DMA enabled transfers

## 1.5.29 Deserial Serial Peripheral Interface (DSPI)

The DSPI modules provide a synchronous serial interface for communication between the MPC5643L and external devices.

A DSPI module provides these features:

- Full duplex, synchronous transfers
- · Master or slave operation
- Programmable master bit rates
- Programmable clock polarity and phase
- · End-of-transmission interrupt flag
- Programmable transfer baud rate
- Programmable data frames from 4 to 16 bits
- As many as 8 chip select lines available, depending on package and pin multiplexing
- 4 clock and transfer attributes registers
- Chip select strobe available as alternate function on one of the chip select pins for de-glitching
- FIFOs for buffering as many as 5 transfers on the transmit and receive side
- Queueing operation possible through use of the eDMA
- General purpose I/O functionality on pins when not used for SPI

#### 1.5.30 FlexPWM

The pulse width modulator module (FlexPWM) contains four PWM channels, each of which is configured to control a single half-bridge power stage. Two modules are included on 257 MAPBGA devices; on the 144 LQFP package, only one module is present. Additionally, four fault input channels are provided per FlexPWM module.

This PWM is capable of controlling most motor types, including:

- AC induction motors (ACIM)
- Permanent Magnet AC motors (PMAC)
- Brushless (BLDC) and brush DC motors (BDC)
- Switched (SRM) and variable reluctance motors (VRM)
- Stepper motors

A FlexPWM module implements the following features:

- 16 bits of resolution for center, edge aligned, and asymmetrical PWMs
- Maximum operating frequency as high as 120 MHz
  - Clock source not modulated and independent from system clock (generated via secondary FMPLL)
- Fine granularity control for enhanced resolution of the PWM period
- PWM outputs can operate as complementary pairs or independent channels
- Ability to accept signed numbers for PWM generation
- Independent control of both edges of each PWM output
- Synchronization to external hardware or other PWM supported

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- Double buffered PWM registers
  - Integral reload rates from 1 to 16
  - Half cycle reload capability
- Multiple ADC trigger events can be generated per PWM cycle via hardware
- Fault inputs can be assigned to control multiple PWM outputs
- Programmable filters for fault inputs
- Independently programmable PWM output polarity
- Independent top and bottom deadtime insertion
- Each complementary pair can operate with its own PWM frequency and deadtime values
- Individual software control for each PWM output
- All outputs can be forced to a value simultaneously
- PWMX pin can optionally output a third signal from each channel
- · Channels not used for PWM generation can be used for buffered output compare functions
- Channels not used for PWM generation can be used for input capture functions
- Enhanced dual edge capture functionality
- Option to supply the source for each complementary PWM signal pair from any of the following:
  - External digital pin
  - Internal timer channel
  - External ADC input, taking into account values set in ADC high- and low-limit registers
- DMA support

#### 1.5.31 eTimer module

The MPC5643L provides three eTimer modules (on the LQFP package eTimer\_2 is available internally only without any external I/O access). Six 16-bit general purpose up/down timer/counters per module are implemented with the following features:

- Maximum clock frequency of 120 MHz
- Individual channel capability
  - Input capture trigger
  - Output compare
  - Double buffer (to capture rising edge and falling edge)
  - Separate prescaler for each counter
  - Selectable clock source
  - 0–100% pulse measurement
  - Rotation direction flag (Quad decoder mode)
- Maximum count rate
  - Equals peripheral clock divided by 2 for external event counting
  - Equals peripheral clock for internal clock counting
- Cascadeable counters
- Programmable count modulo
- Quadrature decode capabilities
- Counters can share available input pins
- Count once or repeatedly
- Preloadable counters
- Pins available as GPIO when timer functionality not in use
- · DMA support

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## 1.5.32 Sine Wave Generator (SWG)

A digital-to-analog converter is available to generate a sine wave based on 32 stored values for external devices (ex: resolver).

## 1.5.33 Analog-to-Digital Converter module (ADC)

The ADC module features include:

#### Analog part:

- 2 on-chip ADCs
  - 12-bit resolution SAR architecture
  - Same digital interface as in the MPC5604P family
  - A/D Channels: 9 external, 3 internal and 4 shared with other A/D (total 16 channels)
  - One channel dedicated to each T-sensor to enable temperature reading during application
  - Separated reference for each ADC
  - Shared analog supply voltage for both ADCs
  - One sample and hold unit per ADC
  - Adjustable sampling and conversion time

#### Digital part:

- 4 analog watchdogs comparing ADC results against predefined levels (low, high, range) before results are stored in the appropriate ADC result location
- 2 modes of operation: CPU Mode or CTU Mode
- CPU mode features
  - Register based interface with the CPU: one result register per channel
  - ADC state machine managing three request flows: regular command, hardware injected command, software injected command
  - Selectable priority between software and hardware injected commands
  - 4 analog watchdogs comparing ADC results against predefined levels (low, high, range)
  - DMA compatible interface
- CTU mode features
  - Triggered mode only
  - 4 independent result queues (1  $\times$  16 entries, 2  $\times$  8 entries, 1  $\times$  4 entries)
  - Result alignment circuitry (left justified; right justified)
  - 32-bit read mode allows to have channel ID on one of the 16-bit parts
  - DMA compatible interfaces
- Built-in self-test features triggered by software

## 1.5.34 Cross Triggering Unit (CTU)

The ADC cross triggering unit allows automatic generation of ADC conversion requests on user selected conditions without CPU load during the PWM period and with minimized CPU load for dynamic configuration.

The CTU implements the following features:

- Cross triggering between ADC, FlexPWM, eTimer, and external pins
- Double buffered trigger generation unit with as many as 8 independent triggers generated from external triggers
- Maximum operating frequency less than or equal to 120 MHz
- Trigger generation unit configurable in sequential mode or in triggered mode
- · Trigger delay unit to compensate the delay of external low pass filter

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- Double buffered global trigger unit allowing eTimer synchronization and/or ADC command generation
- Double buffered ADC command list pointers to minimize ADC-trigger unit update
- Double buffered ADC conversion command list with as many as 24 ADC commands
- Each trigger capable of generating consecutive commands
- ADC conversion command allows control of ADC channel from each ADC, single or synchronous sampling, independent result queue selection
- DMA support with safety features

## 1.5.35 Cyclic Redundancy Checker (CRC) Unit

The CRC module is a configurable multiple data flow unit to compute CRC signatures on data written to its input register.

The CRC unit has the following features:

- 3 sets of registers to allow 3 concurrent contexts with possibly different CRC computations, each with a selectable polynomial and seed
- Computes 16- or 32-bit wide CRC on the fly (single-cycle computation) and stores result in internal register. The following standard CRC polynomials are implemented:

$$- x^8 + x^4 + x^3 + x^2 + 1 \text{ [8-bit CRC]}$$

$$- x^{16} + x^{12} + x^5 + 1 \text{ [16-bit CRC-CCITT]}$$

$$- x^{32} + x^{26} + x^{23} + x^{22} + x^{16} + x^{12} + x^{11} + x^{10} + x^8 + x^7 + x^5 + x^4 + x^2 + x + 1$$

$$\text{[32-bit CRC-ethernet(32)]}$$

- Key engine to be coupled with communication periphery where CRC application is added to allow implementation of safe communication protocol
- Offloads core from cycle-consuming CRC and helps checking configuration signature for safe start-up or periodic procedures
- CRC unit connected as peripheral bus on internal peripheral bus
- DMA support

# 1.5.36 Redundancy Control and Checker Unit (RCCU)

The RCCU checks all outputs of the sphere of replication (addresses, data, control signals). It has the following features:

- Duplicated module to guarantee highest possible diagnostic coverage (check of checker)
- Multiple times replicated IPs are used as checkers on the SoR outputs

## 1.5.37 Junction temperature sensor

The junction temperature sensor provides a value via an ADC channel that can be used by software to calculate the device junction temperature.

The key parameters of the junction temperature sensor include:

- Nominal temperature range from -40 to 150 °C
- Software temperature alarm via analog ADC comparator possible

## 1.5.38 Nexus Port Controller (NPC)

The NPC module provides real-time development support capabilities for this device in compliance with the IEEE-ISTO 5001-2003. This development support is supplied for MCUs without requiring external address and data pins for internal visibility.

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The NPC block interfaces to the host processor and internal buses to provide development support as per the IEEE-ISTO 5001-2003 Class 3+, including selected features from Class 4 standard.

The development support provided includes program trace, data trace, watchpoint trace, ownership trace, run-time access to the MCUs internal memory map and access to the Power Architecture internal registers during halt. The Nexus interface also supports a JTAG only mode using only the JTAG pins. The following features are implemented:

- Full and reduced port modes
- MCKO (message clock out) pin
- 4 or 12 MDO (message data out) pins<sup>1</sup>
- 2 MSEO (message start/end out) pins
- EVTO (event out) pin
  - Auxiliary input port
- EVTI (event in) pin
- 5-pin JTAG port (JCOMP, TDI, TDO, TMS, and TCK)
  - Supports JTAG mode
- Host processor (e200) development support features
  - Data trace via data write messaging (DWM) and data read messaging (DRM). This allows the development tool to trace reads or writes, or both, to selected internal memory resources.
  - Ownership trace via ownership trace messaging (OTM). OTM facilitates ownership trace by providing visibility of which process ID or operating system task is activated. An ownership trace message is transmitted when a new process/task is activated, allowing development tools to trace ownership flow.
  - Program trace via branch trace messaging (BTM). Branch trace messaging displays program flow discontinuities (direct branches, indirect branches, exceptions, etc.), allowing the development tool to interpolate what transpires between the discontinuities. Thus, static code may be traced.
  - Watchpoint messaging (WPM) via the auxiliary port
  - Watchpoint trigger enable of program and/or data trace messaging
  - Data tracing of instruction fetches via private opcodes

# 1.5.39 IEEE 1149.1 JTAG Controller (JTAGC)

The JTAGC block provides the means to test chip functionality and connectivity while remaining transparent to system logic when not in test mode. All data input to and output from the JTAGC block is communicated in serial format. The JTAGC block is compliant with the IEEE standard.

The JTAG controller provides the following features:

- IEEE Test Access Port (TAP) interface with 5 pins:
  - TDI
  - TMS
  - TCK
  - TDO
  - JCOMP
- Selectable modes of operation include JTAGC/debug or normal system operation
- 5-bit instruction register that supports the following IEEE 1149.1-2001 defined instructions:
  - BYPASS
  - IDCODE

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<sup>1. 4</sup> MDO pins on 144 LQFP package, 12 MDO pins on 257 MAPBGA package.



- EXTEST
- SAMPLE
- SAMPLE/PRELOAD
- 3 test data registers: a bypass register, a boundary scan register, and a device identification register. The size of the boundary scan register is parameterized to support a variety of boundary scan chain lengths.
- TAP controller state machine that controls the operation of the data registers, instruction register and associated circuitry

#### 1.5.40 Voltage regulator / Power Management Unit (PMU)

The on-chip voltage regulator module provides the following features:

- · Single external rail required
- Single high supply required: nominal 3.3 V both for packaged and Known Good Die option
  - Packaged option requires external ballast transistor due to reduced dissipation capacity at high temperature but can use embedded transistor if power dissipation is maintained within package dissipation capacity (lower frequency of operation)
  - Known Good Die option uses embedded ballast transistor as dissipation capacity is increased to reduce system
    cost
- All I/Os are at same voltage as external supply (3.3 V nominal)
- Duplicated Low-Voltage Detectors (LVD) to guarantee proper operation at all stages (reset, configuration, normal operation) and, to maximize safety coverage, one LVD can be tested while the other operates (on-line self-testing feature)

## 1.5.41 Built-In Self-Test (BIST) capability

This device includes the following protection against latent faults:

- Boot-time Memory Built-In Self-Test (MBIST)
- Boot-time scan-based Logic Built-In Self-Test (LBIST)
- Run-time ADC Built-In Self-Test (BIST)
- Run-time Built-In Self Test of LVDs

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# 2.1 Package pinouts

Figure 2 shows the MPC5643L in the 144 LQFP package.

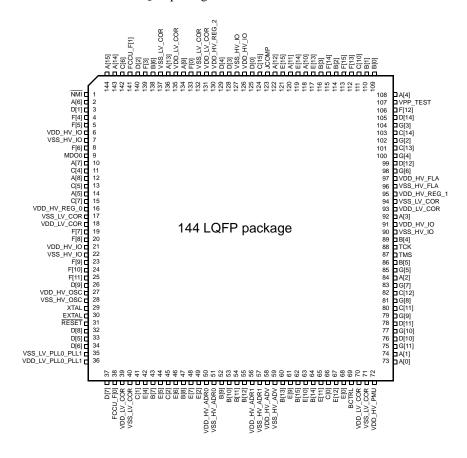


Figure 2. MPC5643L 144 LQFP pinout (top view)

Figure 3 shows the MPC5643L in the 257 MAPBGA package.



	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17
Α	V <sub>SS_HV</sub>	V <sub>SS_HV</sub> _IO	V <sub>DD_HV</sub>	H[2]	H[0]	G[14]	D[3]	C[15]	V <sub>DD_HV</sub> _IO	A[12]	H[10]	H[14]	A[10]	B[2]	C[10]	V <sub>SS_HV</sub> _IO	V <sub>SS_HV</sub>
В	V <sub>SS_HV</sub>	V <sub>SS_HV</sub> _IO	B[6]	A[14]	F[3]	A[9]	D[4]	D[0]	V <sub>SS_HV</sub>	H[12]	E[15]	E[14]	B[3]	F[13]	B[0]	V <sub>DD_HV</sub>	V <sub>SS_HV</sub>
С	V <sub>DD_HV</sub>	NC <sup>1</sup>	V <sub>SS_HV</sub>	FCCU_ F[1]	D[2]	A[13]	V <sub>DD_HV</sub> _REG_2	V <sub>DD_HV</sub> _REG_2	I[0]	JCOMP	H[11]	I[1]	F[14]	B[1]	V <sub>SS_HV</sub>	A[4]	F[12]
D	F[5]	F[4]	A[15]	C[6]	V <sub>SS_LV_</sub>	V <sub>DD_LV</sub> COR	F[0]	V <sub>DD_HV</sub>	V <sub>SS_HV</sub>	NC	A[11]	E[13]	F[15]	V <sub>DD_HV</sub> _IO	V <sub>PP</sub> _test	D[14]	G[3]
E	MDO0	F[6]	D[1]	NMI										NC	C[14]	G[2]	I[3]
F	H[1]	G[12]	A[7]	A[8]		V <sub>DD_LV</sub> COR	V <sub>DD_LV</sub> COR	V <sub>DD_LV</sub> COR	V <sub>DD_LV</sub> _ COR	V <sub>DD_LV</sub> COR	V <sub>DD_LV</sub> _ COR	V <sub>DD_LV_</sub> COR		NC	C[13]	I[2]	G[4]
G	H[3]	V <sub>DD_HV</sub> _IO	C[5]	A[6]		V <sub>DD_LV</sub> COR	V <sub>SS_LV_</sub> COR	V <sub>SS_LV_</sub> COR	V <sub>SS_LV_</sub> COR	V <sub>SS_LV_</sub> COR	V <sub>SS_LV_</sub> COR	V <sub>DD_LV</sub> COR		D[12]	H[13]	H[9]	G[6]
Н	G[13]	V <sub>SS_HV</sub> _IO	C[4]	A[5]		V <sub>DD_LV</sub>	$V_{\rm SS\_LV}$	$V_{SS\_LV}$	V <sub>SS_LV</sub>	$V_{SS\_LV}$	V <sub>SS_LV</sub>	$V_{DD\_LV}$		V <sub>SS_LV</sub>	V <sub>DD_HV</sub> _REG_1	V <sub>DD_HV</sub> _fla	H[6]
J	F[7]	G[15]	V <sub>DD_HV</sub> _REG_0	V <sub>DD_HV</sub> _REG_0		V <sub>DD_LV</sub>	V <sub>SS_LV</sub>	V <sub>SS_LV</sub>	V <sub>SS_LV</sub>	V <sub>SS_LV</sub>	V <sub>SS_LV</sub>	V <sub>DD_LV</sub>		V <sub>DD_LV</sub>	V <sub>DD_HV</sub> _REG_1	V <sub>SS_HV</sub> _fla	H[15]
K	F[9]	F[8]		C[7]		V <sub>DD_LV</sub>	V <sub>SS_LV</sub>	V <sub>SS_LV</sub>	V <sub>SS_LV</sub>	V <sub>SS_LV</sub>	V <sub>SS_LV</sub>	V <sub>DD_LV</sub>		NC	H[8]	H[7]	A[3]
L	F[10]	F[11]	D[9]	NC		V <sub>DD_LV</sub>	V <sub>SS_LV</sub>	V <sub>SS_LV</sub>	V <sub>SS_LV</sub>	V <sub>SS_LV</sub>	V <sub>SS_LV</sub>	V <sub>DD_LV</sub>		NC	TCK	H[4]	B[4]
M	V <sub>DD_HV</sub> _osc	V <sub>DD_HV</sub> _IO	D[8]	NC		V <sub>DD_LV</sub>	V <sub>DD_LV</sub>	V <sub>DD_LV</sub>	V <sub>DD_LV</sub>	V <sub>DD_LV</sub>	V <sub>DD_LV</sub>	V <sub>DD_LV</sub>		C[11]	B[5]	TMS	H[5]
N	XTAL	V <sub>SS_HV</sub> _IO	D[5]	V <sub>SS_LV_</sub> PLL										NC	C[12]	A[2]	G[5]
Р	V <sub>SS_HV</sub> _osc	RESET	D[6]	V <sub>DD_LV_</sub> PLL	V <sub>DD_LV</sub> _ COR	V <sub>SS_LV_</sub> COR	B[8]	NC	V <sub>SS_HV</sub>	V <sub>DD_HV</sub> _IO	B[14]	V <sub>DD_LV</sub> COR	V <sub>SS_LV_</sub> COR	V <sub>DD_HV</sub> _IO	G[10]	G[8]	G[7]
R	EXTAL	FCCU _F[0]	V <sub>SS_HV</sub> _IO	D[7]	B[7]	E[6]	V <sub>DD_HV</sub> _ADR0	B[10]	V <sub>DD_HV</sub> _ADR1	B[13]	B[15]	C[0]	BCTRL	A[1]	V <sub>SS_HV</sub> _IO	D[11]	G[9]
Т	V <sub>SS_HV</sub>	V <sub>DD_HV</sub> _IO	NC	C[1]	E[5]	E[7]	V <sub>SS_HV</sub> _ADR0	B[11]	V <sub>SS_HV</sub> _ADR1	E[9]	E[10]	E[12]	E[0]	A[0]	D[10]	V <sub>DD_HV</sub> _IO	V <sub>SS_HV</sub>
U	V <sub>SS_HV</sub>	V <sub>SS_HV</sub> _IO	NC	E[4]	C[2]	E[2]	B[9]	B[12]	V <sub>DD_HV</sub> _adv	V <sub>SS_HV</sub> _ADV	E[11]	NC	NC	V <sub>DD_HV</sub> _PMU	G[11]	V <sub>SS_HV</sub> _IO	V <sub>SS_HV</sub>
	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17

<sup>&</sup>lt;sup>1</sup> NC = Not connected (the pin is physically not connected to anything on the device)

Figure 3. MPC5643L 257 MAPBGA pinout (top view)

Table 3 and Table 4 provide the pin function summaries for the 144-pin and 257-pin packages, respectively, listing all the signals multiplexed to each pin.

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Table 3. 144 LQFP pin function summary

Pin#	Port/function	Peripheral	Output function	Input function
1	NMI			
2	A[6]	SIUL	GPIO[6]	GPIO[6]
	-	DSPI_1	SCK	SCK
	_	SIUL	_	EIRQ[6]
3	D[1]	SIUL	GPIO[49]	GPIO[49]
	-	eTimer_1	ETC[2]	ETC[2]
		CTU_0	EXT_TGR	_
	_	FlexRay	_	CA_RX
4	F[4]	SIUL	GPIO[84]	GPIO[84]
		NPC	MDO[3]	<del>_</del>
5	F[5]	SIUL	GPIO[85]	GPIO[85]
		NPC	MDO[2]	_
6	$V_{DD\_HV\_IO}$		<u> </u>	
7	V <sub>SS_HV_IO</sub>		_	
8	F[6]	SIUL	GPIO[86]	GPIO[86]
		NPC	MDO[1]	_
9	MDO0		_	
10	A[7]	SIUL	GPIO[7]	GPIO[7]
		DSPI_1	SOUT	_
		SIUL	_	EIRQ[7]
11	C[4]	SIUL	GPIO[36]	GPIO[36]
		DSPI_0	CS0	CS0
		FlexPWM_0	X[1]	X[1]
	_	SSCM	DEBUG[4]	_
		SIUL	_	EIRQ[22]
12	A[8]	SIUL	GPIO[8]	GPIO[8]
	_	DSPI_1	_	SIN
		SIUL	_	EIRQ[8]
13	C[5]	SIUL	GPIO[37]	GPIO[37]
		DSPI_0	SCK	SCK
		SSCM	DEBUG[5]	_
		FlexPWM_0	_	FAULT[3]
		SIUL	_	EIRQ[23]

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Table 3. 144 LQFP pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
14	A[5]	SIUL	GPIO[5]	GPIO[5]
		DSPI_1	CS0	CS0
		eTimer_1	ETC[5]	ETC[5]
		DSPI_0	CS7	
		SIUL	_	EIRQ[5]
15	C[7]	SIUL	GPIO[39]	GPIO[39]
		FlexPWM_0	A[1]	A[1]
		SSCM	DEBUG[7]	_
		DSPI_0	_	SIN
16	V <sub>DD_HV_REG_0</sub>		_	
17	V <sub>SS_LV_COR</sub>		_	
18	V <sub>DD_LV_COR</sub>		_	
19	F[7]	SIUL	GPIO[87]	GPIO[87]
		NPC	MCKO	_
20	F[8]	SIUL	GPIO[88]	GPIO[88]
		NPC	MSEO[1]	_
21	V <sub>DD_HV_IO</sub>		_	
22	V <sub>SS_HV_IO</sub>		_	
23	F[9]	SIUL	GPIO[89]	GPIO[89]
		NPC	MSEO[0]	_
24	F[10]	SIUL	GPIO[90]	GPIO[90]
		NPC	EVTO	_
25	F[11]	SIUL	GPIO[91]	GPIO[91]
		NPC	_	EVTI
26	D[9]	SIUL	GPIO[57]	GPIO[57]
		FlexPWM_0	X[0]	X[0]
		LINFlexD_1	TXD	_
27	V <sub>DD_HV_OSC</sub>		_	
28	V <sub>SS_HV_OSC</sub>		_	
29	XTAL		_	
30	EXTAL		_	
31	RESET		_	

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Table 3. 144 LQFP pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
32	D[8]	SIUL	GPIO[56]	GPIO[56]
		DSPI_1	CS2	_
		eTimer_1	ETC[4]	ETC[4]
		DSPI_0	CS5	_
		FlexPWM_0	_	FAULT[3]
33	D[5]	SIUL	GPIO[53]	GPIO[53]
		DSPI_0	CS3	_
		FlexPWM_0	_	FAULT[2]
34	D[6]	SIUL	GPIO[54]	GPIO[54]
		DSPI_0	CS2	_
		FlexPWM_0	X[3]	X[3]
		FlexPWM_0	_	FAULT[1]
35	V <sub>SS_LV_PLL0_PLL1</sub>		_	
36	V <sub>DD_LV_PLL0_PLL1</sub>		_	
37	D[7]	SIUL	GPIO[55]	GPIO[55]
		DSPI_1	CS3	_
		DSPI_0	CS4	_
		SWG	analog output	<del>_</del>
38	FCCU_F[0]	FCCU	F[0]	F[0]
39	V <sub>DD_LV_COR</sub>		_	
40	V <sub>SS_LV_COR</sub>		<del>_</del>	
41	C[1]	SIUL	_	GPIO[33]
		ADC_0	_	AN[2]
42	E[4]	SIUL	_	GPIO[68]
		ADC_0	_	AN[7]
43	B[7]	SIUL	_	GPIO[23]
		LINFlexD_0	_	RXD
		ADC_0	_	AN[0]
44	E[5]	SIUL	_	GPIO[69]
	-	ADC_0	_	AN[8]
45	C[2]	SIUL	_	GPIO[34]
	-	ADC_0	_	AN[3]
46	E[6]	SIUL	_	GPIO[70]
		ADC_0	_	AN[4]

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Table 3. 144 LQFP pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
47	B[8]	SIUL	_	GPIO[24]
		eTimer_0	_	ETC[5]
		ADC_0	_	AN[1]
48	E[7]	SIUL	_	GPIO[71]
		ADC_0	_	AN[6]
49	E[2]	SIUL	_	GPIO[66]
		ADC_0	_	AN[5]
50	V <sub>DD_HV_ADR0</sub>		_	
51	V <sub>SS_HV_ADR0</sub>		_	
52	B[9]	SIUL	_	GPIO[25]
		ADC_0 ADC_1	_	AN[11]
53	B[10]	SIUL	_	GPIO[26]
		ADC_0 ADC_1	_	AN[12]
54	B[11]	SIUL	_	GPIO[27]
		ADC_0 ADC_1	_	AN[13]
55	B[12]	SIUL	_	GPIO[28]
		ADC_0 ADC_1	_	AN[14]
56	V <sub>DD_HV_ADR1</sub>		_	
57	V <sub>SS_HV_ADR1</sub>		_	
58	$V_{DD\_HV\_ADV}$		_	
59	V <sub>SS_HV_ADV</sub>		_	
60	B[13]	SIUL	_	GPIO[29]
		LINFlexD_1	_	RXD
		ADC_1	_	AN[0]
61	E[9]	SIUL	_	GPIO[73]
		ADC_1	_	AN[7]
62	B[15]	SIUL	_	GPIO[31]
		SIUL	_	EIRQ[20]
		ADC_1	_	AN[2]
63	E[10]	SIUL	_	GPIO[74]
		ADC_1	_	AN[8]

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Table 3. 144 LQFP pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
64	B[14]	SIUL	_	GPIO[30]
		eTimer_0	_	ETC[4]
		SIUL	_	EIRQ[19]
		ADC_1	_	AN[1]
65	E[11]	SIUL	_	GPIO[75]
		ADC_1	_	AN[4]
66	C[0]	SIUL	_	GPIO[32]
		ADC_1	_	AN[3]
67	E[12]	SIUL	_	GPIO[76]
		ADC_1	_	AN[6]
68	E[0]	SIUL	_	GPIO[64]
		ADC_1	_	AN[5]
69	BCTRL		_	
70	V <sub>DD_LV_COR</sub>		_	
71	V <sub>SS_LV_COR</sub>		_	
72	V <sub>DD_HV_PMU</sub>		_	
73	A[0]	SIUL	GPIO[0]	GPIO[0]
		eTimer_0	ETC[0]	ETC[0]
		DSPI_2	SCK	SCK
		SIUL	_	EIRQ[0]
74	A[1]	SIUL	GPIO[1]	GPIO[1]
		eTimer_0	ETC[1]	ETC[1]
		DSPI_2	SOUT	_
		SIUL	_	EIRQ[1]
75	G[11]	SIUL	GPIO[107]	GPIO[107]
		FlexRay	DBG3	_
		FlexPWM_0	_	FAULT[3]
76	D[10]	SIUL	GPIO[58]	GPIO[58]
		FlexPWM_0	A[0]	A[0]
		eTimer_0	_	ETC[0]
77	G[10]	SIUL	GPIO[106]	GPIO[106]
		FlexRay	DBG2	_
		DSPI_2	CS3	<del>-</del>
		FlexPWM_0	_	FAULT[2]

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Table 3. 144 LQFP pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
78	D[11]	SIUL	GPIO[59]	GPIO[59]
		FlexPWM_0	B[0]	B[0]
		eTimer_0	_	ETC[1]
79	G[9]	SIUL	GPIO[105]	GPIO[105]
		FlexRay	DBG1	_
	-	DSPI_1	CS1	_
	-	FlexPWM_0	_	FAULT[1]
		SIUL	_	EIRQ[29]
80	C[11]	SIUL	GPIO[43]	GPIO[43]
		eTimer_0	ETC[4]	ETC[4]
		DSPI_2	CS2	_
81	G[8]	SIUL	GPIO[104]	GPIO[104]
		FlexRay	DBG0	_
		DSPI_0	CS1	_
		FlexPWM_0	_	FAULT[0]
		SIUL	_	EIRQ[21]
82	C[12]	SIUL	GPIO[44]	GPIO[44]
		eTimer_0	ETC[5]	ETC[5]
		DSPI_2	CS3	_
83	G[7]	SIUL	GPIO[103]	GPIO[103]
		FlexPWM_0	B[3]	B[3]
84	A[2]	SIUL	GPIO[2]	GPIO[2]
	-	eTimer_0	ETC[2]	ETC[2]
		FlexPWM_0	A[3]	A[3]
		DSPI_2	_	SIN
	-	MC_RGM	_	ABS[0]
	-	SIUL	_	EIRQ[2]
85	G[5]	SIUL	GPIO[101]	GPIO[101]
		FlexPWM_0	X[3]	X[3]
		DSPI_2	CS3	_
86	B[5]	SIUL	GPIO[21]	GPIO[21]
		JTAGC	_	TDI
87	TMS		_	
88	TCK			

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Table 3. 144 LQFP pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function	
89	B[4]	SIUL	GPIO[20]	GPIO[20]	
		JTAGC	TDO		
90	V <sub>SS_HV_IO</sub>		_		
91	V <sub>DD_HV_IO</sub>		_		
92	A[3]	SIUL	GPIO[3]	GPIO[3]	
		eTimer_0	ETC[3]	ETC[3]	
		DSPI_2	CS0	CS0	
		FlexPWM_0	B[3]	B[3]	
		MC_RGM	_	ABS[2]	
		SIUL	_	EIRQ[3]	
93	V <sub>DD_LV_COR</sub>		_		
94	V <sub>SS_LV_COR</sub>		_		
95	V <sub>DD_HV_REG_1</sub>		_		
96	V <sub>SS_HV_FLA</sub>	_			
97	V <sub>DD_HV_FLA</sub>		_		
98	G[6]	SIUL	GPIO[102]	GPIO[102]	
		FlexPWM_0	A[3]	A[3]	
99	D[12]	SIUL	GPIO[60]	GPIO[60]	
		FlexPWM_0	X[1]	X[1]	
		LINFlexD_1	_	RXD	
100	G[4]	SIUL	GPIO[100]	GPIO[100]	
		FlexPWM_0	B[2]	B[2]	
		eTimer_0	_	ETC[5]	
101	C[13]	SIUL	GPIO[45]	GPIO[45]	
		eTimer_1	ETC[1]	ETC[1]	
		CTU_0	_	EXT_IN	
		FlexPWM_0	_	EXT_SYNC	
102	G[2]	SIUL	GPIO[98]	GPIO[98]	
		FlexPWM_0	X[2]	X[2]	
		DSPI_1	CS1	_	
103	C[14]	SIUL	GPIO[46]	GPIO[46]	
		eTimer_1	ETC[2]	ETC[2]	
		CTU_0	EXT_TGR	_	

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Table 3. 144 LQFP pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
104	G[3]	SIUL	GPIO[99]	GPIO[99]
		FlexPWM_0	A[2]	A[2]
		eTimer_0	_	ETC[4]
105	D[14]	SIUL	GPIO[62]	GPIO[62]
		FlexPWM_0	B[1]	B[1]
		eTimer_0	_	ETC[3]
106	F[12]	SIUL	GPIO[92]	GPIO[92]
		eTimer_1	ETC[3]	ETC[3]
		SIUL	_	EIRQ[30]
107	V <sub>PP_TEST</sub> 1		_	
108	A[4]	SIUL	GPIO[4]	GPIO[4]
		eTimer_1	ETC[0]	ETC[0]
		DSPI_2	CS1	_
		eTimer_0	ETC[4]	ETC[4]
		MC_RGM	_	FAB
		SIUL	_	EIRQ[4]
109	B[0]	SIUL	GPIO[16]	GPIO[16]
		FlexCAN_0	TXD	_
		eTimer_1	ETC[2]	ETC[2]
		SSCM	DEBUG[0]	
		SIUL	_	EIRQ[15]
110	B[1]	SIUL	GPIO[17]	GPIO[17]
		eTimer_1	ETC[3]	ETC[3]
		SSCM	DEBUG[1]	
		FlexCAN_0	_	RXD
		FlexCAN_1	_	RXD
		SIUL	_	EIRQ[16]
111	C[10]	SIUL	GPIO[42]	GPIO[42]
		DSPI_2	CS2	_
		FlexPWM_0	A[3]	A[3]
		FlexPWM_0	_	FAULT[1]
112	F[13]	SIUL	GPIO[93]	GPIO[93]
	-	eTimer_1	ETC[4]	ETC[4]
		SIUL		EIRQ[31]

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Table 3. 144 LQFP pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
113	F[15]	SIUL	GPIO[95]	GPIO[95]
		LINFlexD_1	_	RXD
114	B[2]	SIUL	GPIO[18]	GPIO[18]
		LINFlexD_0	TXD	_
		SSCM	DEBUG[2]	_
		SIUL	_	EIRQ[17]
115	F[14]	SIUL	GPIO[94]	GPIO[94]
		LINFlexD_1	TXD	_
116	B[3]	SIUL	GPIO[19]	GPIO[19]
		SSCM	DEBUG[3]	_
		LINFlexD_0	_	RXD
117	E[13]	SIUL	GPIO[77]	GPIO[77]
		eTimer_0	ETC[5]	ETC[5]
		DSPI_2	CS3	_
		SIUL	_	EIRQ[25]
118	A[10]	SIUL	GPIO[10]	GPIO[10]
		DSPI_2	CS0	CS0
		FlexPWM_0	B[0]	B[0]
		FlexPWM_0	X[2]	X[2]
		SIUL	_	EIRQ[9]
119	E[14]	SIUL	GPIO[78]	GPIO[78]
		eTimer_1	ETC[5]	ETC[5]
		SIUL	_	EIRQ[26]
120	A[11]	SIUL	GPIO[11]	GPIO[11]
		DSPI_2	SCK	SCK
		FlexPWM_0	A[0]	A[0]
		FlexPWM_0	A[2]	A[2]
		SIUL	_	EIRQ[10]
121	E[15]	SIUL	GPIO[79]	GPIO[79]
		DSPI_0	CS1	_
		SIUL	_	EIRQ[27]
			1	L



Table 3. 144 LQFP pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
122	A[12]	SIUL	GPIO[12]	GPIO[12]
		DSPI_2	SOUT	_
		FlexPWM_0	A[2]	A[2]
		FlexPWM_0	B[2]	B[2]
		SIUL	_	EIRQ[11]
123	JCOMP	_	_	JCOMP
124	C[15]	SIUL	GPIO[47]	GPIO[47]
		FlexRay	CA_TR_EN	_
		eTimer_1	ETC[0]	ETC[0]
		FlexPWM_0	A[1]	A[1]
		CTU_0	_	EXT_IN
		FlexPWM_0	_	EXT_SYNC
125	D[0]	SIUL	GPIO[48]	GPIO[48]
		FlexRay	CA_TX	_
		eTimer_1	ETC[1]	ETC[1]
		FlexPWM_0	B[1]	B[1]
126	V <sub>DD_HV_IO</sub>		_	
127	V <sub>SS_HV_IO</sub>		_	
128	D[3]	SIUL	GPIO[51]	GPIO[51]
		FlexRay	CB_TX	_
		eTimer_1	ETC[4]	ETC[4]
		FlexPWM_0	A[3]	A[3]
129	D[4]	SIUL	GPIO[52]	GPIO[52]
		FlexRay	CB_TR_EN	_
		eTimer_1	ETC[5]	ETC[5]
		FlexPWM_0	B[3]	B[3]
130	V <sub>DD_HV_REG_2</sub>		_	1
131	V <sub>DD_LV_COR</sub>		_	
132	V <sub>SS_LV_COR</sub>		_	
133	F[0]	SIUL	GPIO[80]	GPIO[80]
		FlexPWM_0	A[1]	A[1]
		eTimer_0	_	ETC[2]
		SIUL	_	EIRQ[28]
		t	1	

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Table 3. 144 LQFP pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
134	A[9]	SIUL	GPIO[9]	GPIO[9]
		DSPI_2	CS1	_
		FlexPWM_0	B[3]	B[3]
		FlexPWM_0	_	FAULT[0]
135	V <sub>DD_LV_COR</sub>		_	
136	A[13]	SIUL	GPIO[13]	GPIO[13]
		FlexPWM_0	B[2]	B[2]
		DSPI_2	_	SIN
		FlexPWM_0	_	FAULT[0]
		SIUL	_	EIRQ[12]
137	V <sub>SS_LV_COR</sub>		_	
138	B[6]	SIUL	GPIO[22]	GPIO[22]
		MC_CGM	clk_out	_
		DSPI_2	CS2	_
		SIUL	_	EIRQ[18]
139	F[3]	SIUL	GPIO[83]	GPIO[83]
		DSPI_0	CS6	_
140	D[2]	SIUL	GPIO[50]	GPIO[50]
		eTimer_1	ETC[3]	ETC[3]
		FlexPWM_0	X[3]	X[3]
		FlexRay	_	CB_RX
141	FCCU_F[1]	FCCU	F[1]	F[1]
142	C[6]	SIUL	GPIO[38]	GPIO[38]
		DSPI_0	SOUT	_
		FlexPWM_0	B[1]	B[1]
		SSCM	DEBUG[6]	_
		SIUL	_	EIRQ[24]
143	A[14]	SIUL	GPIO[14]	GPIO[14]
		FlexCAN_1	TXD	_
		eTimer_1	ETC[4]	ETC[4]
		SIUL	_	EIRQ[13]
			1	l



Table 3. 144 LQFP pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
144	A[15]	SIUL	GPIO[15]	GPIO[15]
		eTimer_1	ETC[5]	ETC[5]
		FlexCAN_1	_	RXD
		FlexCAN_0	_	RXD
		SIUL	_	EIRQ[14]

<sup>&</sup>lt;sup>1</sup> V<sub>PP\_TEST</sub> should always be tied to ground (V<sub>SS</sub>) for normal operations.

Table 4. 257 MAPBGA pin function summary

Pin#	Port/function	Peripheral	Output function	Input function
A1	V <sub>SS_HV_IO_RING</sub>		_	
A2	V <sub>SS_HV_IO_RING</sub>		_	
A3	V <sub>DD_HV_IO_RING</sub>		_	
A4	H[2]	SIUL	GPIO[114]	GPIO[114]
		NPC	MDO[5]	_
A5	H[0]	SIUL	GPIO[112]	GPIO[112]
		NPC	MDO[7]	_
A6	G[14]	SIUL	GPIO[110]	GPIO[110]
		NPC	MDO[9]	_
A7	D[3]	SIUL	GPIO[51]	GPIO[51]
		FlexRay	CB_TX	_
		eTimer_1	ETC[4]	ETC[4]
		FlexPWM_0	A[3]	A[3]
A8	C[15]	SIUL	GPIO[47]	GPIO[47]
		FlexRay	CA_TR_EN	_
		eTimer_1	ETC[0]	ETC[0]
		FlexPWM_0	A[1]	A[1]
		CTU_0	_	EXT_IN
		FlexPWM_0	_	EXT_SYNC
A9	V <sub>DD_HV_IO_RING</sub>		_	
A10	A[12]	SIUL	GPIO[12]	GPIO[12]
		DSPI_2	SOUT	_
		FlexPWM_0	A[2]	A[2]
		FlexPWM_0	B[2]	B[2]
		SIUL	_	EIRQ[11]

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Table 4. 257 MAPBGA pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
A11	H[10]	SIUL	GPIO[122]	GPIO[122]
		FlexPWM_1	X[2]	X[2]
		eTimer_2	ETC[2]	ETC[2]
A12	H[14]	SIUL	GPIO[126]	GPIO[126]
		FlexPWM_1	A[3]	A[3]
		eTimer_2	ETC[4]	ETC[4]
A13	A[10]	SIUL	GPIO[10]	GPIO[10]
		DSPI_2	CS0	CS0
		FlexPWM_0	B[0]	B[0]
		FlexPWM_0	X[2]	X[2]
		SIUL	_	EIRQ[9]
A14	B[2]	SIUL	GPIO[18]	GPIO[18]
		LINFlexD_0	TXD	_
		SSCM	DEBUG[2]	_
		SIUL	_	EIRQ[17]
A15	C[10]	SIUL	GPIO[42]	GPIO[42]
		DSPI_2	CS2	_
		FlexPWM_0	A[3]	A[3]
		FlexPWM_0	_	FAULT[1]
A16	V <sub>SS_HV_IO_RING</sub>		_	1
A17	V <sub>SS_HV_IO_RING</sub>		_	
B1	V <sub>SS_HV_IO_RING</sub>		_	
B2	V <sub>SS_HV_IO_RING</sub>		_	
В3	B[6]	SIUL	GPIO[22]	GPIO[22]
		MC_CGM	clk_out	_
		DSPI_2	CS2	_
		SIUL	_	EIRQ[18]
B4	A[14]	SIUL	GPIO[14]	GPIO[14]
		FlexCAN_1	TXD	_
		eTimer_1	ETC[4]	ETC[4]
		SIUL	_	EIRQ[13]
B5	F[3]	SIUL	GPIO[83]	GPIO[83]
		DSPI_0	CS6	_

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Table 4. 257 MAPBGA pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
B6	A[9]	SIUL	GPIO[9]	GPIO[9]
		DSPI_2	CS1	_
		FlexPWM_0	B[3]	B[3]
		FlexPWM_0	_	FAULT[0]
B7	D[4]	SIUL	GPIO[52]	GPIO[52]
		FlexRay	CB_TR_EN	_
		eTimer_1	ETC[5]	ETC[5]
		FlexPWM_0	B[3]	B[3]
B8	D[0]	SIUL	GPIO[48]	GPIO[48]
		FlexRay	CA_TX	_
		eTimer_1	ETC[1]	ETC[1]
		FlexPWM_0	B[1]	B[1]
B9	V <sub>SS_HV_IO_RING</sub>		_	
B10	H[12]	SIUL	GPIO[124]	GPIO[124]
		FlexPWM_1	B[2]	B[2]
B11	E[15]	SIUL	GPIO[79]	GPIO[79]
		DSPI_0	CS1	_
		SIUL	_	EIRQ[27]
B12	E[14]	SIUL	GPIO[78]	GPIO[78]
		eTimer_1	ETC[5]	ETC[5]
		SIUL	_	EIRQ[26]
B13	B[3]	SIUL	GPIO[19]	GPIO[19]
		SSCM	DEBUG[3]	_
		LINFlexD_0	_	RXD
B14	F[13]	SIUL	GPIO[93]	GPIO[93]
		eTimer_1	ETC[4]	ETC[4]
		SIUL	_	EIRQ[31]
B15	B[0]	SIUL	GPIO[16]	GPIO[16]
		FlexCAN_0	TXD	_
		eTimer_1	ETC[2]	ETC[2]
		SSCM	DEBUG[0]	_
		SIUL	_	EIRQ[15]
B16	V <sub>DD_HV_IO_RING</sub>		_	
B17	V <sub>SS_HV_IO_RING</sub>		_	
C1	V <sub>DD_HV_IO_RING</sub>		_	

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Table 4. 257 MAPBGA pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
C2	Not connected		_	
C3	V <sub>SS_HV_IO_RING</sub>		_	
C4	FCCU_F[1]	FCCU	F[1]	F[1]
C5	D[2]	SIUL	GPIO[50]	GPIO[50]
		eTimer_1	ETC[3]	ETC[3]
		FlexPWM_0	X[3]	X[3]
		FlexRay	_	CB_RX
C6	A[13]	SIUL	GPIO[13]	GPIO[13]
		FlexPWM_0	B[2]	B[2]
		DSPI_2	_	SIN
		FlexPWM_0	_	FAULT[0]
		SIUL	_	EIRQ[12]
C7	V <sub>DD_HV_REG_2</sub>		_	
C8	V <sub>DD_HV_REG_2</sub>		_	
C9	I[0]	SIUL	GPIO[128]	GPIO[128]
		eTimer_2	ETC[0]	ETC[0]
		DSPI_0	CS4	_
		FlexPWM_1	_	FAULT[0]
C10	JCOMP	_	_	JCOMP
C11	H[11]	SIUL	GPIO[123]	GPIO[123]
		FlexPWM_1	A[2]	A[2]
C12	I[1]	SIUL	GPIO[129]	GPIO[129]
		eTimer_2	ETC[1]	ETC[1]
		DSPI_0	CS5	_
		FlexPWM_1	_	FAULT[1]
C13	F[14]	SIUL	GPIO[94]	GPIO[94]
		LINFlexD_1	TXD	_
C14	B[1]	SIUL	GPIO[17]	GPIO[17]
		eTimer_1	ETC[3]	ETC[3]
		SSCM	DEBUG[1]	<del>_</del>
		FlexCAN_0	_	RXD
		FlexCAN_1	_	RXD
		SIUL	_	EIRQ[16]
C15	V <sub>SS_HV_IO_RING</sub>		_	



Table 4. 257 MAPBGA pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
C16	A[4]	SIUL	GPIO[4]	GPIO[4]
		eTimer_1	ETC[0]	ETC[0]
		DSPI_2	CS1	_
		eTimer_0	ETC[4]	ETC[4]
		MC_RGM	_	FAB
		SIUL	_	EIRQ[4]
C17	F[12]	SIUL	GPIO[92]	GPIO[92]
		eTimer_1	ETC[3]	ETC[3]
		SIUL	_	EIRQ[30]
D1	F[5]	SIUL	GPIO[85]	GPIO[85]
		NPC	MDO[2]	_
D2	F[4]	SIUL	GPIO[84]	GPIO[84]
		NPC	MDO[3]	_
D3	A[15]	SIUL	GPIO[15]	GPIO[15]
		eTimer_1	ETC[5]	ETC[5]
		FlexCAN_1	_	RXD
		FlexCAN_0	_	RXD
		SIUL	_	EIRQ[14]
D4	C[6]	SIUL	GPIO[38]	GPIO[38]
		DSPI_0	SOUT	_
		FlexPWM_0	B[1]	B[1]
		SSCM	DEBUG[6]	_
		SIUL	_	EIRQ[24]
D5	V <sub>SS_LV_CORE_RING</sub>		_	
D6	V <sub>DD_LV_CORE_RING</sub>		_	
D7	F[0]	SIUL	GPIO[80]	GPIO[80]
		FlexPWM_0	A[1]	A[1]
		eTimer_0	_	ETC[2]
		SIUL	_	EIRQ[28]
D8	V <sub>DD_HV_IO_RING</sub>		_	
D9	V <sub>SS_HV_IO_RING</sub>		_	
D10	Not connected		_	

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Table 4. 257 MAPBGA pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
D11	A[11]	SIUL	GPIO[11]	GPIO[11]
		DSPI_2	SCK	SCK
		FlexPWM_0	A[0]	A[0]
		FlexPWM_0	A[2]	A[2]
		SIUL	_	EIRQ[10]
D12	E[13]	SIUL	GPIO[77]	GPIO[77]
		eTimer_0	ETC[5]	ETC[5]
		DSPI_2	CS3	_
		SIUL	_	EIRQ[25]
D13	F[15]	SIUL	GPIO[95]	GPIO[95]
		LINFlexD_1	_	RXD
D14	V <sub>DD_HV_IO_RING</sub>		_	L
D15	V <sub>PP_TEST</sub> 1		_	
D16	D[14]	SIUL	GPIO[62]	GPIO[62]
		FlexPWM_0	B[1]	B[1]
		eTimer_0	_	ETC[3]
D17	G[3]	SIUL	GPIO[99]	GPIO[99]
		FlexPWM_0	A[2]	A[2]
		eTimer_0	_	ETC[4]
E1	MDO0		_	
E2	F[6]	SIUL	GPIO[86]	GPIO[86]
		NPC	MDO[1]	_
E3	D[1]	SIUL	GPIO[49]	GPIO[49]
		eTimer_1	ETC[2]	ETC[2]
		CTU_0	EXT_TGR	_
		FlexRay	_	CA_RX
E4	NMI		_	
E14	Not connected		_	
E15	C[14]	SIUL	GPIO[46]	GPIO[46]
		eTimer_1	ETC[2]	ETC[2]
		CTU_0	EXT_TGR	_
E16	G[2]	SIUL	GPIO[98]	GPIO[98]
		FlexPWM_0	X[2]	X[2]
		DSPI_1	CS1	_



Table 4. 257 MAPBGA pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
E17	I[3]	SIUL	GPIO[131]	GPIO[131]
		eTimer_2	ETC[3]	ETC[3]
		DSPI_0	CS7	_
		CTU_0	EXT_TGR	_
		FlexPWM_1	_	FAULT[3]
F1	H[1]	SIUL	GPIO[113]	GPIO[113]
		NPC	MDO[6]	_
F2	G[12]	SIUL	GPIO[108]	GPIO[108]
		NPC	MDO[11]	_
F3	A[7]	SIUL	GPIO[7]	GPIO[7]
		DSPI_1	SOUT	_
		SIUL	_	EIRQ[7]
F4	A[8]	SIUL	GPIO[8]	GPIO[8]
		DSPI_1	_	SIN
		SIUL	_	EIRQ[8]
F6	V <sub>DD_LV_CORE_RING</sub>		_	
F7	V <sub>DD_LV_CORE_RING</sub>		_	
F8	V <sub>DD_LV_CORE_RING</sub>		_	
F9	V <sub>DD_LV_CORE_RING</sub>		_	
F10	V <sub>DD_LV_CORE_RING</sub>		_	
F11	V <sub>DD_LV_CORE_RING</sub>		_	
F12	V <sub>DD_LV_CORE_RING</sub>		_	
F14	Not connected		_	
F15	C[13]	SIUL	GPIO[45]	GPIO[45]
		eTimer_1	ETC[1]	ETC[1]
		CTU_0	_	EXT_IN
		FlexPWM_0	_	EXT_SYNC
F16	I[2]	SIUL	GPIO[130]	GPIO[130]
		eTimer_2	ETC[2]	ETC[2]
		DSPI_0	CS6	_
		FlexPWM_1	_	FAULT[2]
F17	G[4]	SIUL	GPIO[100]	GPIO[100]
		FlexPWM_0	B[2]	B[2]
		eTimer_0	_	ETC[5]

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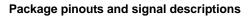




Table 4. 257 MAPBGA pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
G1	H[3]	SIUL	GPIO[115]	GPIO[115]
		NPC	MDO[4]	_
G2	V <sub>DD_HV_IO_RING</sub>		_	
G3	C[5]	SIUL	GPIO[37]	GPIO[37]
		DSPI_0	SCK	SCK
		SSCM	DEBUG[5]	_
		FlexPWM_0	_	FAULT[3]
		SIUL	_	EIRQ[23]
G4	A[6]	SIUL	GPIO[6]	GPIO[6]
		DSPI_1	SCK	SCK
		SIUL	_	EIRQ[6]
G6	V <sub>DD_LV_CORE_RING</sub>		_	
G7	V <sub>SS_LV_CORE_RING</sub>		_	
G8	V <sub>SS_LV_CORE_RING</sub>	_		
G9	V <sub>SS_LV_CORE_RING</sub>		_	
G10	V <sub>SS_LV_CORE_RING</sub>		_	
G11	V <sub>SS_LV_CORE_RING</sub>		_	
G12	V <sub>DD_LV_CORE_RING</sub>		_	
G14	D[12]	SIUL	GPIO[60]	GPIO[60]
		FlexPWM_0	X[1]	X[1]
		LINFlexD_1	_	RXD
G15	H[13]	SIUL	GPIO[125]	GPIO[125]
		FlexPWM_1	X[3]	X[3]
		eTimer_2	ETC[3]	ETC[3]
G16	H[9]	SIUL	GPIO[121]	GPIO[121]
		FlexPWM_1	B[1]	B[1]
		DSPI_0	CS7	_
G17	G[6]	SIUL	GPIO[102]	GPIO[102]
		FlexPWM_0	A[3]	A[3]
H1	G[13]	SIUL	GPIO[109]	GPIO[109]
		NPC	MDO[10]	_
H2	V <sub>SS_HV_IO_RING</sub>		_	



Table 4. 257 MAPBGA pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
Н3	C[4]	SIUL	GPIO[36]	GPIO[36]
		DSPI_0	CS0	CS0
		FlexPWM_0	X[1]	X[1]
		SSCM	DEBUG[4]	_
		SIUL	_	EIRQ[22]
H4	A[5]	SIUL	GPIO[5]	GPIO[5]
		DSPI_1	CS0	CS0
		eTimer_1	ETC[5]	ETC[5]
		DSPI_0	CS7	_
	-	SIUL	_	EIRQ[5]
H6	$V_{DD\_LV}$		_	
H7	V <sub>SS_LV</sub>		_	
H8	V <sub>SS_LV</sub>		_	
H9	V <sub>SS_LV</sub>		_	
H10	V <sub>SS_LV</sub>		_	
H11	V <sub>SS_LV</sub>		_	
H12	$V_{DD\_LV}$		_	
H14	V <sub>SS_LV</sub>		_	
H15	V <sub>DD_HV_REG_1</sub>		_	
H16	$V_{DD\_HV\_FLA}$		_	
H17	H[6]	SIUL	GPIO[118]	GPIO[118]
		FlexPWM_1	B[0]	B[0]
		DSPI_0	CS5	_
J1	F[7]	SIUL	GPIO[87]	GPIO[87]
		NPC	MCKO	_
J2	G[15]	SIUL	GPIO[111]	GPIO[111]
		NPC	MDO[8]	_
J3	$V_{DD\_HV\_REG\_0}$		_	
J4	V <sub>DD_HV_REG_0</sub>		<del>_</del>	
J6	$V_{DD\_LV}$		_	
J7	V <sub>SS_LV</sub>		_	
J8	V <sub>SS_LV</sub>	<del>_</del>		
J9	V <sub>SS_LV</sub>	_		
J10	V <sub>SS_LV</sub>		_	
J11	V <sub>SS_LV</sub>			

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Table 4. 257 MAPBGA pin function summary (continued)

Pin #	Port/function	Peripheral	Output function	Input function
J12	$V_{DD\_LV}$		_	I
J14	V <sub>DD_LV</sub>	_		
J15	V <sub>DD_HV_REG_1</sub>	_		
J16	V <sub>SS_HV_FLA</sub>		_	
J17	H[15]	SIUL	GPIO[127]	GPIO[127]
		FlexPWM_1	B[3]	B[3]
		eTimer_2	ETC[5]	ETC[5]
K1	F[9]	SIUL	GPIO[89]	GPIO[89]
		NPC	MSEO[0]	_
K2	F[8]	SIUL	GPIO[88]	GPIO[88]
		NPC	MSEO[1]	_
K3	RDY	NPC	RDY	_
		SIUL	GPIO[132]	GPIO[132]
K4	C[7]	SIUL	GPIO[39]	GPIO[39]
		FlexPWM_0	A[1]	A[1]
		SSCM	DEBUG[7]	_
		DSPI_0	_	SIN
K6	V <sub>DD_LV</sub>		_	l
K7	V <sub>SS_LV</sub>		_	
K8	V <sub>SS_LV</sub>		_	
K9	V <sub>SS_LV</sub>		_	
K10	V <sub>SS_LV</sub>		_	
K11	V <sub>SS_LV</sub>		_	
K12	$V_{DD\_LV}$		_	
K14	Not connected		_	
K15	H[8]	SIUL	GPIO[120]	GPIO[120]
		FlexPWM_1	A[1]	A[1]
		DSPI_0	CS6	_
K16	H[7]	SIUL	GPIO[119]	GPIO[119]
		FlexPWM_1	X[1]	X[1]
		eTimer_2	ETC[1]	ETC[1]
	•		•	



Table 4. 257 MAPBGA pin function summary (continued)

		<u> </u>		
Pin#	Port/function	Peripheral	Output function	Input function
K17	A[3]	SIUL	GPIO[3]	GPIO[3]
		eTimer_0	ETC[3]	ETC[3]
		DSPI_2	CS0	CS0
		FlexPWM_0	B[3]	B[3]
		MC_RGM	_	ABS[2]
		SIUL	_	EIRQ[3]
L1	F[10]	SIUL	GPIO[90]	GPIO[90]
		NPC	EVTO	_
L2	F[11]	SIUL	GPIO[91]	GPIO[91]
		NPC	_	EVTI
L3	D[9]	SIUL	GPIO[57]	GPIO[57]
		FlexPWM_0	X[0]	X[0]
		LINFlexD_1	TXD	_
L4	Not connected	<u> </u>		
L6	$V_{DD\_LV}$		_	
L7	V <sub>SS_LV</sub>		_	
L8	V <sub>SS_LV</sub>		_	
L9	V <sub>SS_LV</sub>		_	
L10	V <sub>SS_LV</sub>		_	
L11	V <sub>SS_LV</sub>		_	
L12	$V_{DD\_LV}$		_	
L14	Not connected		_	
L15	TCK		_	
L16	H[4]	SIUL	GPIO[116]	GPIO[116]
		FlexPWM_1	X[0]	X[0]
		eTimer_2	ETC[0]	ETC[0]
L17	B[4]	SIUL	GPIO[20]	GPIO[20]
		JTAGC	TDO	_
M1	V <sub>DD_HV_OSC</sub>		_	
M2	V <sub>DD_HV_IO_RING</sub>		_	
	D[8]	SIUL	GPIO[56]	GPIO[56]
M3			1	
M3		DSPI_1	CS2	_
М3		DSPI_1 eTimer_1	CS2 ETC[4]	— ETC[4]
M3				— ETC[4] —

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Table 4. 257 MAPBGA pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
M4	Not connected		_	
M6	V <sub>DD_LV</sub>	_		
M7	$V_{DD\_LV}$	_		
M8	$V_{DD\_LV}$	<del></del>		
M9	$V_{DD\_LV}$		_	
M10	$V_{DD\_LV}$		_	
M11	$V_{DD\_LV}$		_	
M12	V <sub>DD_LV</sub>		_	
M14	C[11]	SIUL	GPIO[43]	GPIO[43]
		eTimer_0	ETC[4]	ETC[4]
		DSPI_2	CS2	_
M15	B[5]	SIUL	GPIO[21]	GPIO[21]
		JTAGC	_	TDI
M16	TMS		_	
M17	H[5]	SIUL	GPIO[117]	GPIO[117]
		FlexPWM_1	A[0]	A[0]
		DSPI_0	CS4	_
N1	XTAL		_	
N2	V <sub>SS_HV_IO_RING</sub>		_	
N3	D[5]	SIUL	GPIO[53]	GPIO[53]
		DSPI_0	CS3	_
		FlexPWM_0	_	FAULT[2]
N4	V <sub>SS_LV_PLL0_PLL1</sub>		_	
N14	Not connected		_	
N15	C[12]	SIUL	GPIO[44]	GPIO[44]
		eTimer_0	ETC[5]	ETC[5]
		DSPI_2	CS3	_
N16	A[2]	SIUL	GPIO[2]	GPIO[2]
		eTimer_0	ETC[2]	ETC[2]
		FlexPWM_0	A[3]	A[3]
		DSPI_2	_	SIN
		MC_RGM	_	ABS[0]
		SIUL	_	EIRQ[2]



Table 4. 257 MAPBGA pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
N17	G[5]	SIUL	GPIO[101]	GPIO[101]
		FlexPWM_0	X[3]	X[3]
		DSPI_2	CS3	_
P1	V <sub>SS_HV_OSC</sub>		_	
P2	RESET		<del>-</del>	
P3	D[6]	SIUL	GPIO[54]	GPIO[54]
		DSPI_0	CS2	_
		FlexPWM_0	X[3]	X[3]
		FlexPWM_0	_	FAULT[1]
P4	V <sub>DD_LV_PLL0_PLL1</sub>		_	
P5	V <sub>DD_LV_CORE_RING</sub>		_	
P6	V <sub>SS_LV_CORE_RING</sub>		_	
P7	B[8]	SIUL	_	GPIO[24]
		eTimer_0	_	ETC[5]
		ADC_0	_	AN[1]
P8	Not connected		_	
P9	V <sub>SS_HV_IO_RING</sub>		_	
P10	V <sub>DD_HV_IO_RING</sub>		_	
P11	B[14]	SIUL	_	GPIO[30]
		eTimer_0	_	ETC[4]
		SIUL	_	EIRQ[19]
		ADC_1	_	AN[1]
P12	V <sub>DD_LV_CORE_RING</sub>		_	
P13	V <sub>SS_LV_CORE_RING</sub>		_	
P14	V <sub>DD_HV_IO_RING</sub>		_	
P15	G[10]	SIUL	GPIO[106]	GPIO[106]
		FlexRay	DBG2	_
		DSPI_2	CS3	_
		FlexPWM_0	_	FAULT[2]
P16	G[8]	SIUL	GPIO[104]	GPIO[104]
		FlexRay	DBG0	_
		DSPI_0	CS1	_
		FlexPWM_0	_	FAULT[0]

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Table 4. 257 MAPBGA pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
P17	G[7]	SIUL	GPIO[103]	GPIO[103]
		FlexPWM_0	B[3]	B[3]
R1	EXTAL		_	
R2	FCCU_F[0]	FCCU	F[0]	F[0]
R3	V <sub>SS_HV_IO_RING</sub>			
R4	D[7]	SIUL	GPIO[55]	GPIO[55]
		DSPI_1	CS3	_
		DSPI_0	CS4	_
		SWG	analog output	_
R5	B[7]	SIUL	_	GPIO[23]
		LINFlexD_0	_	RXD
		ADC_0	_	AN[0]
R6	E[6]	SIUL	_	GPIO[70]
		ADC_0	_	AN[4]
R7	V <sub>DD_HV_ADR0</sub>		_	
R8	B[10]	SIUL	_	GPIO[26]
		ADC_0 ADC_1	_	AN[12]
R9	V <sub>DD_HV_ADR1</sub>		_	
R10	B[13]	SIUL	_	GPIO[29]
		LINFlexD_1	_	RXD
		ADC_1	_	AN[0]
R11	B[15]	SIUL	_	GPIO[31]
		SIUL	_	EIRQ[20]
		ADC_1	_	AN[2]
R12	C[0]	SIUL	_	GPIO[32]
		ADC_1	_	AN[3]
R13	BCTRL		_	
R14	A[1]	SIUL	GPIO[1]	GPIO[1]
		eTimer_0	ETC[1]	ETC[1]
		DSPI_2	SOUT	_
		SIUL	_	EIRQ[1]
R15	V <sub>SS_HV_IO_RING</sub>		<del>-</del>	



Table 4. 257 MAPBGA pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
R16	D[11]	SIUL	GPIO[59]	GPIO[59]
		FlexPWM_0	B[0]	B[0]
		eTimer_0	_	ETC[1]
R17	G[9]	SIUL	GPIO[105]	GPIO[105]
		FlexRay	DBG1	_
		DSPI_1	CS1	_
		FlexPWM_0	_	FAULT[1]
		SIUL	_	EIRQ[29]
T1	V <sub>SS_HV_IO_RING</sub>		_	
T2	V <sub>DD_HV_IO_RING</sub>		_	
Т3	Not connected		_	
T4	C[1]	SIUL	_	GPIO[33]
		ADC_0	_	AN[2]
T5	E[5]	SIUL	_	GPIO[69]
		ADC_0	_	AN[8]
T6	E[7]	SIUL	_	GPIO[71]
		ADC_0	_	AN[6]
T7	V <sub>SS_HV_ADR0</sub>		_	
Т8	B[11]	SIUL	_	GPIO[27]
		ADC_0 ADC_1	_	AN[13]
Т9	V <sub>SS_HV_ADR1</sub>		_	
T10	E[9]	SIUL	_	GPIO[73]
		ADC_1	_	AN[7]
T11	E[10]	SIUL	_	GPIO[74]
		ADC_1	_	AN[8]
T12	E[12]	SIUL	_	GPIO[76]
		ADC_1	_	AN[6]
T13	E[0]	SIUL	_	GPIO[64]
		ADC_1	_	AN[5]
T14	A[0]	SIUL	GPIO[0]	GPIO[0]
		eTimer_0	ETC[0]	ETC[0]
		DSPI_2	SCK	SCK
		SIUL	_	EIRQ[0]

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Table 4. 257 MAPBGA pin function summary (continued)

Pin#	Port/function	Peripheral	Output function	Input function
T15	D[10]	SIUL	GPIO[58]	GPIO[58]
		FlexPWM_0	A[0]	A[0]
		eTimer_0	_	ETC[0]
T16	V <sub>DD_HV_IO_RING</sub>		_	
T17	V <sub>SS_HV_IO_RING</sub>		_	
U1	V <sub>SS_HV_IO_RING</sub>		_	
U2	V <sub>SS_HV_IO_RING</sub>		_	
U3	Not connected		_	
U4	E[4]	SIUL	_	GPIO[68]
		ADC_0	_	AN[7]
U5	C[2]	SIUL	_	GPIO[34]
		ADC_0	_	AN[3]
U6	E[2]	SIUL	_	GPIO[66]
		ADC_0	_	AN[5]
U7	B[9]	SIUL	_	GPIO[25]
		ADC_0 ADC_1	_	AN[11]
U8	B[12]	SIUL	_	GPIO[28]
		ADC_0 ADC_1	_	AN[14]
U9	$V_{DD\_HV\_ADV}$		_	
U10	V <sub>SS_HV_ADV</sub>		_	
U11	E[11]	SIUL	_	GPIO[75]
		ADC_1	_	AN[4]
U12	Not connected		_	
U13	Not connected		_	
U14	V <sub>DD_HV_PMU</sub>		_	
U15	G[11]	SIUL	GPIO[107]	GPIO[107]
	Ī	FlexRay	DBG3	_
		FlexPWM_0	_	FAULT[3]
U16	V <sub>SS_HV_IO_RING</sub>		_	
U17	V <sub>SS_HV_IO_RING</sub>		_	

<sup>&</sup>lt;sup>1</sup> V<sub>PP\_TEST</sub> should always be tied to ground (V<sub>SS</sub>) for normal operations.



#### 2.2 Supply pins

Table 5. Supply pins

	Supply	Pin	#
Symbol	Description	144 pkg	257 pkg
	VREG control and power supply pins		
BCTRL	Voltage regulator external NPN ballast base control pin	69	R13
V <sub>DD_LV_COR</sub>	Core logic supply	70	VDD_LV <sup>1</sup>
V <sub>SS_LV_COR</sub>	Core regulator ground	71	VSS_LV <sup>2</sup>
V <sub>DD_HV_PMU</sub>	Voltage regulator supply	72	U14
	ADC_0/ADC_1 reference voltage and ADC supply	- 1	
V <sub>DD_HV_ADR0</sub>	ADC_0 high reference voltage	50	R7
V <sub>SS_HV_ADR0</sub>	ADC_0 low reference voltage	51	T7
V <sub>DD_HV_ADR1</sub>	ADC_1 high reference voltage	56	R9
V <sub>SS_HV_ADR1</sub>	ADC_1 low reference voltage	57	T9
V <sub>DD_HV_ADV</sub>	ADC voltage supply for ADC_0 and ADC_1	58	U9
V <sub>SS_HV_ADV</sub>	ADC ground for ADC_0 and ADC_1	59	U10
	Power supply pins (3.3 V)		
V <sub>DD_HV_IO</sub>	3.3 V Input/Output supply voltage	6	VDD_HV <sup>3</sup>
V <sub>SS_HV_IO</sub>	3.3 V Input/Output ground	7	VSS_HV <sup>4</sup>
V <sub>DD_HV_REG_0</sub>	VDD_HV_REG_0	16	J3
V <sub>DD_HV_IO</sub>	3.3 V Input/Output supply voltage	21	VDD_HV <sup>3</sup>
V <sub>SS_HV_IO</sub>	3.3 V Input/Output ground	22	VSS_HV <sup>4</sup>
V <sub>DD_HV_OSC</sub>	Crystal oscillator amplifier supply voltage	27	M1
V <sub>SS_HV_OSC</sub>	Crystal oscillator amplifier ground	28	P1
V <sub>SS_HV_IO</sub>	3.3 V Input/Output ground	90	VSS_HV <sup>4</sup>
V <sub>DD_HV_IO</sub>	3.3 V Input/Output supply voltage	91	VDD_HV <sup>3</sup>
V <sub>DD_HV_REG_1</sub>	VDD_HV_REG_1	95	H15
V <sub>SS_HV_FLA</sub>	VSS_HV_FLA	96	J16
V <sub>DD_HV_FLA</sub>	VDD_HV_FLA	97	H16
V <sub>DD_HV_IO</sub>	VDD_HV_IO	126	VDD_HV <sup>3</sup>
V <sub>SS_HV_IO</sub>	VSS_HV_IO	127	VSS_HV <sup>4</sup>
V <sub>DD_HV_REG_2</sub>	VDD_HV_REG_2	130	C7



#### Table 5. Supply pins (continued)

	Supply	Pi	n #
Symbol	Description	144 pkg	_
V <sub>SS_LV_COR</sub>	VSS_LV_COR Decoupling pins for core logic. Decoupling capacitor must be connected between these pins and the nearest V <sub>DD_LV_COR</sub> pin.	17	VSS_HV <sup>2</sup>
V <sub>DD_LV_COR</sub>	VDD_LV_COR Decoupling pins for core logic. Decoupling capacitor must be connected between these pins and the nearest V <sub>SS_LV_COR</sub> pin.	18	VDD_LV <sup>1</sup>
V <sub>SS</sub> 1V2	VSS_LV_PLL0_PLL1 / 1.2 V Decoupling pins for on-chip FMPLL modules. Decoupling capacitor must be connected between this pin and V <sub>DD_LV_PLL</sub> .	35	N4
V <sub>DD</sub> 1V2	VDD_LV_PLL0_PLL1 Decoupling pins for on-chip FMPLL modules. Decoupling capacitor must be connected between this pin and V <sub>SS_LV_PLL</sub> .	36	P4
V <sub>DD_LV_COR</sub>	VDD_LV_COR Decoupling pins for core logic. Decoupling capacitor must be connected between these pins and the nearest V <sub>SS_LV_COR</sub> pin.	39	VDD_LV <sup>1</sup>
V <sub>SS_LV_COR</sub>	VSS_LV_COR Decoupling pins for core logic. Decoupling capacitor must be connected between these pins and the nearest V <sub>DD_LV_COR</sub> pin.	40	VSS_LV <sup>2</sup>
V <sub>DD_LV_COR</sub>	VDD_LV_COR Decoupling pins for core logic and Regulator feedback. Decoupling capacitor must be connected between this pins and V <sub>SS_LV_REGCOR</sub> .	70	VDD_LV <sup>1</sup>
V <sub>SS_LV_COR</sub>	VSS_LV_REGCOR0 Decoupling pins for core logic and Regulator feedback. Decoupling capacitor must be connected between this pins and V <sub>DD_LV_REGCOR</sub> .	71	VSS_LV <sup>2</sup>
$V_{DD\_LV\_COR}$	VDD_LV_COR Decoupling pins for core logic. Decoupling capacitor must be connected between these pins and the nearest V <sub>SS_LV_COR</sub> pin.	93	VDD_LV <sup>1</sup>
V <sub>SS_LV_COR</sub>	VSS_LV_COR / 1.2 V Decoupling pins for core logic. Decoupling capacitor must be connected between these pins and the nearest V <sub>DD_LV_COR pin</sub> .	94	VSS_LV <sup>2</sup>
V <sub>DD</sub> 1V2	VDD_LV_COR Decoupling pins for core logic. Decoupling capacitor must be connected between these pins and the nearest VDD_LV_COR pin.	131	VDD_LV <sup>1</sup>
V <sub>SS</sub> 1V2	VSS_LV_COR Decoupling pins for core logic. Decoupling capacitor must be connected between these pins and the nearest V <sub>DD_LV_COR</sub> pin.	132	VSS_LV <sup>2</sup>
V <sub>DD</sub> 1V2	VDD_LV_COR / Decoupling pins for core logic. Decoupling capacitor must be connected between these pins and the nearest V <sub>DD_LV_COR</sub> pin.	135	VDD_LV <sup>1</sup>
V <sub>SS</sub> 1V2	VSS_LV_COR / Decoupling pins for core logic. Decoupling capacitor must be connected between these pins and the nearest V <sub>DD_LV_COR</sub> pin.	137	VSS_LV <sup>2</sup>

<sup>1</sup> VDD\_LV balls are tied together on the 257 MAPBGA substrate.

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- <sup>2</sup> VSS\_LV balls are tied together on the 257 MAPBGA substrate.
- <sup>3</sup> VDD\_HV balls are tied together on the 257 MAPBGA substrate.
- <sup>4</sup> VSS\_HV balls are tied together on the 257 MAPBGA substrate.

#### 2.3 System pins

Table 6. System pins

			Pin #	
Symbol	Description	Direction	144 pkg	257 pkg
	Dedicated pins			•
MDO0 <sup>1</sup>	Nexus Message Data Output — line	Output only	9	E1
NMI <sup>2</sup>	Non Maskable Interrupt	Input only	1	E4
XTAL	Input for oscillator amplifier circuit and internal clock generator	Input only	29	N1
EXTAL <sup>3</sup>	Oscillator amplifier output	Input/Output <sup>4</sup>	30	R1
TMS <sup>2</sup>	JTAG state machine control	Input only	87	M16
TCK <sup>2</sup>	JTAG clock	Input only	88	L15
JCOMP <sup>5</sup>	JTAG compliance select	Input only	123	C10
	Reset pin		•	l
RESET	Bidirectional reset with Schmitt-Trigger characteristics and noise filter. This pin has medium drive strength. Output drive is open drain and must be terminated by an external resistor of value 1KOhm. <sup>6</sup>	Bidirectional	31	P2
	Test pin		•	
VPP TEST	Pin for testing purpose only. To be tied to ground in normal operating mode.		107	D15

<sup>&</sup>lt;sup>1</sup> This pad is configured for Fast (F) pad speed.

#### **NOTE**

None of system pins (except RESET) provides an open drain output.

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<sup>&</sup>lt;sup>2</sup> This pad contains a weak pull-up.

<sup>&</sup>lt;sup>3</sup> EXTAL is an "Output" in "crystal" mode, and is an "Input" in "ext clock" mode.

In XOSC Bypass Mode, the analog portion of crystal oscillator (amplifier) is disabled. An external clock can be applied at EXTAL as an input. In XOSC Normal Mode, EXTAL is an output

<sup>&</sup>lt;sup>5</sup> This pad contains a weak pull-down.

<sup>&</sup>lt;sup>6</sup> RESET output shall be considered valid only after the 3.3V supply reaches its stable value.

# 2.4 Pin muxing

Table 7 defines the pin list and muxing for this device.

Each entry of Table 7 shows all the possible configurations for each pin, via the alternate functions. The default function assigned to each pin after reset is indicated by ALT0.

### NOTE

Pins labeled "NC" are to be left unconnected. Any connection to an external circuit or voltage may cause unpredictable device behavior or damage.

Pins labeled "Reserved" are to be tied to ground. Not doing so may cause unpredictable device behavior.

## Table 7. Pin muxing

		Alternate	a)	Judino	†II dal	xiim ‡iidal	Weak pull	Pad speed <sup>1</sup>	peed1	<u>.</u>	Pin #	
PCR Peripheral output Cutput mux sel	output function		an w	sel	functions	select	config during reset	SRC = 1	SRC = 0	· <u>-</u>	144 pkg	257 pkg
					Port A							
PCR[0] SIUL GPIO[0] ALTO	[0]OIA9		ALT0		GPIO[0]	I	I	Σ	တ		73	T14
eTimer_0 ETC[0] ALT1	ETC[0]		ALT1		ETC[0]	PSMI[35]; PADSEL=0						
DSPI_2 SCK ALT2	SCK		ALT2		SCK	PSMI[1]; PADSEL=0						
SINT	1		I		EIRQ[0]	1						
PCR[1] SIUL GPIO[1] ALTO	GPI0[1]		ALT0		GPIO[1]	I	I	Σ	ဟ		74	R14
eTimer_0 ETC[1] ALT1	ETC[1]		ALT1		ETC[1]	PSMI[36]; PADSEL=0						
DSPI_2 SOUT ALT2	SOUT		ALT2		I	I						
- I SINF	I				EIRQ[1]	I						

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Table 7. Pin muxing (continued)

Pin #	144 257 pkg pkg	84 N16							92 K17										
Pad speed <sup>1</sup>	SC SRC 1 = 0	S							Ø										
Weak pull Pac	configduring SRC reset = 1	Pull down M																	
7114	select			PSMI[37]; PADSEL=0	PSMI[37]; PADSEL=0 PSMI[23]; PADSEL=0	PSMI[37]; PADSEL=0 PSMI[23]; PADSEL=0 PSMI[2]; PADSEL=0 ————————————————————————————————————	PSMI[37]; PADSEL=0 PSMI[23]; PADSEL=0 PSMI[2]; PADSEL=0 — — — — — — — — — — — — — — — — — — —	PSMI[37]; PADSEL=0 PSMI[23]; PADSEL=0 PSMI[2]; PADSEL=0 — — — — — — — — — — — — — — — — — — —	PSMI[37]; PADSEL=0 PSMI[23]; PADSEL=0 PSMI[2]; PADSEL=0 — — — — PSMI[38]; PADSEL=0 PSMI[38]; PADSEL=0 PSMI[37]; PADSEL=0 PSMI[27];	PSMI[37]; PADSEL=0 PSMI[23]; PADSEL=0 PSMI[2]; PADSEL=0 ————————————————————————————————————	PSMI[37]; PADSEL=0 PSMI[23]; PADSEL=0 PSMI[2]; PADSEL=0 ————————————————————————————————————	PSMI[37]; PADSEL=0 PSMI[23]; PADSEL=0 PSMI[2]; PADSEL=0	PSMI[37]; PADSEL=0 PSMI[23]; PADSEL=0 PSMI[2]; PADSEL=0	PSMI[37]; PADSEL=0 PSMI[2]; PADSEL=0	PSMI[37]; PADSEL=0 PSMI[23]; PADSEL=0 PSMI[2]; PADSEL=0	PSMI[37]; PADSEL=0 PSMI[23]; PADSEL=0 PSMI[2]; PADSEL=0			
1	functions	GPIOI21	2 2 2 1 2 1 2 1 2 1	ETC[2]	ETC[2] A[3]	ETC[2] A[3] SIN	ETC[2] A[3] SIN ABS[0]	ETC[2] A[3] SIN ABS[0] EIRQ[2]	ETC[2] A[3] A[3] ABS[0] EIRQ[2] GPIO[3]	A[3] A[3] A[3] ABS[0] EIRQ[2] GPIO[3] ETC[3]	A[3] A[3] A[3] ABS[0] EIRQ[2] GPIO[3] ETC[3] CS0	A[3] A[3] A[3] ABS[0] EIRQ[2] GPIO[3] ETC[3] CS0 CS0	A[3] A[3] A[3] ABS[0] EIRQ[2] GPI0[3] ETC[3] ETC[3] B[3] ABS[2]	A[3] A[3] A[3] A[3] ABS[0] EIRQ[2] GPIO[3] ETC[3] CS0 CS0 CS0 ABS[2] EIRQ[3]	A[3] A[3] A[3] A[3] ABS[0] EIRQ[2] GPIO[3] ETC[3] ETC[3] EIRQ[2] GPIO[4]	A[3] A[3] A[3] ABS[0] EIRQ[2] GPIO[3] ETC[3] ETC[3] B[3] ABS[2] B[3] ABS[2] EIRQ[3] GPIO[4] ETC[0]	A[3] A[3] A[3] A[3] ABS[0] EIRQ[2] GPIO[3] ETC[3] CS0	A[3] A[3] A[3] A[3] ABS[0] EIRQ[2] GPIO[3] ETC[3] ETC[3] EIRQ[3] GPIO[4] ETC[0]  — — — — — — — — — — — — — — — — — —	A[3] A[3] A[3] ABS[0] EIRQ[2] GPIO[3] ETC[3] ETC[3] B[3] ABS[2] EIRQ[3] GPIO[4] ETC[0] ETC[0] FAB
	mux sel	ALT0		ALT1	ALT1 ALT3	ALT1 ALT3	ALT1 ALT3 —	ALT1 ALT3 ————————————————————————————————————	ALT3 ALT3 ALT0	ALT3 ALT3	ALT3 ALT3 ALT0 ALT1 ALT1	ALT3 ALT7 ALT7 ALT7 ALT7 ALT7	ALT3 ALT7 ALT7 ALT7 ALT7 ALT7 ALT7	ALT1 ALT3 ALT2 ALT3 ALT3 ALT3	ALT3 ALT7 ALT7 ALT7 ALT7 ALT7 ALT7	ALT3 ALT7 ALT7 ALT7 ALT7 ALT7 ALT7 ALT7	ALT3 ALT2 ALT3 ALT3 ALT4 ALT7 ALT7 ALT7 ALT7 ALT7	ALT3 ALT3 ALT4 ALT7 ALT7 ALT7 ALT7 ALT7 ALT7 ALT7 ALT7	ALT3 ALT7 ALT7 ALT7 ALT7 ALT7 ALT7 ALT7 ALT7
output	function	GPIO[2]	ETC[2]		A[3]	A[3]	A[3]	A[3]	A[3]	A[3]	A[3]  — — — — — — — — — — — — — — — — — —	A[3]	A[3]  — — — — — — — — — — — — — — — — — —	A[3]  — — — — — — — — — — — — — — — — — —	A[3]	A[3]  — — — — — — — — — — — — — — — — — —	A[3]  — — — — — — — — — — — — — — — — — —	A[3]  — — — — — — — — — — — — — — — — — —	A[3]  — — — — — — — — — — — — — — — — — —
Darinharal	רפווטויפומו	SIUL	eTimer_0	FlexPWM_0		DSPI_2	DSPI_2 MC_RGM	DSPI_2 MC_RGM SIUL	DSPI_2 MC_RGM SIUL SIUL	DSPI_2 MC_RGM SIUL SIUL SIUL	DSPI_2 MC_RGM SIUL SIUL eTimer_0 DSPI_2	DSPI_2 MC_RGM SIUL SIUL SIUL eTimer_0 DSPI_2 FlexPWM_0	DSPI_2 MC_RGM SIUL SIUL SIUL eTimer_0 DSPI_2 DSPI_2 MC_RGM	DSPI_2 MC_RGM SIUL SIUL eTimer_0 DSPI_2 FlexPWM_0	DSPI_2 MC_RGM SIUL SIUL SIUL ETimer_0 DSPI_2 FlexPWM_0 MC_RGM SIUL SIUL	DSPI_2 MC_RGM SIUL SIUL ETimer_0 DSPI_2 MC_RGM SIUL SIUL SIUL SIUL ETimer_1	DSPI_2 MC_RGM SIUL SIUL SIUL DSPI_2 FlexPWM_0 MC_RGM SIUL SIUL SIUL SIUL DSPI_2	DSPI_2 MC_RGM SIUL SIUL SIUL ETIMEr_0 MC_RGM SIUL SIUL SIUL SIUL SIUL SIUL ETIMEr_1 ETIMEr_1 ETIMEr_0	DSPI_2 MC_RGM SIUL SIUL SIUL DSPI_2 FlexPWM_0 MC_RGM SIUL SIUL SIUL SIUL SIUL SIUL SIUL SIUL
PCR	;	PCR[2]	I	I					PCR[3]	PCR[3]	PCR[3]	PCR[3]	PCR[3]	PCR[3]	PCR[3]	PCR[4]	PCR[3]	PCR[3]	PCR[4]
name	)	A[2]							A[3]	A[3]	A[3]	A[3]	A[3]	A[3]	A[3]	A[4]	A[3]	A[3]	A[4]

Table 7. Pin muxing (continued)

	257 pkg	¥					G4			F3			F4			B6			
#																			
Pin #	144 pkg	14					2			10			12			134			
peed1	SRC = 0	တ					S			တ			S			တ			
Pad speed <sup>1</sup>	SRC = 1	Σ					Σ			Σ			Σ			Σ			
Weak pull	config during reset	I					I			I			I			I			
yi w tildal	select	I	I	PSMI[14]; PADSEL=0	I	I		I	I	I	I	I	I	I	I	I	I	PSMI[27]; PADSEL=1	PSMI[16]; PADSEL=0
1	functions	GP10[5]	CS0	ETC[5]	I	EIRQ[5]	GPIO[6]	SCK	EIRQ[6]	GP10[7]	I	EIRQ[7]	GPIO[8]	SIN	EIRQ[8]	GP10[9]	ı	B[3]	FAULT[0]
1	mux sel	ALT0	ALT1	ALT2	ALT3	I	ALT0	ALT1	I	ALT0	ALT1	I	ALT0	I	I	ALT0	ALT1	ALT3	1
Alternate	output function	GP10[5]	CS0	ETC[5]	CS7	I	[9]OI49	SCK	I	GPI0[7]	SOUT	I	GP10[8]	I	I	(B)(J)	CS1	B[3]	I
	Peripheral	SIUL	DSPI_1	eTimer_1	DSPI_0	SIUL	SIUL	DSPI_1	SIUL	SIUL	DSPI_1	SIUL	SIUL	DSPI_1	SIUL	SIUL	DSPI_2	FlexPWM_0	FlexPWM_0
	PCR	PCR[5]		•			PCR[6]			PCR[7]			PCR[8]			PCR[9]			•
ţ	name	A[5]					A[6]			A[7]			A[8]			A[9]			

Table 7. Pin muxing (continued)

	<b>P</b> E	က					<u>_</u>					0				
	257 pkg	A13					D11					A10				
Pin #	144 pkg	118					120					122				
<u>_</u>	U <sub>0</sub>															
Pad speed <sup>1</sup>	SRC = 0	S					တ					S				
Pad	SRC = 1	Σ					Σ					Σ				
Weak pull	config during reset						1					1				
Wea	config re	•					•					•				
XIIW	ect	i	I[3]; EL=1	[24]; EL=0	[29]; EL=0			I[1]; EL=1	[20]; EL=0	[22]; EL=0	i	ı	ı	[22]; EL=1	[26]; EL=0	
Yilm tilloul	select		PSMI[3]; PADSEL=1	PSMI[24]; PADSEL=0	PSMI[29]; PADSEL=0	l	I	PSMI[1]; PADSEL=1	PSMI[20]; PADSEL=0	PSMI[22]; PADSEL=0	l	I	ļ	PSMI[22]; PADSEL=1	PSMI[26]; PADSEL=0	I
+	suc	10]				[6]	11]				10]	12]				11]
<u> </u>	functions	GP10[10]	CSO	B[0]	X[2]	EIRQ[9]	GP10[11]	SCK	A[0]	A[2]	EIRQ[10]	GP10[12]	1	A[2]	B[2]	EIRQ[11]
1 c	mux sel	ALTO	ALT1	ALT2	ALT3	I	ALTO	ALT1	ALT2	ALT3		ALTO	ALT1	ALT2	ALT3	1
	? E															
nate	put tion	[10]	00	[C	2]		)[11]	X	0	2]		[12]	1	7]	2]	ı
Alternate	output function	GPI0[10]	CSO	B[0]	X[2]		GP10[11]	SCK	A[0]	A[2]		GPI0[12]	SOUT	A[2]	B[2]	
	<u></u>			0	0				0	0				0	0	
	Peripheral	SIUL	DSPI_2	FlexPWM_0	FlexPWM_0	SIUL	SIUL	DSPI_2	FlexPWM_0	FlexPWM_0	SIUL	SINL	DSPI_2	FlexPWM_0	FlexPWM_0	SIUL
	Peri	S	DS	FlexF	FlexF	S	S	DS	Flex	FlexF	S	S	SO	Flex	Flex	S
	œ	[10]	ı	1	1	1	[11]	ı	ı	ı	l .	[12]	l .	ı	ı	
	PCR	PCR[10]					PCR[11]					PCR[12]				
Fort	name	A[10]					A[11]					A[12]				
۵	- e	¥					₹					¥				

Table 7. Pin muxing (continued)

	257 pkg	90					B4				D3						B15				
Pin #	144 pkg	136					143				144						109				
Pad speed <sup>1</sup>	SRC =0	S					တ				တ						တ				
	SRC = 1	Σ					Σ				Σ						Σ				
Weak pull	config during reset	_					I				I						Ι				
Input mix	select	1	PSM[26]; PADSEL=1	PSMI[2]; PADSEL=1	PSMI[16]; PADSEL=1	I		I	PSMI[13]; PADSEL=0	I	I	PSM[14]; PADSEL=1	PSMI[34]; PADSEL=0	PSMI[33]; PADSEL=0	I		I	I	PSMI[11]; PADSEL=0	1	I
ţ	functions	GP10[13]	B[2]	NIS	FAULT[0]	EIRQ[12]	GPIO[14]	I	ETC[4]	EIRQ[13]	GPI0[15]	ETC[5]	RXD	RXD	EIRQ[14]	Port B	GPI0[16]	I	ETC[2]	l	FIRO[15]
Output	mux sel	ALT0	ALT2		I	I	ALT0	ALT1	ALT2	I	ALT0	ALT2		I	-		ALT0	ALT1	ALT2	ALT3	
Alternate	output function	GPI0[13]	B[2]	I	I	I	GPI0[14]	TXD	ETC[4]	I	GPI0[15]	ETC[5]	I	I	Ι		GPI0[16]	TXD	ETC[2]	DEBUG[0]	1
	Peripheral	SINL	FlexPWM_0	DSPI_2	FlexPWM_0	SIUL	SIUL	FlexCAN_1	eTimer_1	SIUL	SIUL	eTimer_1	FlexCAN_1	FlexCAN_0	SIUL		SIUL	FlexCAN_0	eTimer_1	SSCM	SIUL
	PCR	PCR[13]	l	l	1	I	PCR[14]	1	l	I	PCR[15]	I	l	l	I		PCR[16]	l	l	1	1
Port	name	A[13]					A[14]				A[15]						B[0]				

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Table 7. Pin muxing (continued)

#### C14 B13 M15 257 pkg A14 L17 $\mathbf{B}$ 3 144 pkg 110 114 116 138 83 86 SRC Pad speed<sup>1</sup> 0 ഗ ഗ ഗ ഗ ഗ ഗ SRC ī ≥ ≥ Σ ш Σ ட Weak pull configduring reset Pull up Input mux select PSMI[12]; PADSEL=0 PSMI[31]; PADSEL=0 PSMI[33]; PADSEL=1 PSMI[34]; PADSEL=1 Input functions GPI0[17] EIRQ[17] EIRQ[16] GP10[18] **GPIO[19]** GP10[21] EIRQ[18] **GPIO[20]** GP10[22] ETC[3] RXDRXD X $\overline{\Box}$ Output mux sel ALT2 ALT3 ALT3 ALT0 ALT3 ALT0 ALT0 ALT0 **ALT0** ALT1 ALT1 ALT1 Alternate output function DEBUG[2] GP10[17] DEBUG[3] DEBUG[1] **GPIO[18] GPIO[19]** GPIO[20] GP10[22] GP10[21] ETC[3] clk\_out 100 X CS2 LINFlexD\_0 FlexCAN\_0 FlexCAN\_1 Peripheral MC\_CGM DSPI\_2 eTimer\_1 \_INFlexD\_ JTAGC SSCM SSCM SSCM JTAGC SIUL SINL SINL SINT SIUL SIUL SINE SIUL SIUL PCR[20] PCR[17] PCR[21] PCR[22] **PCR[18]** PCR[19] PCR Port name B[5] B[6] B[2] B[3]

Table 7. Pin muxing (continued)

#### R10 257 pkg R5 88 8 8 7 Ρ7 144 pkg 22 43 53 9 47 52 54 SRC =0 Pad speed<sup>1</sup> SRC ī Weak pull configduring reset Input mux select PSMI[8]; PADSEL=2 PSMI[32]; PADSEL=0 PSMI[31]; PADSEL=1 Input functions AN[11]<sup>3</sup> GPI[26] GPI[27] GPI[23] GPI[25] GPI[28] AN[14]<sup>3</sup> GPI[29] GPI[24] **ETC[5]** AN[1]<sup>3</sup> AN[12]<sup>3</sup> AN[13]<sup>3</sup> $AN[0]^3$ $AN[0]^3$ RXD RXD Output mux sel ALT0 ALT0 Alternate output function LINFlexD\_0 LINFlexD\_1 Peripheral eTimer\_0 ADC\_0 ADC\_1 ADC\_0 ADC\_0 ADC\_0 ADC\_1 ADC\_0 ADC\_1 ADC\_0 ADC\_1 ADC\_1 SINL SINF SINF SINL SINF SINF SIUL PCR[23] PCR[25] PCR[29] PCR[24] PCR[26] PCR[27] PCR[28] PCR Port name B[10] B[12] B[13] B[9]

Table 7. Pin muxing (continued)

ţ			Alternate	110	1100	VIII TIICA	Weak pull	Pad s	Pad speed <sup>1</sup>	# uiA	#
name	PCR	Peripheral	output function	mux sel	functions	select	config during reset	SRC = 1	SRC = 0	144 pkg	257 pkg
B[14]	PCR[30]	SINL	I	ALTO	[0E]Id9	1	I	I	ı	64	P11
		eTimer_0	I	I	ETC[4]	PSMI[7]; PADSEL=2					
		SIUL	I		EIRQ[19]						
		ADC_1	I		AN[1] <sup>3</sup>	I					
B[15]	PCR[31]	SINL	I	ALT0	GPI[31]	1	I		ı	62	R11
		SINL	I	1	EIRQ[20]	1					
		ADC_1	I	I	AN[2] <sup>3</sup>	I					
					Port C						
C[0]	PCR[32]	SINL	I	ALT0	GPI[32]	1	I			99	R12
		ADC_1	I	I	AN[3] <sup>3</sup>	I					
C[1]	PCR[33]	SINL	I	ALT0	GPI[33]	I	I		I	41	T4
		ADC_0	I	I	AN[2] <sup>3</sup>	I					
C[2]	PCR[34]	SINL	I	ALT0	GPI[34]	I	I	I	I	45	U5
		ADC_0	I	1	AN[3] <sup>3</sup>	I					
C[4]	PCR[36]	SINL	GP10[36]	ALT0	[9E]OI49	1	I	Σ	တ	11	H
		DSPI_0	0SO	ALT1	OSO	1					
		FlexPWM_0	X[1]	ALT2	X[1]	PSMI[28]; PADSEL=0					
		SSCM	DEBUG[4]	ALT3	I	I					
		SIUL	I	I	EIRQ[22]	1					

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Table 7. Pin muxing (continued)

#### A15 M14 257 pkg G3 4 <u>주</u> 144 pkg 142 11 2 13 8 SRC Pad speed<sup>1</sup> 0 ഗ ഗ ഗ ഗ ഗ SRC ī ≥ ≥ ≥ ≥ ≥ Weak pull configduring reset Input mux select PSMI[25]; PADSEL=0 PSMI[21]; PADSEL=0 PSMI[17]; PADSEL=0 PSMI[19]; PADSEL=0 PSMI[7]; PADSEL=1 PSMI[23]; PADSEL=1 Input functions FAULT[3] GPI0[37] **EIRQ[24] GPIO[42]** FAULT[1] EIRQ[23] GP10[38] GPIO[39] **GPIO[43] ETC[4]** SCK B[1] A[1] $\frac{Z}{S}$ A[3] Output mux sel ALT3 ALT0 ALT0 ALT2 ALT3 ALT0 ALT2 ALT3 ALT3 ALT0 ALT0 ALT1 ALT1 ALT1 ALT1 Alternate output function DEBUG[5] DEBUG[6] DEBUG[7] **GPIO[42] GPIO[43]** GP10[37] GP10[38] GPIO[39] ETC[4] SOUT SCK B[1] A[1] CS2 A[3] FlexPWM\_0 FlexPWM\_0 FlexPWM\_0 FlexPWM\_0 FlexPWM\_0 Peripheral DSPI\_2 DSPI\_0 eTimer\_0 DSPI\_0 DSPI\_2 DSPI 0 SSCM SSCM SSCM SINL SINL SIUL SINL SIUL SIUL SIUL PCR[38] PCR[39] PCR[37] PCR[42] PCR[43] PCR Port name C[10] C[5] C[6] C[7]

Table 7. Pin muxing (continued)

Γ		7	2			2				2			~					
		257 pkg	N15			F15				E15			A8					
	Pin #	144 pkg	82			101				103			124					
7	seed'	SRC =0	S			S				S			S					
	Pad speed	SRC = 1	Σ			Σ				Σ			SYM					
	Weak pull	config during reset	I			I				I			I					
	Input mix	select	I	PSMI[8]; PADSEL=0		I	PSMI[10]; PADSEL=0	PSMI[0]; PADSEL=0	PSMI[15]; PADSEL=0	I	PSMI[11]; PADSEL=1	I	I	I	PSMI[9]; PADSEL=1	PSMI[21]; PADSEL=1	PSMI[0]; PADSEL=1	PSMI[15]; PADSEL=1
	‡iou	functions	GPI0[44]	ETC[5]	ı	GPIO[45]	ETC[1]	EXT_IN	EXT_SYNC	GP10[46]	ETC[2]	I	GPI0[47]	I	ETC[0]	A[1]	EXT_IN	EXT_SYNC
	ti di i	mux sel	ALT0	ALT1	ALT2	ALT0	ALT1	I		ALT0	ALT1	ALT2	ALT0	ALT1	ALT2	ALT3	I	I
	Alternate	output function	GPI0[44]	ETC[5]	CS3	GPIO[45]	ETC[1]	I	I	GPIO[46]	ETC[2]	EXT_TGR	GPI0[47]	CA_TR_EN	ETC[0]	A[1]	I	I
		Peripheral	SIUL	eTimer_0	DSPI_2	SIUL	eTimer_1	CTU_0	FlexPWM_0	SIUL	eTimer_1	CTU_0	SIUL	FlexRay	eTimer_1	FlexPWM_0	CTU_0	FlexPWM_0
		PCR	PCR[44]			PCR[45]				PCR[46]			PCR[47]					
	Port	name	C[12]			C[13]				C[14]			C[15]					

Table 7. Pin muxing (continued)

	257 pkg		88 88				E3				C5				A7			
#			-															
Pin #	144 pkg		125				3				140				128			
eed1	SRC = 0		တ				တ				ဟ				တ			
Pad speed <sup>1</sup>	SRC = 1		SYM				Σ				Σ				SYM			
	l		0)												(0)			
Weak pull	config during reset		1				1				I				I			
noilt mix		-	I	I	PSMI[10]; PADSEL=1	PSMI[25]; PADSEL=1	I	PSMI[11]; PADSEL=2	I	I	1	PSMI[12]; PADSEL=1	PSMI[30]; PADSEL=0	I	I	I	PSMI[13]; PADSEL=1	PSMI[23]; PADSEL=2
ļ.	functions	Port D	GP10[48]	I	ETC[1]	B[1]	GPIO[49]	ETC[2]	I	CA_RX	GP10[50]	ETC[3]	X[3]	CB_RX	GP10[51]	I	ETC[4]	A[3]
ţi d	mux sel	-	ALT0	ALT1	ALT2	ALT3	ALT0	ALT2	ALT3	I	ALT0	ALT2	ALT3	I	ALT0	ALT1	ALT2	ALT3
Alternate	output function		GPIO[48]	CA_TX	ETC[1]	B[1]	GPIO[49]	ETC[2]	EXT_TGR	I	GPIO[50]	ETC[3]	X[3]	I	GPI0[51]	CB_TX	ETC[4]	A[3]
	Peripheral		SIUL	FlexRay	eTimer_1	FlexPWM_0	SIUL	eTimer_1	CTU_0	FlexRay	SIUL	eTimer_1	FlexPWM_0	FlexRay	SIUL	FlexRay	eTimer_1	FlexPWM_0
	PCR		PCR[48]	•			PCR[49]				PCR[50]				PCR[51]			
T C	name		[0]Q				D[1]				D[2]				D[3]			

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Table 7. Pin muxing (continued)

	257 pkg	B7				N3			P3				R4				M3				
Pin #	144 pkg	129				33			34				37				32				
Pad speed <sup>1</sup>	SRC = 0	S				တ			တ				တ				S				
Pad s	SRC = 1	SYM				Σ			Σ				Σ				Σ				
Weak pull	config during reset	1				1			I				I				I				
Input mux	select	1	I	PSMI[14]; PADSEL=2	PSMI[27]; PADSEL=2	I	I	PSMI[18]; PADSEL=0	I	I	PSMI[30]; PADSEL=1	PSMI[17]; PADSEL=1	I	I	I	I	I	I	PSMI[13]; PADSEL=2		PSMI[19]; PADSEL=1
Input	functions	GPI0[52]	I	ETC[5]	B[3]	GPIO[53]	I	FAULT[2]	GPI0[54]	I	X[3]	FAULT[1]	GP10[55]	I	I	I	GP10[56]	I	ETC[4]	I	FAULT[3]
Output	mux sel	ALTO	ALT1	ALT2	ALT3	ALT0	ALT1	I	ALT0	ALT1	ALT3	I	ALT0	ALT1	ALT3	I	ALT0	ALT1	ALT2	ALT3	I
Alternate	output function	GPI0[52]	CB_TR_EN	ETC[5]	B[3]	GPI0[53]	CS3	I	GPI0[54]	CS2	X[3]	I	GPI0[55]	CS3	CS4	analog output	GPI0[56]	CS2	ETC[4]	CS5	1
	Peripheral	SIUL	FlexRay	eTimer_1	FlexPWM_0	SIUL	DSPI_0	FlexPWM_0	SIUL	DSPI_0	FlexPWM_0	FlexPWM_0	SIUL	DSPI_1	DSPI_0	SWG	SIUL	DSPI_1	eTimer_1	DSPI_0	FlexPWM_0
(	PCR R	PCR[52]	ı			PCR[53]		1	PCR[54]			1	PCR[55]	1	1	1	PCR[56]	1	1	ı	
Port	name	D[4]				D[5]			[9]0				[2]0				D[8]				

Table 7. Pin muxing (continued)

Port		,	Alternate	Output	Input	Input mux	Weak pull	Pad speed <sup>1</sup>	peed1	_	Pin #	
name	PCR	Peripheral	output function	mux sel	functions	select	config during reset	SRC = 1	SRC = 0		144 pkg	257 pkg
D[9]	PCR[57]	SINL	GPI0[57]	ALT0	GP10[57]	1	I	Σ	S		26	F3
		FlexPWM_0	[0]X	ALT1	[0]X	I						
		LINFlexD_1	TXD	ALT2	I	I						
D[10]	PCR[58]	SIUL	GPIO[58]	ALT0	GP10[58]	I	I	Σ	ဟ		92	T15
		FlexPWM_0	A[0]	ALT1	A[0]	PSMI[20]; PADSEL=1						
		eTimer_0	I	I	ETC[0]	PSMI[35]; PADSEL=1						
D[11]	PCR[59]	SIUL	GPIO[59]	ALT0	GP10[59]	I	I	Σ	တ		78	R16
		FlexPWM_0	B[0]	ALT1	B[0]	PSMI[24]; PADSEL=1						
		eTimer_0	I	I	ETC[1]	PSMI[36]; PADSEL=1						
D[12]	PCR[60]	SIUL	GPIO[60]	ALT0	GPIO[60]		I	Σ	ဟ		66	G14
		FlexPWM_0	X[1]	ALT1	X[1]	PSMI[28]; PADSEL=1						
		LINFlexD_1	I	I	RXD	PSMI[32]; PADSEL=1						
D[14]	PCR[62]	SINL	GPI0[62]	ALT0	GPIO[62]	1	I	Σ	S		105	D16
		FlexPWM_0	B[1]	ALT1	B[1]	PSMI[25]; PADSEL=2						
		eTimer_0	I	I	ETC[3]	PSMI[38]; PADSEL=1						
					Port E							
E[0]	PCR[64]	SINF	_	ALTO	GPI[64]	_	_	I	ı		89	T13
		ADC_1	I	1	AN[5] <sup>3</sup>	_						
E[2]	PCR[66]	SINF	1	ALT0	GPI[66]	_	_	I			49	90
		ADC_0	I	I	AN[5] <sup>3</sup>							

Table 7. Pin muxing (continued)

#### **D12** B12 T10 T12 257 pkg 11 U4 **1**2 **R**6 <u>1</u> **T11** 144 pkg 119 117 42 46 48 63 65 4 61 67 SRC Pad speed<sup>1</sup> 0 ഗ ഗ 1 SRC ī Σ ≥ Weak pull configduring reset Input mux select PSMI[14]; PADSEL=3 PSMI[8]; PADSEL=1 Input functions GPI0[78] **GPIO[77] EIRQ[25]** EIRQ[26] GPI[73] GPI[74] GPI[75] GPI[76] ETC[5] GPI[68] GPI[69] GPI[70] AN[4]<sup>3</sup> GPI[71] AN[7]<sup>3</sup> AN[8]<sup>3</sup> AN[4]<sup>3</sup> AN[6]<sup>3</sup> ETC[5] AN[7]<sup>3</sup> AN[8]<sup>3</sup> AN[6]<sup>3</sup> Output mux sel ALT0 ALT0 ALT0 **ALT0** ALT1 ALT1 Alternate output function **GPI0[77]** GP10[78] ETC[5] ETC[5] CS3 Peripheral DSPI\_2 eTimer\_0 eTimer\_1 ADC\_0 ADC\_0 ADC\_0 ADC\_0 ADC\_1 ADC\_1 ADC\_1 ADC\_1 SIUL SIUL SIUL SIUL SIUL SIUL SINL SIUL SIUL SIUL SIUL SIUL PCR[73] **PCR[74]** PCR[75] PCR[76] **PCR[78]** PCR[68] PCR[69] PCR[70] PCR[77] PCR[71] PCR Port name E[12] E[14] E[10] E[13] E[4] E[7] E[9] E[5] E[6]

Table 7. Pin muxing (continued)

GPIO[79]	79] — — — M  27] — — — M  80] — — — M  80] — — — M  PADSEL=2 2] PSMI[37]; PADSEL=1 P	79] — — — M 27] — — — M 80] — — — — M 80] — — — — M PADSEL=2 2] PSMI[37]; PADSEL=1 28] — — — M 83] — — — M 84] — — F	79] — — — M 27] — — — M 80] — — — — M PSMI[21]; PADSEL=1 2] PSMI[37]; PADSEL=1 28] — — — M 83] — — — M 84] — — F	79] — — — M 27] — — — M 80] — — — M PADSEL=2 2] PSMI[37]; PADSEL=1 PADSEL=1 28] — — — M 83] — — — M 84] — — — F 85] — — F	79] — — — M 80] — — — M 80] — — — M PADSEL=2 2] PSMI[37]; PADSEL=1 28] — — — M 83] — — — F 84] — — — F 85] — — F	27] — — — M 27] — — — M 80] — — — M PADSEL=2 PADSEL=1 28] — — — M 83] — — — F 84] — — — F 85] — — — F 86] — — F	27] — — — M 80] — — — M 80] — — — M PADSEL=2 2] PSMI[37]; PADSEL=1 28] — — — M 84] — — — F 85] — — — F 86] — — F	27] — — — M 80] — — — M 80] — — — — M PADSEL=2 2] PSMI[37]; PADSEL=1 28] — — — F 84] — — — F 85] — — — F 86] — — — F 87] — — F	79] — — — — M — — — — — — M — — — — — — —	PSMI[21]; PADSEL=2 PSMI[37]; PADSEL=1	27] — — — — M — — — — — — — — — — — — — —	27] — — — M M — — — — — M M — — — — — — —	27] — — — — M — — — — — — — — — — — — — —
27] — — — — — — — — — — — — — — — — — — —	27] — — — — — — — — — — — — — — — — — — —	27] — — — — — — — — — — — — — — — — — — —	27] — — — — — — — — — — — — — — — — — — —	27] — — — — — — — — — — — — — — — — — — —	27] — — — — — — — — — — — — — — — — — — —	27] — — — — — — — — — — — — — — — — — — —	27] — — — — — — — — — — — — — — — — — — —	27] — — — — — — — — — — — — — — — — — — —	27] — — — — — — — — — — — — — — — — — — —	PSMI[21]; PADSEL=2 PSMI[37]; PADSEL=1	27] — — — — — — — — — — — — — — — — — — —	27] — — — — — — — — — — — — — — — — — — —	27] — — — — — — — — — — — — — — — — — — —
2]	23 23	277 278 331 289 281 281 281 281 281 281 281 281 281 281	2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2	25 21 23 83 83 83 83 83 83 83 83 83 83 83 83 83	2	2]	23 23 23 23 24 28 28 28 28 28 28 28 28 28 28 28 28 28	21	2	<del>                                     </del>	2	2	21
EIRQ[27]   Port F     GPIO[80]   A[1]   ETC[2]   EIRQ[28]   GPIO[83]	EIRQ[27]   Port F   GPIO[80]   A[1]   ETC[2]   ETC[2]   GPIO[83]	IRQ[27]   ort F	(Q[27] 10[80] 10[80] 10[83] 10[84]	2[27] 2[21] 2[28] 2[28] 2[28] 2[28]	[27]	[27] [80] [8] [83] [84] [85]	[27] [80] [83] [84] [85]	1   1   1   1   1   1   1   1   1   1	277] [	[1]   [2]   [3]		[88]       [88]       [88]	[27]       [27]       [27]       [27]       [27]       [27]       [27]       [27]       [27]       [27]       [27]       [28]       [38]
FlexPWM_0 A[1]  eTimer_0 —  SIUL —  SIUL GPI0[83]													
Φ													
SINL		SIUL SIUL	SIUL SIUL SIUL NPC	SIUL SIUL SIUL SIUL SIUL SIUL SIUL	SIUL SIUL SIUL SIUL NPC NPC	SIUL SIUL SIUL SIUL SIUL SIUL SIUL SIUL	SIUL SIUL SIUL SIUL SIUL SIUL NPC	SIUL SIUL SIUL SIUL SIUL SIUL SIUL SIUL	SIUL SIUL SIUL SIUL SIUL SIUL SIUL NPC	SIUL SIUL SIUL SIUL SIUL SIUL SIUL SIUL	SIUL SIUL SIUL SIUL SIUL SIUL SIUL SIUL	SIUL SIUL SIUL SIUL SIUL SIUL SIUL SIUL	SIUL SIUL SIUL SIUL SIUL SIUL SIUL SIUL
SIUL GPIO[83]	SIUL GPIO[83] DSPI_0 CS6	SIUL GPIO[83]  DSPI_0 CS6  SIUL GPIO[84]	SIUL GPIO[83]  SIUL GPIO[84]  NPC MDO[3]	SIUL   GPIO[83]   SIUL   GPIO[84]   SIUL   GPIO[84]   SIUL   GPIO[85]   SIUL   GPI	SIUL   GPIO[83]	SIUL   GPIO[83]	SIUL   GPIO[83]	SIUL   GPIO[83]	SIUL   GPIO[83]	SIUL   GPIO[83]	SIUL   GPIO[83]	SIUL   GPIO[83]	SIUL   GPIO[83]
	980	SIUL GPIO[84]	SIUL GPIO[84] NPC MDO[3]	SIUL GPIO[84]  NPC MDO[3]  SIUL GPIO[85]	SIUL   GPIO[84]   NPC   MDO[3]   NPC   MDO[2]   MDO[2]   NPC   MDO[2]   MDO[2]	SIUL   GPIO[84]   NPC   MDO[3]   SIUL   GPIO[85]   SIUL   GPIO[86]   SIUL   GPIO[8	SIUL   GPIO[84]   NPC   MDO[3]   SIUL   GPIO[85]   NPC   MDO[2]   SIUL   GPIO[86]   NPC   MDO[1]   MDO[	SIUL   GPIO[84]   NPC   MDO[3]   NPC   MDO[2]   NPC   MDO[2]   NPC   MDO[2]   SIUL   GPIO[86]   NPC   MDO[1]   SIUL   GPIO[87]   SIUL   GPIO[87]   SIUL   GPIO[87]   NPC   MDO[1]   NPC	SIUL GPIO[84]  NPC MDO[3]  SIUL GPIO[85]  NPC MDO[2]  SIUL GPIO[86]  NPC MDO[1]  SIUL GPIO[87]	SIUL   GPIO[84]   NPC   MDO[3]   SIUL   GPIO[85]   NPC   MDO[7]   SIUL   GPIO[86]   NPC   MDO[1]   SIUL   GPIO[87]   SIUL   GPIO[88]   S	SIUL   GPIO[84]   SIUL   GPIO[84]   SIUL   GPIO[85]   SIUL   GPIO[86]   SIUL   GPIO[86]   SIUL   GPIO[87]   SIUL   GPIO[87]   SIUL   GPIO[87]   SIUL   GPIO[88]   SIUL   GPI	SIUL   GPIO[84]   SIUL   GPIO[85]   SIUL   GPIO[85]   SIUL   GPIO[85]   SIUL   GPIO[87]   SIUL   GPIO[88]   SIUL   GPIO[88]   SIUL   GPIO[88]   SIUL   GPIO[89]   SIUL   GPI	SIUL   GPIO[84]   NPC   MDO[3]   SIUL   GPIO[85]   NPC   MDO[1]   SIUL   GPIO[86]   NPC   MCKO   SIUL   GPIO[88]   NPC   MSEO[1]   SIUL   GPIO[88]   NPC   MSEO[1]   SIUL   GPIO[89]   NPC   MSEO[1]   SIUL   GPIO[89]   NPC   MSEO[0]   NPC

Table 7. Pin muxing (continued)

PCR 93  SIUL   Alternate   Autoriate										-			Ī	
SiUL   CPIO[91]   ALTO   CPIO[91]   CPIO[91]   CPIO[91]   CPIO[91]   CPIO[91]   CPIO[91]   CPIO[91]   CPIO[92]   CPIO[9				Alternate	Ç	ţiidu	Input mix	Weak pull	Pad sl	peed1	_	# Li		
SIUL   GPIO[91]   ALTO   GPIO[91]   —		2 	Peripheral	output function	mux sel	functions	select	config during reset	SRC = 1	SRC = 0			257 pkg	
NPC	ď	CR[91]	SIUL	GP10[91]	ALT0	GPIO[91]	1	1	Σ	S		25	7	
SIUL         GPIO[92]         ALT0         GPIO[92]         —         M         S         106           eTimer_1         ETC[3]         ALT1         ETC[3]         PSMI[12]:         M         S         112           SIUL         GPIO[93]         ALT0         GPIO[93]         —         M         S         112           SIUL         GPIO[94]         ALT1         ETC[4]         PSMI[13]:         —         M         S         115           LINFlexD_1         TXD         ALT0         GPIO[94]         —         —         M         S         113           LINFlexD_1         TXD         ALT0         GPIO[94]         —         —         M         S         113           FCCU         FI01         ALT0         GPIO[94]         —         —         M         S         113           FCCU         FCCU         F[0]         ALT0         GPIO[95]         —         M         S         141           FCCU         F[1]         ALT0         F[1]         —         S         S         S         141           FICCU         F[1]         ALT0         GPIO[98]         —         —         S         S			NPC	I	ALT2	EVTI	I							
SIUL	<u> </u>	CR[92]	SIUL	GPI0[92]	ALT0	GPIO[92]	I	I	Σ	S			C17	
SIUL         —         —         EIRQ[30]         —         M         S         112           SIUL         GPIO[93]         ALT0         GPIO[93]         —         M         S         112           eTimer_1         ETC[4]         ALT1         ETC[4]         PSMI[13]; P			eTimer_1	ETC[3]	ALT1	ETC[3]	PSMI[12]; PADSEL=2							
SIUL         GPIO[93]         ALT0         GPIO[93]         —         M         S         112           eTime_1         ETC[4]         ALT1         ETC[4]         PSMI[13]: PADSEL=3         N         S         115           SIUL         —         —         —         M         S         115           LINFlexD_1         TXD         ALT0         GPIO[94]         —         M         S         115           LINFlexD_1         TXD         ALT0         GPIO[95]         —         —         M         S         113           LINFlexD_1         TXD         ALT0         GPIO[95]         —         —         M         S         113           FCCU         F[0]         ALT0         F[0]         —         —         S         S         S         S         S         141           FCCU         F[1]         ALT0         F[1]         —         —         S         S         S         141           FCCU         F[1]         ALT0         GPIO[98]         —         —         S         S         S         141           FIRSPWM_0         X[2]         ALT1         X[2]         PSWIGEL=2         —	_		SIUL	I	1	EIRQ[30]	I							
eTIMEL_1         ETC[4]         ALT1         ETC[4]         PSMI[13];         ALT0         GPIO[94]         ALT0         GPIO[94]         ALT0         GPIO[94]         ALT0         GPIO[95]         ALT1         ALT2		PCR[93]	SIUL	GP10[93]	ALT0	GP10[93]	1	1	Σ	S			B14	
SIUL         —         —         —         —         M         S         115           LINFlexD_1         TXD         ALTO         GPIO[94]         —         M         S         115           LINFlexD_1         TXD         ALTO         GPIO[95]         —         M         S         113           LINFlexD_1         —         —         RXD         PSMI[32];         —         M         S         113           FCCU         F[0]         ALTO         F[0]         —         S         S         S         38           FCCU         F[1]         ALTO         F[1]         —         S         S         S         141           FCCU         F[1]         ALTO         F[1]         —         S         S         S         38           FIGNORAL         ALTO         GPIO[98]         ALTO         RATI         M         S         102           FIGNORAL         ALTI         ALTI         PADSEIL=1         M         S         102           BSPI_1         CS1         ALTI         M         S         M         S         102			eTimer_1	ETC[4]	ALT1	ETC[4]	PSMI[13]; PADSEL=3							
SIUL         GPIO[94]         ALT0         GPIO[94]         —         M         S         115           LINFlexD_1         TXD         ALT1         —         —         M         S         113           SIUL         GPIO[95]         ALT0         GPIO[95]         —         M         S         113           FCCU         F[0]         ALT0         F[0]         —         S         S         S         38           FCCU         F[1]         ALT0         F[1]         —         S         S         S         141           FCCU         F[1]         ALT0         F[1]         —         S         S         S         141           FICH         GPIO[98]         ALT1         X[2]         PSMI[29]         —         M         S         102           FIEXPWM_O         X[2]         ALT1         X[2]         PSMI[29]         —         M         S         102	_		SIUL	I		EIRQ[31]	1							
LINFlexD_1         TXD         ALT1         —         —         —         M         S         113           SIUL         GPIO[95]         ALT0         GPIO[95]         —         M         S         113           LINFlexD_1         —         —         RXD         PSMI[32]; PADSEL=2         —         M         S         113           FCCU         F[0]         ALT0         F[1]         —         S         S         S         S         141           FCCU         F[1]         ALT0         F[1]         —         S         S         S         141           SIUL         GPIO[98]         ALT0         GPIO[98]         —         M         S         102           FlexPWM_0         X[2]         ALT1         X[2]         PSMI[29]; PSMI[29]; PSMI[29]; PSMI[29]; PSMI[29]; PSMI[29]; PSMI[20]         M         S         S         102		PCR[94]	SIUL	GPI0[94]	ALT0	GPI0[94]	I	I	Σ	တ			C13	
SIUL   GPIO[95]   ALTO   GPIO[95]   — — M   S   113			LINFlexD_1	TXD	ALT1	I	I							
LINFlexD_1		PCR[95]	SIUL	GP10[95]	ALT0	GP10[95]	1	I	Σ	S			D13	
FCCU         FCCU         FCCU         FCCU         F[1]         —         S         S         S         ALTO         FIGURED SIDE         —         —         M         S         ALTO         FIGURED SIDE         —         M         S         ALTO         FIGURED SIDE         —         M         S         ALTO         ALTO <th c<="" td=""><td></td><td></td><td>LINFlexD_1</td><td></td><td>I</td><td>RXD</td><td>PSMI[32]; PADSEL=2</td><td></td><td></td><td></td><td></td><td></td><td></td></th>	<td></td> <td></td> <td>LINFlexD_1</td> <td></td> <td>I</td> <td>RXD</td> <td>PSMI[32]; PADSEL=2</td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td>			LINFlexD_1		I	RXD	PSMI[32]; PADSEL=2						
FCCU         F[0]         ALTO         F[0]         —         S         S         S         38           FCCU         F[1]         ALTO         F[1]         —         S         S         141           SIUL         GPIO[98]         ALTO         GPIO[98]         —         M         S         102           FIexPWM_O         X[2]         ALT1         X[2]         PSMI[29]; PSMI[29]; PADSEL=1         M         S         102           DSPI_1         CS1         ALT2         —         —         M         S         102						FCCU								
FCCU         F[1]         ALTO         F[1]         —         S         S         141           SIUL         GPIO[98]         ALT1         K[2]         PSMI[29]; PSMI[29]; PADSEL=1         M         S         102           FIexPWM_0         X[2]         ALT1         X[2]         PSMI[29]; PADSEL=1         M         S         102           DSPI_1         CS1         ALT2         —         —         —         F         F		I	FCCU	[0]4	ALTO	F[0]	I	I	S	S		88	R2	
SIUL         GPIO[98]         ALT0         GPIO[98]         —         M         S         102           FIexPWM_0         X[2]         ALT1         X[2]         PSMI[29]; PADSEL=1         PADSEL=1         ALT2         —	<u></u>	1	FCCU	F[1]	ALTO	F[1]	I		S	S		141	C4	
SIUL         GPIO[98]         ALT0         GPIO[98]         —         M         S         102           FIexPWM_0         X[2]         ALT1         X[2]         PSMI[29]; PADSEL=1         ADSEL=1         A						Port G								
0 X[2] ALT1 X[2] CS1 ALT2 —		PCR[98]	SIUL	[86]OI49	ALT0	[86]OI49	1	I	Σ	S		-	E16	
CS1			FlexPWM_0	[z]x	ALT1	[Z]X	PSMI[29]; PADSEL=1							
			DSPI_1	CS1	ALT2	I	1							

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Table 7. Pin muxing (continued)

#### N17 P16 D17 257 pkg F17 G17 P17 100 144 pkg 104 85 86 83 8 SRC Pad speed<sup>1</sup> 0 ഗ ഗ ഗ ഗ ഗ ഗ SRC ī ≥ ≥ Σ ≥ ≥ ≥ Weak pull configduring reset Input mux select PSMI[7]; PADSEL=3 PSMI[26]; PADSEL=2 PSMI[8]; PADSEL=3 PSMI[23]; PADSEL=3 PSMI[27]; PADSEL=3 PSMI[16]; PADSEL=2 PSMI[22]; PADSEL=2 PSMI[30]; PADSEL=2 Input functions GP10[100] GPIO[104] FAULT[0] GPIO[99] GPI0[101] GPI0[102] GP10[103] **EIRQ[21]** ETC[4] **ETC[5]** A[2] B[3] B[2] X[3] A[3] Output mux sel ALT0 ALT0 **ALT0** ALT0 ALT0 ALT2 ALT2 ALT1 ALT1 ALT1 ALT1 ALT1 ALT1 Alternate output function GP10[99] GP10[100] GP10[101] GP10[103] GP10[104] GP10[102] DBG0 CS3 B[3] A[2] B[2] X[3] A[3] CS1 FlexPWM\_0 FlexPWM\_0 FlexPWM\_0 FlexPWM\_0 FlexPWM\_0 FlexPWM\_0 Peripheral DSPI\_2 eTimer\_0 eTimer\_0 DSPI\_0 FlexRay SIUL SIUL SINL SIUL SIUL SIUL SIUL PCR[100] PCR[101] PCR[102] PCR[103] PCR[104] PCR[99] PCR Port name G[3] <u>G[4]</u> G[5] G[6] <u>G[7]</u> <u>G[8]</u>

Table 7. Pin muxing (continued)

	257 pkg	R17					P15				U15			F2		Ŧ		A6		72			A5	
Pin #	144 pkg	62					77				75			I		I		ļ						
Pad speed <sup>1</sup>	SRC = 0	S					တ				S			S		တ		ഗ		တ			S	
	SRC = 1	Σ					Σ				Σ			ட		ш		ட		ь			ь	
Weak pull	config during reset	I					Ι				I			Ι		I		Ι		1			I	
Viim tiidal	select	1	Ι	I	PSMI[17]; PADSEL=2	I	I	I	I	PSMI[18]; PADSEL=1	I	I	PSMI[19]; PADSEL=2	I	I	1	I	1	I		I			_
1100	functions	GPI0[105]	I	I	FAULT[1]	EIRQ[29]	GPI0[106]	I	I	FAULT[2]	GPI0[107]	I	FAULT[3]	GPI0[108]	I	GPIO[109]	I	GPI0[110]	I	GPI0[111]	I	Port H	GPI0[112]	_
4110	mux sel	ALT0	ALT1	ALT2	I	I	ALT0	ALT1	ALT2	I	ALT0	ALT1	I	ALT0	ALT2	ALT0	ALT2	ALT0	ALT2	ALT0	ALT2		ALT0	ALT2
Alternate	output function	GP10[105]	DBG1	CS1	I	I	GP10[106]	DBG2	CS3	I	GP10[107]	DBG3	I	GP10[108]	MDO[11]	GP10[109]	MDO[10]	GPI0[110]	[6]OQW	GPI0[111]	MDO[8]		GPI0[112]	MDO[7]
	Peripheral	SIUL	FlexRay	DSPI_1	FlexPWM_0	SIUL	SIUL	FlexRay	DSPI_2	FlexPWM_0	SIUL	FlexRay	FlexPWM_0	SIUL	NPC	SIUL	NPC	SIUL	NPC	SIUL	NPC		SIUL	NPC
	PCR	PCR[105]		I	I	I	PCR[106]	I	I	I	PCR[107]	I	I	PCR[108]		PCR[109]	I	PCR[110]	I	PCR[111]	I		PCR[112]	
ţ	name	[6]9]					G[10]				G[11]			G[12]		G[13]		G[14]		G[15]			H[0]	

Table 7. Pin muxing (continued)

34.	257 pkg	F1		<b>A</b> 4		G1		L16			M17			H17			K16			K15			G16		
Pin #	144 pkg													1						1			1		
d <sup>1</sup>	ပ္မ																								
Pad speed <sup>1</sup>	SRC SRC = 1 = 0	S		S		R S		S			S			S W			S ∑			S			S		_
-											-														_
Weak pull	config during reset	1		1		1		I			I			I			I			I			I		
yii a tii aa	select	1	I	I		I	I	1	I	PSMI[39]; PADSEL=0	I	I	I	l	1	1	I	1	PSMI[40]; PADSEL=0	1	I	I	1		
	functions	GPI0[113]	1	GPI0[114]	1	GPI0[115]	I	GPIO[116]	[o]x	ETC[0]	GPI0[117]	[0]W	I	GPI0[118]	B[0]	1	GPIO[119]	X[1]	ETC[1]	GPI0[120]	A[1]	I	GPI0[121]	B[1]	
c tiretine	mux sel	ALT0	ALT2	ALT0	ALT2	ALT0	ALT2	ALT0	ALT1	ALT2	ALT0	ALT1	ALT3	ALT0	ALT1	ALT3	ALT0	ALT1	ALT2	ALT0	ALT1	ALT3	ALT0	ALT1	
Alternate	output function	GPI0[113]	MDO[6]	GPI0[114]	MDO[5]	GPIO[115]	MDO[4]	GPI0[116]	[0]X	ETC[0]	GPI0[117]	A[0]	CS4	GPI0[118]	B[0]	CS5	GPIO[119]	X[1]	ETC[1]	GPIO[120]	A[1]	9SO	GPI0[121]	B[1]	
	Peripheral	SIUL	NPC	SIUL	NPC	SIUL	NPC	SIUL	FlexPWM_1	eTimer_2	SIUL	FlexPWM_1	DSPI_0	SIUL	FlexPWM_1	DSPI_0	SIUL	FlexPWM_1	eTimer_2	SIUL	FlexPWM_1	DSPI_0	SIUL	FlexPWM_1	
	PCR	PCR[113]		PCR[114]	•	PCR[115]		PCR[116]			PCR[117]	1	•	PCR[118]			PCR[119]			PCR[120]	1		PCR[121]		1
trod.	name	H[1]		H[2]		H[3]		H[4]			H[5]			[9]H			H[7]			H[8]			[6]H		

Table 7. Pin muxing (continued)

		257 pkg	A11			C11		B10		G15			A12			117				60			_
Pin #		144 pkg	1					1		1			1			1			-				_
	•																						_
eed1	5	SRC = 0	S			S		S		S			S			S				S			
Pad speed <sup>1</sup>	2000	SRC = 1	Σ			Σ		Σ		Σ			Σ			Σ				Σ			
		config during reset	I			ı		I		I			I			I			-	I			
	Input mux	select	I	I	I	I	I	I	1	I	I	PSMI[42]; PADSEL=0	I	I	I	I	I	I		I	PSMI[39]; PADSEL=1	I	
	Input	functions	GPI0[122]	X[2]	ETC[2]	GPI0[123]	A[2]	GPIO[124]	B[2]	GPIO[125]	X[3]	ETC[3]	GPIO[126]	A[3]	ETC[4]	GPI0[127]	B[3]	ETC[5]	Port I	GPIO[128]	ETC[0]	I	
	Output	mux sel	ALT0	ALT1	ALT2	ALT0	ALT1	ALT0	ALT1	ALT0	ALT1	ALT2	ALT0	ALT1	ALT2	ALT0	ALT1	ALT2		ALT0	ALT1	ALT2	
	Alternate	output function	GPI0[122]	X[2]	ETC[2]	GPI0[123]	A[2]	GPIO[124]	B[2]	GPI0[125]	X[3]	ETC[3]	GPIO[126]	A[3]	ETC[4]	GPI0[127]	B[3]	ETC[5]		GPI0[128]	ETC[0]	CS4	
		Peripheral	SIUL	FlexPWM_1	eTimer_2	SIUL	FlexPWM_1	SIUL	FlexPWM_1	SIUL	FlexPWM_1	eTimer_2	SIUL	FlexPWM_1	eTimer_2	SIUL	FlexPWM_1	eTimer_2		SIUL	eTimer_2	DSPI_0	
	!	PCR	PCR[122]	l	l	PCR[123]	l	PCR[124]	I	PCR[125]	l	ı	PCR[126]	l	l	PCR[127]	l	I		PCR[128]	I	I	
	Port	name	H[10]			H[11]		H[12]		H[13]			H[14]			H[15]				[0]			

# Table 7. Pin muxing (continued)

	257 pkg	C12				F16				E17					83	
Pin #	144 pkg									1						
_																
eed1	SRC = 0	S				တ				တ					တ	
Pad speed <sup>1</sup>	SRC = 1	Σ	Σ							Σ					ш	
	config during reset	I				I				I					I	
Indit milk	select	I	PSMI[40]; PADSEL=1	I	I	I	PSMI[41]; PADSEL=1	I	I	I	PSMI[42]; PADSEL=1	I	I	I	I	
†iidal	functions	GPI0[129]	ETC[1]	I	FAULT[1]	GPIO[130]	ETC[2]	I	FAULT[2]	GPI0[131]	ETC[3]	I	I	FAULT[3]	GPI0[132]	1
Output	mux sel	ALT0	ALT1	ALT2	I	ALT0	ALT1	ALT2	1	ALT0	ALT1	ALT2	ALT3	1	ALT0	ALT2
Alternate	output function	GPIO[129]	ETC[1]	CS5	I	GPIO[130]	ETC[2]	9SO	I	GPI0[131]	ETC[3]	CS7	EXT_TGR	I	GPI0[132]	RDY
	Peripheral	SIUL	eTimer_2	DSPI_0	FlexPWM_1	SIUL	eTimer_2	DSPI_0	FlexPWM_1	SIUL	eTimer_2	DSPI_0	CTU_0	FlexPWM_1	SIUL	NPC
	PCR	PCR[129]	•	•	•	PCR[130]	•		•	PCR[131]			•		PCR[132]	
Port	name	[1]				[2]				[2]					RDY	

Programmable via the SRC (Slew Rate Control) bit in the respective Pad Configuration Register; S = Slow, M = Medium, F = Fast, SYM = Symmetric (for FlexRay)

The default function of this pin out of reset is ALT1 (TDO)

<sup>3</sup> Analog

Open Drain can be configured by the PCRn for all pins used as output (except FCCU\_F[0] and FCCU\_F[1] ).

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## 3.1 Introduction

This section contains detailed information on power considerations, DC/AC electrical characteristics, and AC timing specifications for this device.

This device is designed to operate at 120 MHz. The electrical specifications are preliminary and are from previous designs, design simulations, or initial evaluation. These specifications may not be fully tested or guaranteed at this early stage of the product life cycle. Finalized specifications will be published after complete characterization and device qualifications have been completed.

The "Symbol" column of the electrical parameter and timings tables contains an additional column containing "SR", "CC", "P", "C", "T", or "D".

- "SR" identifies system requirements—conditions that must be provided to ensure normal device operation. An example is the input voltage of a voltage regulator.
- "CC" identifies controller characteristics—indicating the characteristics and timing of the signals that the chip provides.
- "P", "C", "T", or "D" apply only to controller characteristics—specifications that define normal device operation. They specify how each characteristic is guaranteed.
  - P: parameter is guaranteed by production testing of each individual device.
  - C: parameter is guaranteed by design characterization. Measurements are taken from a statistically relevant sample size across process variations.
  - T: parameter is guaranteed by design characterization on a small sample size from typical devices under typical conditions unless otherwise noted. All values are shown in the typical ("typ") column are within this category.
  - D: parameters are derived mainly from simulations.

# 3.2 Absolute maximum ratings

Table 8. Absolute maximum ratings<sup>1</sup>

Symbol		Parameter	Conditions	Min	Max	Unit
V <sub>DD_HV_REG</sub>	SR	3.3 V voltage regulator supply voltage	_	-0.3	3.63 <sup>2, 3</sup>	V
$V_{DD\_HV\_IOx}$	SR	3.3 V input/output supply voltage	_	-0.3	3.63 <sup>2, 3</sup>	V
V <sub>SS_HV_IOx</sub>	SR	Input/output ground voltage	<del>-</del>	-0.1	0.1	V
V <sub>DD_HV_FLA</sub>	SR	3.3 V flash supply voltage	_	-0.3	3.63 <sup>2, 3</sup>	V
V <sub>SS_HV_FLA</sub>	SR	Flash memory ground	_	-0.1	0.1	V
V <sub>DD_HV_OSC</sub>	SR	3.3 V crystal oscillator amplifier supply voltage		-0.3	3.63 <sup>2, 3</sup>	٧
V <sub>SS_HV_OSC</sub>	SR	3.3 V crystal oscillator amplifier reference voltage	_	-0.1	0.1	٧
V <sub>DD_HV_ADR0</sub> <sup>3,4</sup> V <sub>DD_HV_ADR1</sub>	SR	3.3 V / 5.0 V ADC_0 high reference voltage 3.3 V / 5.0 V ADC_1 high reference voltage	_	-0.3	6.0	٧
V <sub>SS_HV_ADR0</sub> V <sub>SS_HV_ADR1</sub>	SR	ADC_0 ground and low reference voltage ADC_1 ground and low reference voltage	_	-0.1	0.1	V
V <sub>DD_HV_ADV</sub>	SR	3.3 V ADC supply voltage	_	-0.3	3.63 <sup>2, 3</sup>	V
V <sub>SS_HV_ADV</sub>	SR	3.3 V ADC supply ground	_	-0.1	0.1	V

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Table 8. Absolute maximum ratings<sup>1</sup> (continued)

Symbol		Parameter	Conditions	Min	Max	Unit
TV <sub>DD</sub>	SR	Supply ramp rate	_	3.0 × 10-6 (3.0 V/sec)	0.5 V/μs	V/µs
V <sub>IN</sub>	SR	Voltage on any pin with respect to ground	_	-0.3	6.0 <sup>5</sup>	V
		(Vss_hv_lo <i>x</i> )	Relative to V <sub>DD</sub>	-0.3	$V_{DD} + 0.3^{5,6}$	
I <sub>INJPAD</sub>	SR	Injected input current on any pin during overload condition	_	-10	10	mA
I <sub>INJSUM</sub>	SR	Absolute sum of all injected input currents during overload condition	_	-50	50	mA
T <sub>STG</sub>	SR	Storage temperature	_	-55	150	°C

<sup>&</sup>lt;sup>1</sup> Functional operating conditions are given in the DC electrical characteristics. Absolute maximum ratings are stress ratings only, and functional operation at the maxima is not guaranteed. Stress beyond the listed maxima may affect device reliability or cause permanent damage to the device.

# 3.3 Recommended operating conditions

Table 9. Recommended operating conditions (3.3 V)

Symbol		Parameter	Conditions	Min <sup>1</sup>	Max	Unit
$V_{DD\_HV\_REG}$	SR	3.3 V voltage regulator supply voltage	_	3.0	3.63	V
V <sub>DD_HV_IOx</sub>	SR	3.3 V input/output supply voltage	_	3.0	3.63	V
V <sub>SS_HV_IOx</sub>	SR	Input/output ground voltage	_	0	0	V
V <sub>DD_HV_FLA</sub>	SR	3.3 V flash supply voltage	_	3.0	3.63	V
V <sub>SS_HV_FLA</sub>	SR	Flash memory ground	_	0	0	V
V <sub>DD_HV_OSC</sub>	SR	3.3 V crystal oscillator amplifier supply voltage	_	3.0	3.63	V
V <sub>SS_HV_OSC</sub>	SR	3.3 V crystal oscillator amplifier reference voltage	_	0	0	V
V <sub>DD_HV_ADR0</sub> <sup>2,3</sup> V <sub>DD_HV_ADR1</sub>	SR	3.3 V / 5.0 V ADC_0 high reference voltage 3.3 V / 5.0 V ADC_1 high reference voltage	_	4.5 to 5.5 or 3.0 to 3.63		V
$V_{DD\_HV\_ADV}$	SR	3.3 V ADC supply voltage	_	3.0	3.63	V
V <sub>SS_HV_AD0</sub> V <sub>SS_HV_AD1</sub>	SR	ADC_0 ground and low reference voltage ADC_1 ground and low reference voltage	_	0	0	V
V <sub>SS_HV_ADV</sub>	SR	3.3 V ADC supply ground	_	0	0	V
V <sub>DD_LV_REGCOR</sub> <sup>4</sup>	SR	Internal supply voltage	_	_	_	V
V <sub>SS_LV_REGCOR</sub> <sup>5</sup>	SR	Internal reference voltage	_	0	0	V
V <sub>DD_LV_CORx</sub> <sup>2</sup>	SR	Internal supply voltage	_	_	_	V

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 $<sup>^2</sup>$  5.3 V for 10 hours cumulative over lifetime of device, 3.3 V +10% for time remaining.

<sup>&</sup>lt;sup>3</sup> Voltage overshoots during a high-to-low or low-to-high transition must not exceed 10 seconds per instance.

<sup>&</sup>lt;sup>4</sup> 6.4 V for 10 hours cumulative time, 6.0 V for time remaining.

Internal structures hold the input voltage less than the maximum voltage on all pads powered by VDDE supplies, if the maximum injection current specification is met and VDDE is within the operating voltage specifications.

 $<sup>^{6}</sup>$  Only when  $V_{DD} < 5.2 \text{ V}$ .



Table 9. Recommended operating conditions (3.3 V) (continued)

Symbol		Parameter	Conditions	Min <sup>1</sup>	Max	Unit
V <sub>SS_LV_CORx</sub> <sup>3</sup>	SR	Internal reference voltage	_	0	0	٧
V <sub>DD_LV_PLL</sub> <sup>2</sup>	SR	Internal supply voltage	_	_	_	V
V <sub>SS_LV_PLL</sub> <sup>3</sup>	SR	Internal reference voltage	_	0	0	V
T <sub>A</sub>	SR	Ambient temperature under bias	f <sub>CPU</sub> ≤ 120 MHz	-40	125	°C
TJ	SR	Junction temperature under bias	_	-40	150	°C

Full functionality cannot be guaranteed when voltage drops below 3.0 V. In particular, ADC electrical characteristics and I/Os DC electrical specification may not be guaranteed.

## 3.4 Thermal characteristics

Table 10. Thermal characteristics for 100 LQFP package<sup>1</sup>

Syml	ool	Parameter	Conditions	Value	Unit
$R_{\theta JA}$	D	Thermal resistance, junction-to-ambient natural	Single layer board – 1s	46	°C/W
		convection <sup>2</sup>	Four layer board – 2s2p	34	
$R_{\theta JMA}$	D	Thermal resistance, junction-to-ambient forced	Single layer board – 1s	36	°C/W
		convection at 200 ft/min	Four layer board – 2s2p	28	
$R_{\theta JB}$	D	Thermal resistance junction-to-board <sup>3</sup>	_	19	°C/W
$R_{\theta JC}$	D	Thermal resistance junction-to-case <sup>4</sup>	_	8	°C/W
$\Psi_{JT}$	D	Junction-to-package-top natural convection <sup>5</sup>	_	2	°C/W

Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.

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V<sub>DD\_HV\_ADR0</sub> and V<sub>DD\_HV\_ADR1</sub> cannot be operated at different voltages, and need to be supplied by the same voltage source.

<sup>&</sup>lt;sup>3</sup> VDD\_HV\_ADRx must always be applied and should be stable before LBIST starts. If this supply is not above its absolute minimum level, LBIST operations can fail.

<sup>&</sup>lt;sup>4</sup> Can be connected to emitter of external NPN. Low voltage supplies are not under user control. They are produced by an on-chip voltage regulator.

<sup>&</sup>lt;sup>5</sup> For the device to function properly, the low voltage grounds (V<sub>SS\_LV\_xxx</sub>) must be shorted to high voltage grounds (V<sub>SS\_HV\_xxx</sub>) and the low voltage supply pins (V<sub>DD\_LV\_xxx</sub>) must be connected to the external ballast emitter, if one is used

Junction-to-Ambient thermal resistance determined per JEDEC JESD51-3 and JESD51-6. Thermal test board meets JEDEC specification for this package.

Junction-to-Board thermal resistance determined per JEDEC JESD51-8. Thermal test board meets JEDEC specification for the specified package.

Junction-to-Case at the top of the package determined using MIL-STD 883 Method 1012.1. The cold plate temperature is used for the case temperature. Reported value includes the thermal resistance of the interface layer.

<sup>&</sup>lt;sup>5</sup> Thermal characterization parameter indicating the temperature difference between the package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.



Table 11. Thermal characteristics for 144 LQFP package<sup>1</sup>

Symb	ool	Parameter	Conditions	Value	Unit
$R_{\theta JA}$	D	Thermal resistance, junction-to-ambient natural	Single layer board – 1s	44	°C/W
		convection <sup>2</sup>	Four layer board – 2s2p	36	
$R_{\theta JMA}$	D	Thermal resistance, junction-to-ambient forced	Single layer board – 1s	35	°C/W
		convection at 200 ft/min	Four layer board – 2s2p	30	
$R_{\theta JB}$	D	Thermal resistance junction-to-board <sup>3</sup>	_	24	°C/W
$R_{\theta JC}$	D	Thermal resistance junction-to-case <sup>4</sup>	_	8	°C/W
$\Psi_{JT}$	D	Junction-to-package-top natural convection <sup>5</sup>	_	2	°C/W

Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.

Table 12. Thermal characteristics for 257 MAPBGA package<sup>1</sup>

Symb	ool	Parameter	Conditions	Value	Unit
$R_{\theta JA}$	D	Thermal resistance junction-to-ambient natural	Single layer board – 1s	46	°C/W
		convection <sup>2</sup>	Four layer board – 2s2p	26	
$R_{\theta JMA}$	D	Thermal resistance, junction-to-ambient forced	Single layer board – 1s	37	°C/W
		convection at 200 ft/min	Four layer board – 2s2p	22	
$R_{\theta JB}$	D	Thermal resistance junction-to-board <sup>3</sup>	_	13	°C/W
$R_{\theta JC}$	D	Thermal resistance junction-to-case <sup>4</sup>	_	8	°C/W
$\Psi_{JT}$	D	Junction-to-package-top natural convection <sup>5</sup>	_	2	°C/W

Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.

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Junction-to-Ambient thermal resistance determined per JEDEC JESD51-3 and JESD51-6. Thermal test board meets JEDEC specification for this package.

Junction-to-Board thermal resistance determined per JEDEC JESD51-8. Thermal test board meets JEDEC specification for the specified package.

Junction-to-Case at the top of the package determined using MIL-STD 883 Method 1012.1. The cold plate temperature is used for the case temperature. Reported value includes the thermal resistance of the interface layer.

<sup>&</sup>lt;sup>5</sup> Thermal characterization parameter indicating the temperature difference between the package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

Junction-to-Ambient thermal resistance determined per JEDEC JESD51-3 and JESD51-6. Thermal test board meets JEDEC specification for this package.

Junction-to-Board thermal resistance determined per JEDEC JESD51-8. Thermal test board meets JEDEC specification for the specified package.

Junction-to-Case at the top of the package determined using MIL-STD 883 Method 1012.1. The cold plate temperature is used for the case temperature. Reported value includes the thermal resistance of the interface layer.

<sup>&</sup>lt;sup>5</sup> Thermal characterization parameter indicating the temperature difference between the package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.



# 3.4.1 General notes for specifications at maximum junction temperature

An estimation of the chip junction temperature, T<sub>I</sub>, can be obtained from Equation 1:

$$T_{J} = T_{A} + (R_{\theta JA} \times P_{D})$$
 Eqn. 1

where:

 $T_A$  = ambient temperature for the package ( $^{\circ}$ C)  $R_{\theta JA}$  = junction to ambient thermal resistance ( $^{\circ}$ C/W)  $P_D$  = power dissipation in the package (W)

The junction to ambient thermal resistance is an industry standard value that provides a quick and easy estimation of thermal performance. Unfortunately, there are two values in common usage: the value determined on a single layer board and the value obtained on a board with two planes. For packages such as the PBGA, these values can be different by a factor of two. Which value is closer to the application depends on the power dissipated by other components on the board. The value obtained on a single layer board is appropriate for the tightly packed printed circuit board. The value obtained on the board with the internal

When a heat sink is used, the thermal resistance is expressed in Equation 2 as the sum of a junction to case thermal resistance and a case to ambient thermal resistance:

planes is usually appropriate if the board has low power dissipation and the components are well separated.

$$R_{\theta IA} = R_{\theta IC} + R_{\theta CA}$$
 Eqn. 2

where:

 $\begin{array}{ll} R_{\theta JA} & = \text{junction to ambient thermal resistance (°C/W)} \\ R_{\theta JC} & = \text{junction to case thermal resistance (°C/W)} \\ R_{\theta CA} & = \text{case to ambient thermal resistance (°C/W)} \end{array}$ 

 $R_{\theta JC}$  is device related and cannot be influenced by the user. The user controls the thermal environment to change the case to ambient thermal resistance,  $R_{\theta CA}$ . For instance, the user can change the size of the heat sink, the air flow around the device, the interface material, the mounting arrangement on printed circuit board, or change the thermal dissipation on the printed circuit board surrounding the device.

To determine the junction temperature of the device in the application when heat sinks are not used, the Thermal Characterization Parameter ( $\Psi_{JT}$ ) can be used to determine the junction temperature with a measurement of the temperature at the top center of the package case using Equation 3:

$$T_{J} = T_{T} + (\Psi_{JT} \times P_{D})$$
 Eqn. 3

where:

 $T_T$  = thermocouple temperature on top of the package (°C)

 $\Psi_{JT}$  = thermal characterization parameter (°C/W)  $P_D$  = power dissipation in the package (W)

The thermal characterization parameter is measured per JESD51-2 specification using a 40 gauge type T thermocouple epoxied to the top center of the package case. The thermocouple should be positioned so that the thermocouple junction rests on the package. A small amount of epoxy is placed over the thermocouple junction and over about 1 mm of wire extending from the junction. The thermocouple wire is placed flat against the package case to avoid measurement errors caused by cooling effects of the thermocouple wire.

### 3.4.1.1 References

Semiconductor Equipment and Materials International 3081 Zanker Road

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San Jose, CA 95134 USA (408) 943-6900

MIL-SPEC and EIA/JESD (JEDEC) specifications are available from Global Engineering Documents at 800-854-7179 or 303-397-7956.

JEDEC specifications are available on the WEB at http://www.jedec.org.

- 1. C.E. Triplett and B. Joiner, "An Experimental Characterization of a 272 PBGA Within an Automotive Engine Controller Module," Proceedings of SemiTherm, San Diego, 1998, pp. 47–54.
- 2. G. Kromann, S. Shidore, and S. Addison, "Thermal Modeling of a PBGA for Air-Cooled Applications," Electronic Packaging and Production, pp. 53–58, March 1998.
- 3. B. Joiner and V. Adams, "Measurement and Simulation of Junction to Board Thermal Resistance and Its Application in Thermal Modeling," Proceedings of SemiTherm, San Diego, 1999, pp. 212–220.

# 3.5 Electromagnetic Interference (EMI) characteristics

The characteristics in Table 14 were measured using:

- Device configuration, tet conditions, and EM testing per standard IEC61967-2
- Supply voltage of 3.3 V DC
- Ambient temperature of 25 °C

The configuration information referenced in Table 14 is explained in Table 13.

**Table 13. EMI configuration summary** 

Configuration name	Description
Configuration A	<ul> <li>High emission = all pads have max slew rate, LVDS pads running at 40 MHz</li> <li>Oscillator frequency = 40 MHz</li> <li>System bus frequency = 80 MHz</li> <li>No PLL frequency modulation</li> <li>IEC level I (≤ 36 dBµV)</li> </ul>
Configuration B	<ul> <li>Reference emission = pads use min, mid and max slew rates, LVDS pads disabled</li> <li>Oscillator frequency = 40 MHz</li> <li>System bus frequency = 80 MHz</li> <li>2% PLL frequency modulation</li> <li>IEC level K(≤ 30 dB<sub>µ</sub>V)</li> </ul>

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Table 14. EMI emission testing specifications

Symb	ol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{EME}$	СС	Radiated emissions	Configuration A; frequency range 150 kHz–50 MHz	_	16	_	dBμV
			Configuration A; frequency range 50–150 MHz	_	16	_	
			Configuration A; frequency range 150–500 MHz	_	32	_	
			Configuration A; frequency range 500–1000 MHz	_	25	_	
			Configuration B; frequency range 50–150 MHz	_	15	_	
			Configuration B; frequency range 50–150 MHz	_	21	_	
			Configuration B; frequency range 150–500 MHz	_	30	_	
			Configuration B; frequency range 500–1000 MHz	_	24	_	

EMC testing was performed and documented according to these standards: [IEC61508-2-7.4.5.1.b, IEC61508-2-7.2.3.2.e, IEC61508-2-Table-A.17 (partially), IEC61508-2-Table-B.5(partially), SRS2110]

EME testing was performed and documented according to these standards: [IEC 61967-2 & -4]

EMS testing was performed and documented according to these standards: [IEC 62132-2 & -4]

Refer MPC5643L for detailed information pertaining to the EMC, EME, and EMS testing and results.

# 3.6 Electrostatic discharge (ESD) characteristics

Electrostatic discharges (a positive then a negative pulse separated by 1 second) are applied to the pins of each sample according to each pin combination. The sample size depends on the number of supply pins in the device (3 parts  $\times$  (n + 1) supply pin). This test conforms to the AEC-Q100-002/-003/-011 standard.

Table 15. ESD ratings<sup>1, 2</sup>

No.	Symbol		Parameter	Conditions	Class	Max value <sup>3</sup>	Unit
1	V <sub>ESD(HBM)</sub>	SR	Electrostatic discharge (Human Body Model)	T <sub>A</sub> = 25 °C conforming to AEC-Q100-002	H1C	2000	V
2	V <sub>ESD(MM)</sub>	SR	Electrostatic discharge (Machine Model)	T <sub>A</sub> = 25 °C conforming to AEC-Q100-003	M2	200	V
3	V <sub>ESD(CDM)</sub> SI			T <sub>A</sub> = 25 °C	СЗА	500	V
			(Charged Device Model)	conforming to AEC-Q100-011		750 (corners)	

All ESD testing is in conformity with CDF-AEC-Q100 Stress Test Qualification for Automotive Grade Integrated Circuits.

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A device will be defined as a failure if after exposure to ESD pulses the device no longer meets the device specification requirements. Complete DC parametric and functional testing shall be performed per applicable device specification at room temperature followed by hot temperature, unless specified otherwise in the device specification.



<sup>3</sup> Data based on characterization results, not tested in production.

# 3.7 Static latch-up (LU)

Two complementary static tests are required on six parts to assess the latch-up performance:

- A supply overvoltage is applied to each power supply pin.
- A current injection is applied to each input, output and configurable I/O pin.

These tests are compliant with the EIA/JESD 78 IC latch-up standard.

Table 16. Latch-up results

No.	Symbol		Parameter	Conditions	Class
1	LU SR		Static latch-up class	T <sub>A</sub> = 125 °C conforming to JESD 78	II level A

# 3.8 Voltage regulator electrical characteristics

The voltage regulator is composed of the following blocks:

- High power regulator HPREG1 (internal ballast to support core current)
- High power regulator HPREG2 (external NPN to support core current)
- Low voltage detector (LVD\_MAIN\_1) for 3.3 V supply to IO (V<sub>DDIO</sub>)
- Low voltage detector (LVD\_MAIN\_2) for 3.3 V supply (V<sub>DDREG</sub>)
- Low voltage detector (LVD\_MAIN\_3) for 3.3 V flash supply (V<sub>DDFLASH</sub>)
- Low voltage detector (LVD\_DIG\_MAIN) for 1.2 V digital core supply (HPV<sub>DD</sub>)
- Low voltage detector (LVD\_DIG\_BKUP) for the self-test of LVD\_DIG\_MAIN
- High voltage detector (HVD\_DIG\_MAIN) for 1.2 V digital CORE supply (HPV $_{
  m DD}$ )
- High voltage detector (HVD\_DIG\_BKUP) for the self-test of HVD\_DIG\_MAIN.
- Power on Reset (POR)

HPREG1 uses an internal ballast to support the core current. HPREG2 is used only when external NPN transistor is present on board to supply core current. The MPC5643L always powers up using HPREG1 if an external NPN transistor is present. Then the MPC5643L makes a transition from HPREG1 to HPREG2. This transition is dynamic. Once HPREG2 is fully operational, the controller part of HPREG1 is switched off.

The following bipolar transistors are supported:

- BCP68 from ON Semiconductor
- BCX68 from Infineon

Table 17. Recommended operating characteristics

Symbol	Parameter	Value	Unit
h <sub>FE</sub> (β)	DC current gain (Beta)	85 - 375	_
$P_{D}$	Maximum power dissipation @ T <sub>A</sub> =25°C <sup>1</sup>	1.5	W
I <sub>CMaxDC</sub>	Maximum peak collector current	1.0	Α
VCE <sub>SAT</sub>	Collector-to-emitter saturation voltage(Max)	600 <sup>2</sup>	mV
V <sub>BE</sub>	Base-to-emitter voltage (Max)	1.0	V

derating factor 12mW/degC

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<sup>2</sup> Adjust resistor at bipolar transistor collector for 3.3V to avoid VCE<VCE<sub>SAT</sub>

The recommended external ballast transistor is the bipolar transistor BCP68 with the gain range of 85 up to 375 (for IC=500mA, VCE=1V) provided by several suppliers. This includes the gain variations BCP68-10, BCP68-16 and BCP68-25. The most important parameters for the interoperability with the integrated voltage regulator are the DC current gain (hFE) and the temperature coefficient of the gain (XTB). While the specified gain range of most BCP68 vendors is the same, there are slight variations in the temperature coefficient parameter. MPC5643L Voltage regulator operation was simulated against the typical variation on temperature coefficient and against the specified gain range to have a robust design.

Table 18. Voltage regulator electrical specifications

Symb	ool	Parameter	Conditions	Min	Тур	Max	Unit
	C <sub>ext</sub>	External decoupling/ stability capacitor	Min, max values shall be granted with respect to tolerance, voltage, temperature, and aging variations.	12	_	40	μF
	SR	Combined ESR of external capacitor	_	1	_	100	mΩ
	SR	Number of pins for external decoupling/ stability capacitor	_	5	_	_	_
C <sub>V1V2</sub>	SR	Total capacitance on 1.2 V pins	Ceramic capacitors, taking into account tolerance, aging, voltage and temperature variation	300	_	900	nF
t <sub>SU</sub>		Start-up time after main supply stabilization	$C_{load} = 10 \mu F \times 4$	_	_	2.5	ms
		Main High Voltage Power - Low Voltage Detection, upper threshold	_	_	_	2.93	٧
_	D	Main supply low voltage detector, lower threshold	_	2.6	_	_	V
_	D	Digital supply high voltage detector upper threshold	Before a destructive reset initialization phase completion	1.355	_	1.495	V
			After a destructive reset initialization phase completion	1.39	_	1.47	
_	D	Digital supply high voltage detector lower threshold	Before a destructive reset initialization phase completion	1.315	_	1.455	V
			After a destructive reset initialization phase completion	1.35	_	1.38	

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# Table 18. Voltage regulator electrical specifications (continued)

Syml	ool	Parameter	Conditions	Min	Тур	Max	Unit
_	D	Digital supply low voltage detector lower threshold	After a destructive reset initialization phase completion	1.080	_	1.140	V
_	D	Digital supply low voltage detector upper threshold	After a destructive reset initialization phase completion	1.16	_	1.22	V
_	D	Digital supply low voltage detector lower threshold	Before a destructive reset initialization phase	1.080	_	1.226	V
_	D	Digital supply low voltage detector upper threshold	Before a destructive reset initialization phase	1.160	_	1.306	V
_	D	POR rising/ falling supply threshold voltage	_	1.6	_	2.6	V
_	SR	Supply ramp rate	_	3 V/s	_	0.5 V/µs	_
_	D	LVD_MAIN: Time constant of RC filter at LVD input	3.3V noise rejection at the input of LVD comparator	1.1	_	_	μs
_	D	HVD_DIG: Time constant of RC filter at LVD input	1.2V noise rejection at the input of LVD comparator	0.1	_	_	μs
_	D	LVD_DIG: Time constant of RC filter at LVD input	1.2V noise rejection at the input of LVD comparator	0.1	_	_	μs



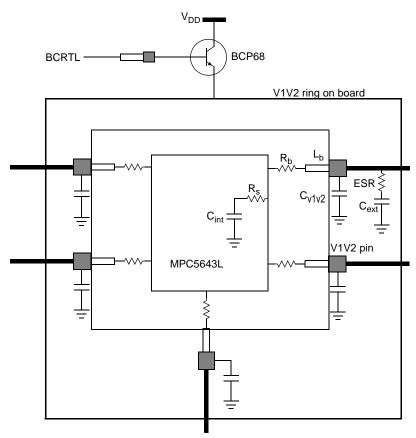


Figure 4. BCP68 board schematic example

## **NOTE**

The minimum value of the ESR is constrained by the resonance caused by the external components, bonding inductance, and internal decoupling. The minimum ESR is required to avoid the resonance and make the regulator stable.

# 3.9 DC electrical characteristics

Table 19 gives the DC electrical characteristics at 3.3 V (3.0 V < V<sub>DD\_HV\_IOx</sub> < 3.6 V).

Table 19. DC electrical characteristics<sup>1</sup>

Symbol		Parameter	Conditions	Min	Тур	Max	Unit
V <sub>IL</sub>	D	Minimum low level input voltage	_	-0.1 <sup>2</sup>	_	_	V
V <sub>IL</sub>	Р	Maximum level input voltage	_	_	_	0.35 V <sub>DD_HV_IOx</sub>	V
V <sub>IH</sub>	Р	Minimum high level input voltage	_	0.65 V <sub>DD_HV_IOx</sub>	_	_	V
V <sub>IH</sub>	D	Maximum high level input voltage	_	_	_	$V_{DD_{-HV_{-IOx}}} + 0.1^{2,3}$	V
V <sub>HYS</sub>	Т	Schmitt trigger hysteresis	_	0.1 V <sub>DD_HV_IOx</sub>	_	_	V
V <sub>OL_S</sub>	Р	Slow, low level output voltage	I <sub>OL</sub> = 1.5 mA	_	_	0.5	V
V <sub>OH_S</sub>	Р	Slow, high level output voltage	$I_{OH} = -1.5 \text{ mA}$	$V_{DD\_HV\_IOx} - 0.8$	_	_	V
V <sub>OL_M</sub>	Р	Medium, low level output voltage	I <sub>OL</sub> = 2 mA	_	_	0.5	V

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Table 19. DC electrical characteristics<sup>1</sup> (continued)

Symbol		Parameter	Conditions	Min	Тур	Max	Unit
V <sub>OH_M</sub>	Р	Medium, high level output voltage	$I_{OH} = -2 \text{ mA}$	$V_{DD\_HV\_IOx} - 0.8$	_	_	V
V <sub>OL_F</sub>	Р	Fast, high level output voltage	I <sub>OL</sub> = 11 mA	_	_	0.5	V
V <sub>OH_F</sub>	Р	Fast, high level output voltage	I <sub>OH</sub> = -11 mA	V <sub>DD_HV_IOx</sub> - 0.8	_	_	V
V <sub>OL_SYM</sub>	Р	Symmetric, high level output voltage	I <sub>OL</sub> = 1.5 mA	_	_	0.5	V
V <sub>OH_SYM</sub>	Р	Symmetric, high level output voltage	$I_{OH} = -1.5 \text{ mA}$	$V_{DD\_HV\_IOx} - 0.8$	_	_	V
I <sub>INJ</sub>	Т	DC injection current per pin (all bi-directional ports)	_	<b>–1</b>	_	1	mA
I <sub>PU</sub>	Р	Equivalent pull-up current	$V_{IN} = V_{IL}$	-130	_	_	μA
			$V_{IN} = V_{IH}$	_	_	-10	
I <sub>PD</sub>	Р	Equivalent pull-down current	$V_{IN} = V_{IL}$	10	_	_	μA
			$V_{IN} = V_{IH}$	_	_	130	
I <sub>IL</sub>	Р	Input leakage current (all bidirectional ports)	$T_{J} = -40 \text{ to}$ +150 °C	-1	_	1	μА
		Input leakage current (all ADC input-only ports) <sup>4</sup>		-0.25	_	0.25	
		Input leakage current (shared ADC input-only ports)		-0.3	_	0.3	
V <sub>ILR</sub>	Р	RESET, low level input voltage	_	-0.1 <sup>2</sup>	_	0.35 V <sub>DD_HV_IOx</sub>	V
V <sub>IHR</sub>	Р	RESET, high level input voltage	_	0.65 V <sub>DD_HV_IOx</sub>	_	V <sub>DD_HV_IOx</sub> +0.1 <sup>2</sup>	V
V <sub>HYSR</sub>	D	RESET, Schmitt trigger hysteresis	_	0.1 V <sub>DD_HV_IOx</sub>	_	_	V
V <sub>OLR</sub>	D	RESET, low level output voltage	I <sub>OL</sub> = 2 mA	_	_	0.5	V
I <sub>PD</sub>	D	RESET, equivalent pull-down	$V_{IN} = V_{IL}$	10	_	_	μA
		current	$V_{IN} = V_{IH}$	_	_	130	

These specifications are design targets and subject to change per device characterization.

# 3.10 Supply current characteristics

Current consumption data is given in Table 20. These specifications are design targets and are subject to change per device characterization.

 $<sup>^{2}\,</sup>$  "SR" parameter values must not exceed the absolute maximum ratings shown in Table 8.

 $<sup>^{3}</sup>$  The max input voltage on the ADC pins is the ADC reference voltage VDD\_HV\_ADRx.

<sup>&</sup>lt;sup>4</sup> Measured values are applicable to all modes of the pad i.e. IBE = 0/1 and / or APC= 0/1.



## **Table 20. Current consumption characteristics**

Symbol		Parameter	Conditions <sup>1</sup>	Min	Тур	Max	Unit
I <sub>DD_LV_FULL</sub> + I <sub>DD_LV_PLL</sub>	Т	Operating current	1.2 V supplies $T_{J} = 25 \text{ °C}$ $V_{DD\_LV\_COR} = 1.32 \text{ V}$	_	_	50 mA+ 2.18 mA*f <sub>CPU</sub> [MHz]	mA
			1.2 V supplies T <sub>J</sub> = 150 °C V <sub>DD_LV_COR</sub> = 1.32 V	_	_	80 mA+ 2.50 mA*f <sub>CPU</sub> [MHz]	
I <sub>DD_LV_TYP</sub> + I <sub>DD_LV_PLL</sub> <sup>2</sup>	Т	Operating current	1.2 V supplies T <sub>J</sub> = 25 °C V <sub>DD_LV_COR</sub> = 1.32 V	_	_	26 + 2.10 mA*f <sub>CPU</sub> [MHz]	mA
			1.2 V supplies T <sub>J</sub> = 150 °C V <sub>DD_LV_COR</sub> = 1.32 V	_	_	41 mA+ 2.30 mA*f <sub>CPU</sub> [MHz]	
I <sub>DD_LV_BIST</sub> + I <sub>DD_LV_PLL</sub>	Т	Operating current	1.2 V supplies during LBIST (full LBIST configuration) T <sub>J</sub> = 25 °C V <sub>DD_LV_COR</sub> = 1.32 V	_	_	250	mA
			1.2 V supplies during LBIST (full LBIST configuration) T <sub>J</sub> = 150 °C V <sub>DD_LV_COR</sub> = 1.32 V	_	_	290	
I <sub>DD_LV_TYP</sub> + I <sub>DD_LV_PLL</sub> 2	Р	Operating current	1.2 V supplies $T_{J} = 25  ^{\circ}\text{C}$ $V_{DD\_LV\_COR} = 1.32  \text{V}$ LSM mode	_	_	279	mA
			$T_J$ = 150 °C $V_{DD\_LV\_COR}$ = 1.32 V LSM mode	_	_	318	mA
I <sub>DD_LV_TYP</sub> + I <sub>DD_LV_PLL</sub> <sup>2</sup>	Т	Operating current	1.2V supplies Tj=105°C V <sub>DD_LV_COR</sub> = 1.2V LSM mode	_	_	275	mA
			1.2V supplies Tj=125°C V <sub>DD_LV_COR</sub> = 1.2V LSM mode	_	_	299	mA



# Table 20. Current consumption characteristics (continued)

Symbol		Parameter	Conditions <sup>1</sup>	Min	Тур	Max	Unit
I <sub>DD_LV_TYP</sub> + I <sub>DD_LV_PLL</sub> <sup>2</sup>	Т	Operating current	1.2V supplies Tj=105°C V <sub>DD_LV_COR</sub> = 1.2V DPM Mode	_	_	189	mA
			1.2V supplies Tj=125°C V <sub>DD_LV_COR</sub> = 1.2V DPM Mode	_	_	214	mA
			1.2V supplies Tj=150°C V <sub>DD_LV_COR</sub> = 1.2V DPM Mode	_	_	235	mA
I <sub>DD_LV_STOP</sub>	Т	Operating current in V <sub>DD</sub> STOP mode	T <sub>J</sub> = 25 °C V <sub>DD_LV_COR</sub> = 1.32 V	_	_	20	mA
	Т		T <sub>J</sub> = 55 °C V <sub>DD_LV_COR</sub> = 1.32 V	_	_	57	
	Р		T <sub>J</sub> = 150 °C V <sub>DD_LV_COR</sub> = 1.32 V	_	_	105	
I <sub>DD_LV_HALT</sub>	Т	Operating current in V <sub>DD</sub> HALT mode	T <sub>J</sub> = 25 °C V <sub>DD_LV_COR</sub> = 1.32 V	_	_	25	mA
	Т		T <sub>J</sub> = 55 °C V <sub>DD_LV_COR</sub> = 1.32 V	_	_	64	
	Р		T <sub>J</sub> = 150 °C V <sub>DD_LV_COR</sub> = 1.32 V	_	_	115	
I <sub>DD_HV_ADC</sub> <sup>3,4</sup>	Т	Operating current	$T_J$ = 150 °C 120 MHz ADC operating at 60 MHz $V_{DD\_HV\_ADC}$ = 3.6 V	_		10	mA
I <sub>DD_HV_AREF</sub> <sup>4</sup>	Т	Operating current	$T_J$ = 150 °C 120 MHz ADC operating at 60 MHz $V_{DD\_HV\_REF}$ = 3.6 V	_	_	3	mA
			$T_J$ = 150 °C 120 MHz ADC operating at 60 MHz $V_{DD\_HV\_REF}$ = 5.5 V	_	_	5	



Table 20. Current consumption characteristics (continued)

Symbol		Parameter	Conditions <sup>1</sup>	Min	Тур	Max	Unit
I <sub>DD_HV_OSC</sub> (oscillator bypass mode)	Т	Operating current	T <sub>J</sub> = 150 °C 3.3 V supplies 120 MHz	_	_	900	μА
I <sub>DD_HV_OSC</sub> (crystal oscillator mode)	D	Operating current	T <sub>J</sub> = 150 °C 3.3 V supplies 120 MHz	_	_	3.5	mA
I <sub>DD_HV_FLASH</sub> 5	Т	Operating current	T <sub>J</sub> = 150 °C 3.3 V supplies 120 MHz	_	_	4	mA
I <sub>DD_HV_PMU</sub>	Т	Operating current	T <sub>J</sub> = 150 °C 3.3 V supplies 120 MHz	_	_	10	mA

Devices configured for DPM mode, single core only with Core 0 executing typical code at 120 MHz from SRAM and Core 1 in reset. If core execution mode not specified, the device is configured for LSM mode with both cores executing typical code at 120 MHz from SRAM.

# 3.11 Temperature sensor electrical characteristics

Table 21. Temperature sensor electrical characteristics

S	Symbol	Parameter	Conditions	Min	Max	Unit
_	Р	Accuracy	$T_J = -40 ^{\circ}\text{C} \text{ to } 150 ^{\circ}\text{C}$	-10	10	°C
T <sub>S</sub>	D	Minimum sampling period	_	4	_	μs

# 3.12 Main oscillator electrical characteristics

The device provides an oscillator/resonator driver. Figure 5 describes a simple model of the internal oscillator driver and provides an example of a connection for an oscillator or a resonator.

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Enabled Modules in 'Typical mode': FlexPWM0, ETimer0/1/2, CTU, SWG, DMA, FlexCAN0/1, LINFlex, ADC1, DSPI0/1, PIT, CRC, PLL0/1, I/O supply current excluded. If DPM mode is configured, Core\_0 is active while Core\_1 is in reset during the measurements.

Internal structures hold the input voltage less than VDDA + 1.0 V on all pads powered by VDDA supplies, if the maximum injection current specification is met and VDDA is within the operating voltage specifications.

<sup>&</sup>lt;sup>4</sup> This value is the total current for both ADCs.

<sup>&</sup>lt;sup>5</sup> VFLASH is only available in the calibration package.



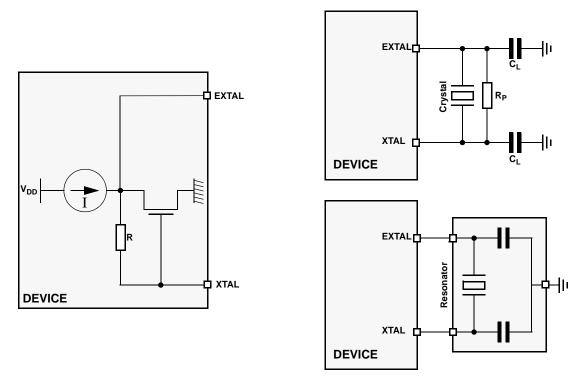


Figure 5. Crystal oscillator and resonator connection scheme

## **NOTE**

XTAL/EXTAL must not be directly used to drive external circuits.

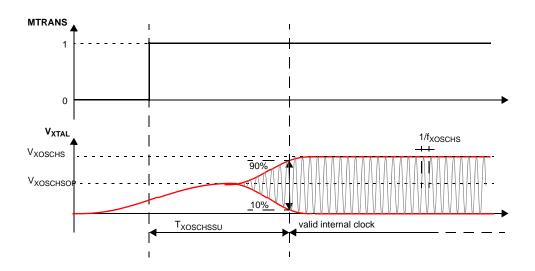


Figure 6. Main oscillator electrical characteristics

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Table 22. Main oscillator electrical characteristics

Symbol		Parameter	Conditions <sup>1</sup>		Value		Unit
Cymbol		T drameter	Conditions	Min	Тур	Max	
f <sub>XOSCHS</sub>	SR	Oscillator frequency	_	4.0	_	40.0	MHz
9 <sub>m</sub> XOSCHS	Р	Oscillator transconductance	V <sub>DD</sub> = 3.3 V ±10%	4.5	_	13.25	mA/V
V <sub>XOSCHS</sub>	D	Oscillation amplitude	f <sub>OSC</sub> = 4, 8, 10, 12, 16 MHz	1.3	_	_	V
			f <sub>OSC</sub> = 40 MHz	1.1	_	_	
V <sub>XOSCHSOP</sub>	D	Oscillation operating point	_	_	0.82	_	V
T <sub>XOSCHSSU</sub>	Т	Oscillator start-up time	$f_{OSC} = 4, 8, 10, 12 \text{ MHz}^2$	_	_	6	ms
			f <sub>OSC</sub> = 16, 40 MHz <sup>2</sup>	_	_	2	
V <sub>IH</sub>	V <sub>IH</sub> SR Input high level CMOS Oscillator bypass mode Schmitt Trigger		Oscillator bypass mode	0.65 × V <sub>DD</sub>	_	V <sub>DD</sub> + 0.4	V
V <sub>IL</sub>			Oscillator bypass mode	-0.4		0.35 × V <sub>DD</sub>	V

 $<sup>^{1}</sup>$  V<sub>DD</sub> = 3.3 V ±10%, T<sub>J</sub> = -40 to +150 °C, unless otherwise specified.

# 3.13 FMPLL electrical characteristics

Table 23. FMPLL electrical characteristics

Symbo	ı	Parameter	Conditions	Min	Тур	Max	Unit
f <sub>REF_CRYSTAL</sub> f <sub>REF_EXT</sub>	D	FMPLL reference frequency range <sup>1</sup>	Crystal reference	4	_	40	MHz
f <sub>PLL_IN</sub>	D	Phase detector input frequency range (after pre-divider)	_	4	_	16	MHz
f <sub>FMPLLOUT</sub>	D	Clock frequency range in normal mode	_	4	_	120 <sup>2</sup>	MHz
f <sub>FREE</sub>	f <sub>FREE</sub> P Free running frequency		Measured using clock division (typically ÷16)	20	_	150	MHz
f <sub>sys</sub>	D	On-chip FMPLL frequency <sup>2</sup>	_	16	_	120	MHz
t <sub>CYC</sub>	D	System clock period	_	_	_	1 / f <sub>sys</sub>	ns
f <sub>LORL</sub>	D	Loss of reference frequency	Lower limit	1.6	_	3.7	MHz
f <sub>LORH</sub>		window <sup>3</sup>	Upper limit	24	_	56	
f <sub>SCM</sub>	D	Self-clocked mode frequency <sup>4,5</sup>	_	20	_	150	MHz
t <sub>LOCK</sub>	Р	Lock time	Stable oscillator ( $f_{PLLIN} = 4 \text{ MHz}$ ), stable $V_{DD}$	_	_	200	μs

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<sup>&</sup>lt;sup>2</sup> The recommended configuration for maximizing the oscillator margin are:

XOSC\_MARGIN = 0 for 4 MHz quartz

XOSC\_MARGIN = 1 for 8/16/40 MHz quartz



### Table 23. FMPLL electrical characteristics (continued)

Symbo	I	Parameter	Conditions	Min	Тур	Max	Unit
t <sub>lpll</sub>	D	FMPLL lock time <sup>6, 7</sup>	_	_	_	200	μS
t <sub>dc</sub>	D	Duty cycle of reference	_	40	_	60	%
C <sub>JITTER</sub>	Т	CLKOUT period jitter <sup>8,9,10,11</sup>	Long-term jitter (avg. over 2 ms interval), f <sub>FMPLLOUT</sub> maximum	-6	_	6	ns
$\Delta$ t <sub>PKJIT</sub>	Т	Single period jitter (peak to peak)	PHI @ 120 MHz, Input clock @ 4 MHz	_	_	175	ps
			PHI @ 100 MHz, Input clock @ 4 MHz	_	_	185	ps
			PHI @ 80 MHz, Input clock @ 4 MHz	_	_	200	ps
$\Delta t_{LTJIT}$	Т	Long term jitter	PHI @ 16 MHz, Input clock @ 4 MHz		_	±6	ns
f <sub>LCK</sub>	D	Frequency LOCK range	_	-6	_	6	% f <sub>FMPLLOUT</sub>
$f_{UL}$	D	Frequency un-LOCK range	_	-18		18	% f <sub>FMPLLOUT</sub>
f <sub>CS</sub>	D	Modulation depth	Center spread	±0.25	_	±2.0	%
f <sub>DS</sub>			Down spread	-0.5	_	-8.0	f <sub>FMPLLOUT</sub>
f <sub>MOD</sub>	D	Modulation frequency <sup>12</sup>	_	_	_	100	kHz

Considering operation with FMPLL not bypassed.

- $^{5}$  f<sub>VCO</sub> is the frequency at the output of the VCO; its range is 256–512 MHz.  $f_{SCM}$  is the self-clocked mode frequency (free running frequency); its range is 20–150 MHz.  $f_{SYS} = f_{VCO} \div ODF$
- This value is determined by the crystal manufacturer and board design. For 4 MHz to 20 MHz crystals specified for this FMPLL, load capacitors should not exceed these limits.
- This specification applies to the period required for the FMPLL to relock after changing the MFD frequency control bits in the synthesizer control register (SYNCR).
- <sup>8</sup> This value is determined by the crystal manufacturer and board design.
- Jitter is the average deviation from the programmed frequency measured over the specified interval at maximum f<sub>SYS</sub>. Measurements are made with the device powered by filtered supplies and clocked by a stable external clock signal. Noise injected into the FMPLL circuitry via V<sub>DDPLL</sub> and V<sub>SSPLL</sub> and variation in crystal oscillator frequency increase the C<sub>JITTER</sub> percentage for a given interval.
- <sup>10</sup> Proper PC board layout procedures must be followed to achieve specifications.
- <sup>11</sup> Values are with frequency modulation disabled. If frequency modulation is enabled, jitter is the sum of C<sub>JITTER</sub> and either f<sub>CS</sub> or f<sub>DS</sub> (depending on whether center spread or down spread modulation is enabled).
- <sup>12</sup> Modulation depth is attenuated from depth setting when operating at modulation frequencies above 50 kHz.

With FM; the value does not include a possible +2% modulation

<sup>3 &</sup>quot;Loss of Reference Frequency" window is the reference frequency range outside of which the FMPLL is in self clocked mode.

Self clocked mode frequency is the frequency that the FMPLL operates at when the reference frequency falls outside the f<sub>I OR</sub> window.



# 3.14 16 MHz RC oscillator electrical characteristics

Table 24. 16 MHz RC oscillator electrical characteristics

Symbol	C	Parameter	Conditions		Unit		
- Cyllibol		i arameter	Conditions	Min	Тур	Max	
f <sub>RC</sub>	Р	RC oscillator frequency	T <sub>A</sub> = 25 °C	_	16	_	MHz
$\Delta_{\sf RCMVAR}$	Р	Fast internal RC oscillator variation over temperature and supply with respect to $f_{RC}$ at $T_A = 25$ °C in high-frequency configuration	_	-6	_	6	%

### 3.15 ADC electrical characteristics

The device provides a 12-bit Successive Approximation Register (SAR) Analog-to-Digital Converter.

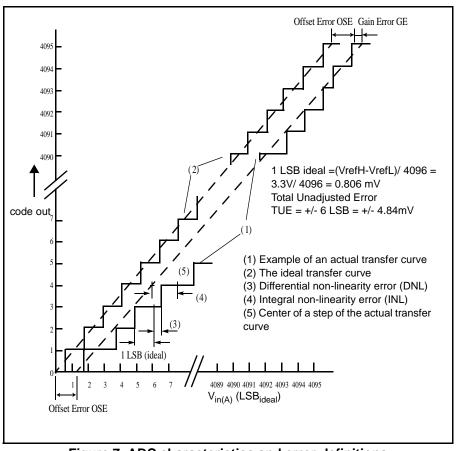


Figure 7. ADC characteristics and error definitions

# 3.15.1 Input Impedance and ADC Accuracy

To preserve the accuracy of the A/D converter, it is necessary that analog input pins have low AC impedance. Placing a capacitor with good high frequency characteristics at the input pin of the device can be effective: the capacitor should be as large as possible, ideally infinite. This capacitor contributes to attenuating the noise present on the input pin; further, it sources charge during the sampling phase, when the analog signal source is a high-impedance source.

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A real filter can typically be obtained by using a series resistance with a capacitor on the input pin (simple RC filter). The RC filtering may be limited according to the value of source impedance of the transducer or circuit supplying the analog signal to be measured. The filter at the input pins must be designed taking into account the dynamic characteristics of the input signal (bandwidth) and the equivalent input impedance of the ADC itself.

In fact a current sink contributor is represented by the charge sharing effects with the sampling capacitance:  $C_S$  and  $C_{p2}$  being substantially a switched capacitance, with a frequency equal to the conversion rate of the ADC, it can be seen as a resistive path to ground. For instance, assuming a conversion rate of 1 MHz, with  $C_{p2} + CS$  equal to 7.5 pF, a resistance of 133 k $\Omega$  is obtained ( $R_{EQ} = 1 / (fS*(C_{p2} + C_S))$ ), where fS represents the conversion rate at the considered channel). To minimize the error induced by the voltage partitioning between this resistance (sampled voltage on  $C_s$ ) and the sum of  $R_S + R_F$ , the external circuit must be designed to respect the Equation 4:

$$V_A \bullet \frac{R_S + R_F}{R_{EQ}} < \frac{1}{2}LSB$$
 Eqn. 4

Equation 4 generates a constraint for external network design, in particular on resistive path. Internal switch resistances ( $R_{SW}$  and  $R_{AD}$ ) can be neglected with respect to external resistances.

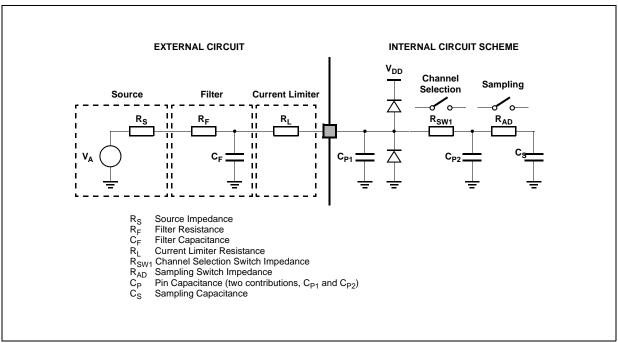


Figure 8. Input Equivalent Circuit

A second aspect involving the capacitance network shall be considered. Assuming the three capacitances  $C_F$ ,  $C_{P1}$  and  $C_{P2}$  are initially charged at the source voltage  $V_A$  (refer to the equivalent circuit reported in Figure 8): A charge sharing phenomenon is installed when the sampling phase is started (A/D switch close).



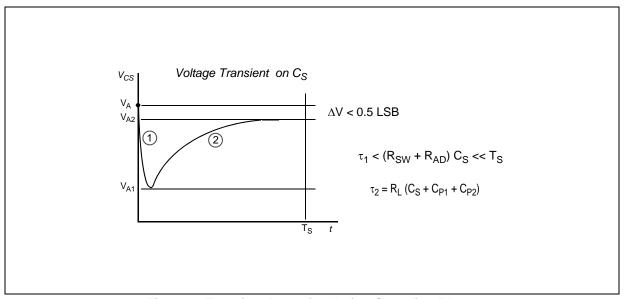


Figure 9. Transient Behavior during Sampling Phase

In particular two different transient periods can be distinguished:

• A first and quick charge transfer from the internal capacitance  $C_{P1}$  and  $C_{P2}$  to the sampling capacitance  $C_S$  occurs ( $C_S$  is supposed initially completely discharged): considering a worst case (since the time constant in reality would be faster) in which  $C_{P2}$  is reported in parallel to  $C_{P1}$  (call  $C_P = C_{P1} + C_{P2}$ ), the two capacitances  $C_P$  and  $C_S$  are in series, and the time constant is

$$\tau_1 = (R_{SW} + R_{AD}) \bullet \frac{C_P \bullet C_S}{C_P + C_S}$$
 Eqn. 5

Equation 5 can again be simplified considering only  $C_S$  as an additional worst condition. In reality, the transient is faster, but the A/D converter circuitry has been designed to be robust also in the very worst case: the sampling time  $T_S$  is always much longer than the internal time constant:

$$\tau_1 < (R_{SW} + R_{AD}) \bullet C_S \ll T_S$$
 Eqn. 6

The charge of  $C_{P1}$  and  $C_{P2}$  is redistributed also on  $C_S$ , determining a new value of the voltage  $V_{A1}$  on the capacitance according to Equation 7:

$$V_{A1} \bullet (C_S + C_{P1} + C_{P2}) = V_A \bullet (C_{P1} + C_{P2})$$
 Eqn. 7

A second charge transfer involves also C<sub>F</sub> (that is typically bigger than the on-chip capacitance) through the resistance
R<sub>L</sub>: again considering the worst case in which C<sub>P2</sub> and C<sub>S</sub> were in parallel to C<sub>P1</sub> (since the time constant in reality
would be faster), the time constant is:

$$\tau_2 < R_L \bullet (C_S + C_{P1} + C_{P2})$$
 Eqn. 8

In this case, the time constant depends on the external circuit: in particular imposing that the transient is completed well before the end of sampling time  $T_S$ , a constraints on  $R_L$  sizing is obtained:

$$10 \bullet \tau_2 = 10 \bullet R_L \bullet (C_S + C_{P1} + C_{P2}) < T_S$$
 Eqn. 9

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Of course,  $R_L$  shall be sized also according to the current limitation constraints, in combination with  $R_S$  (source impedance) and  $R_F$  (filter resistance). Being  $C_F$  definitively bigger than  $C_{P1}$ ,  $C_{P2}$  and  $C_S$ , then the final voltage  $V_{A2}$  (at the end of the charge transfer transient) will be much higher than  $V_{A1}$ . Equation 10 must be respected (charge balance assuming now  $C_S$  already charged at  $V_{A1}$ ):

$$V_{A2} \bullet (C_S + C_{P1} + C_{P2} + C_F) = V_A \bullet C_F + V_{A1} \bullet (C_{P1} + C_{P2} + C_S)$$
 Eqn. 10

The two transients above are not influenced by the voltage source that, due to the presence of the  $R_FC_F$  filter, is not able to provide the extra charge to compensate the voltage drop on  $C_S$  with respect to the ideal source  $V_A$ ; the time constant  $R_FC_F$  of the filter is very high with respect to the sampling time  $(T_S)$ . The filter is typically designed to act as anti-aliasing.

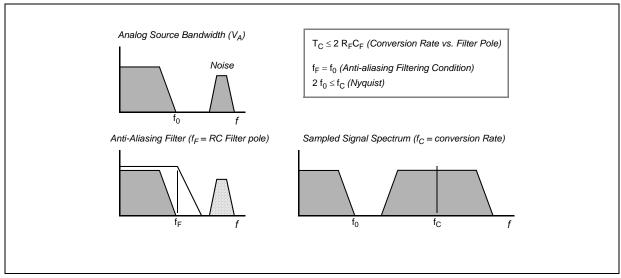


Figure 10. Spectral representation of input signal

Calling  $f_0$  the bandwidth of the source signal (and as a consequence the cut-off frequency of the anti-aliasing filter,  $f_F$ ), according to the Nyquist theorem the conversion rate  $f_C$  must be at least  $2f_0$ ; it means that the constant time of the filter is greater than or at least equal to twice the conversion period  $(T_C)$ . Again the conversion period  $(T_C)$  is longer than the sampling time  $(T_C)$  which is just a portion of it, even when fixed channel continuous conversion mode is selected (fastest conversion rate at a specific channel): in conclusion it is evident that the time constant of the filter  $(T_C)$  is definitively much higher than the sampling time  $(T_C)$ , so the charge level on  $(T_C)$  cannot be modified by the analog signal source during the time in which the sampling switch is closed.

The considerations above lead to impose new constraints on the external circuit, to reduce the accuracy error due to the voltage drop on  $C_S$ ; from the two charge balance equations above, it is simple to derive Equation 11 between the ideal and real sampled voltage on  $C_S$ :

Eqn. 11

$$\frac{V_{A2}}{V_A} = \frac{C_{P1} + C_{P2} + C_F}{C_{P1} + C_{P2} + C_F + C_S}$$

From this formula, in the worst case (when  $V_A$  is maximum, that is for instance 5 V), assuming to accept a maximum error of half a count, a constraint is evident on  $C_F$  value:

Egn. 12

$$C_F > 8192 \cdot C_S$$

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Table 25. ADC conversion characteristics

Symbol		Parameter	Conditions <sup>1</sup>	Min	Тур	Max	Unit
f <sub>CK</sub>	SR	ADC Clock frequency (depends on ADC configuration) (The duty cycle depends on AD_CK <sup>2</sup> frequency)	_	3	_	60	MHz
f <sub>s</sub>	SR	Sampling frequency	_	_	_	983.6 3	KHz
t <sub>sample</sub>	D	Sample time <sup>4</sup>	60 MHz	383	_	_	ns
t <sub>eval</sub>	D	Evaluation time <sup>5</sup>	60 MHz	600	_	_	ns
C <sub>S</sub> <sup>6</sup>	D	ADC input sampling capacitance	_	_	_	7.32	pF
C <sub>P1</sub> <sup>6</sup>	D	ADC input pin capacitance 1	_	_	_	5 <sup>(7)</sup>	pF
C <sub>P2</sub> <sup>6</sup>	D	ADC input pin capacitance 2	_	_	_	8.0	pF
R <sub>SW1</sub> <sup>6</sup>	D	Internal resistance of analog source	V <sub>REF</sub> range = 4.5 to 5.5 V	_	_	0.3	kΩ
			V <sub>REF</sub> range = 3.0 to 3.6 V	_	_	875	Ω
R <sub>AD</sub> <sup>6</sup>	D	Internal resistance of analog source	_	_	_	825	Ω
INL	Р	Integral non linearity	_	-3	_	3	LSB
DNL	Р	Differential non linearity <sup>8</sup>	_	-1	_	2	LSB
OFS	Т	Offset error	_	-6	_	6	LSB
GNE	Т	Gain error	_	-6	_	6	LSB
IS1WINJ			(single ADC channel)				
	С	Max positive/negative injection		-3	_	3	mA
IS1WWINJ			(double ADC channel)				
	С	Max positive/negative injection	Vref_ad0 - Vref_ad1  < 150mV	-3.6	_	3.6	mA
SNR	Т	Signal-to-noise ratio	Vref = 3.3V	67	_	_	dB
SNR	Т	Signal-to-noise ratio	Vref = 5.0V	69	_	_	dB
THD	T	Total harmonic distortion	_	-65	_	_	dB
SINAD	Т	Signal-to-noise and distortion	_	65	_	_	dB
ENOB	Т	Effective number of bits	_	10.5	_	_	bits
TUE <sub>IS1WINJ</sub>	T Total unadjusted error for IS1WINJ (single ADC		Without current injection	-6	_	6	LSB
channels)		With current injection	-8	-	8	LSB	
TUE <sub>IS1WWINJ</sub>	Р	Total unadjusted error for IS1WWINJ (double	Without current injection	-8	_	8	LSB
T ADC ch		ADC channels)	With current injection	-10	_	10	LSB

 $<sup>^{1}</sup>$  T<sub>J</sub> = -40 to +150 °C, unless otherwise specified and analog input voltage from V<sub>AGND</sub> to V<sub>AREF</sub>.

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<sup>&</sup>lt;sup>2</sup> AD\_CK clock is always half of the ADC module input clock defined via the auxiliary clock divider for the ADC.

<sup>&</sup>lt;sup>3</sup> This is the maximum frequency that the analog portion of the ADC can attain. A sustained conversion at this frequency is not possible.



- During the sample time the input capacitance CS can be charged/discharged by the external source. The internal resistance of the analog source must allow the capacitance to reach its final voltage level within t<sub>sample</sub>. After the end of the sample time t<sub>sample</sub>, changes of the analog input voltage have no effect on the conversion result. Values for the sample clock t<sub>sample</sub> depend on programming.
- <sup>5</sup> This parameter does not include the sample time Tsample, but only the time for determining the digital result.
- <sup>6</sup> See Figure 8.
- <sup>7</sup> For the 144-pin package
- <sup>8</sup> No missing codes

# 3.16 Flash memory electrical characteristics

Table 26. Flash memory program and erase electrical specifications

No.	Symbol		Parameter	Typ <sup>1</sup>	Initial Max <sup>2</sup>	Lifetime Max <sup>3</sup>	Unit
1	T <sub>DWPROGRAM</sub>	*4	Double word (64 bits) program time <sup>4</sup>	30	_	500	μs
2	T <sub>PPROGRAM</sub>	*4	Page(128 bits) program time <sup>4</sup>	40	160	500	μs
3	T <sub>16KPPERASE</sub>	*4	16 KB block pre-program and erase time	250	1000	5000	ms
4	T <sub>48KPPERASE</sub>	*4	48 KB block pre-program and erase time	400	1500	5000	ms
5	T <sub>64KPPERASE</sub>	*4	64 KB block pre-program and erase time	450	1800	5000	ms
6	T <sub>128KPPERASE</sub>	*4	128 KB block pre-program and erase time	800	2600	7500	ms
7	T <sub>256KPPERASE</sub>	*4	256 KB block pre-program and erase time	1400	5200	15000	ms

Typical program and erase times represent the median performance and assume nominal supply values and operation at 25C. These values are characterized, but not tested.

Table 27. Flash memory timing

Symbol		Parameter			Unit	
Cymbol	ı	T di diffictor	Min	Тур	Max	Omi
T <sub>RES</sub>	D	Time from clearing the MCR-ESUS or PSUS bit with EHV = 1 until DONE goes low	_	_	100	ns
T <sub>DONE</sub>	D	Time from 0 to 1 transition on the MCR-EHV bit initiating a program/erase until the MCR-DONE bit is cleared	_	_	5	ns
T <sub>PSRT</sub>	D	Time between program suspend resume and the next program suspend request. <sup>1</sup>	100	_		μS
T <sub>ESRT</sub>	D	Time between erase suspend resume and the next erase suspend request. <sup>2</sup>	10			ms

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Initial Max program and erase times provide guidance for time-out limits used in the factory and apply for <100 program/erase cycles, nominal supply values and operation at 25C. These values are verified at production test.

Lifetime Max program and erase times apply across the voltage, temperature, and cycling range of product life. These values are characterized, but not tested.

<sup>&</sup>lt;sup>4</sup> Program times are actual hardware programming times and do not include software overhead.



- <sup>1</sup> Repeated suspends at a high frequency may result in the operation timing out, and the flash module will respond by completing the operation with a fail code (MCR[PEG] = 0), or the operation not able to finish (MCR[DONE] = 1 during Program operation). The minimum time between suspends to ensure this does not occur is  $T_{PSRT}$ .
- If Erase suspend rate is less than T<sub>ESRT</sub>, an increase of slope voltage ramp occurs during erase pulse. This improves erase time but reduces cycling figure due to overstress

Table 28. Flash memory module life

	No. Symbol						
No.			Parameter	Minimu m	Typical	Maximum	Unit
1	P/E	С	Number of program/erase cycles per block for 16 KB, 48 KB, and 64 KB blocks over the operating temperature range <sup>1</sup>	100000	_	_	cycles
2	P/E	С	Number of program/erase cycles per block for 128 KB and 256 KB blocks over the operating temperature range <sup>1</sup>	1000	100000 <sup>2</sup>	_	cycles
3	Retention	С	Minimum data retention at 85 °C average ambient temperature <sup>3</sup> Blocks with 0–1,000 P/E cycles Blocks with 1,001–10,000 P/E cycles Blocks with 10,001–100,000 P/E cycles	20 10 5	_ _ _	_ _ _	years

Operating temperature range is T<sub>J</sub> from –40 °C to 150 °C. Typical endurance is evaluated at 25 °C. Product qualification is performed to the minimum specification. For additional information on the Freescale definition of Typical Endurance, please refer to Engineering Bulletin EB619, *Typical Endurance for Nonvolatile Memory*.

# 3.17 SWG electrical characteristics

Table 29. MPC5643L SWG Specifications

Symbol	Parameter	Value							
Symbol	Farameter	Minimum	Typical	Maximum					
Т	Input clock	12 MHz	16 MHz	20 MHz					
Т	Frequency Range	1kHz	_	50 kHz					
Т	Peak to Peak <sup>1</sup>	0.4 V	_	2.0V					
Т	Peak to Peak variation <sup>2</sup>	-6%	_	6%					
Т	Common Mode <sup>3</sup>	_	1.3 V	_					
Т	Common Mode variation	-6%	_	6%					

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Typical P/E cycles is 100,000 cycles for 128 KB and 256 KB blocks. For additional information on the Freescale definition of Typical Endurance, please refer to Engineering Bulletin EB619, Typical Endurance for Nonvolatile Memory.

<sup>&</sup>lt;sup>3</sup> Ambient temperature averaged over duration of application, not to exceed product operating temperature range.



<b>Table 29.</b> MPC5643L	SWG S	pecifications
---------------------------	-------	---------------

Symbol	Parameter	Value							
Symbol	raiametei	Minimum	Typical	Maximum					
Т	SiNAD <sup>4</sup>	45 dB	_	_					
Т	Load C	25 pF	_	100 pF					
T	Load I	0 μΑ	_	100 μΑ					
Т	ESD Pad Resistance <sup>5</sup>	230 Ω	_	360 Ω					

<sup>1</sup> Peak to Peak value is measured with no R or I load.

# 3.18 AC specifications

# 3.18.1 Pad AC specifications

Table 30. Pad AC specifications (3.3 V , IPP\_HVE = 0 )<sup>1</sup>

No.	No. Pad		Ts	witcho	on <sup>1</sup>	R	ise/Fal (ns)	l <sup>2</sup>		equen (MHz)			rent sl mA/ns		Load drive (pF)
			Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	(ρι )
1	Slow	Т	3	_	40	_	_	40	_	_	4	0.01	_	2	25
			3	_	40	_	_	50	_	_	2	0.01	_	2	50
			3	_	40	_	_	75	_	_	2	0.01	_	2	100
			3	_	40	_	_	100	_	_	2	0.01	_	2	200
2	Medium	Т	1	_	15	_	_	12	_	_	40	2.5	_	7	25
			1	_	15	_	_	25	_	_	20	2.5	_	7	50
			1	_	15	_	_	40	_	_	13	2.5	_	7	100
			1	_	15	_	_	70	_	_	7	2.5	_	7	200
3	Fast	Т	1	_	6	_	_	4	_	_	72	3	_	40	25
			1	_	6	_	_	7	_	_	55	7	_	40	50
			1	_	6	_	_	12	_	_	40	7	_	40	100
			1	_	6	_	_	18	_	_	25	7	_	40	200
4	Symmetric	Т	1	_	8	_	_	5	_	_	50	3	_	25	25

<sup>&</sup>lt;sup>1</sup> Propagation delay from V<sub>DD HV IOx</sub>/2 of internal signal to Pchannel/Nchannel switch-on condition.

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<sup>&</sup>lt;sup>2</sup> Peak to Peak excludes noise, SiNAD must be considered.

<sup>&</sup>lt;sup>3</sup> Common mode value is measured with no R or I load.

<sup>&</sup>lt;sup>4</sup> SiNAD is measured at Max Peak to Peak voltage.

Internal device routing resistance. ESD pad resistance is in series and must be considered for max Peak to Peak voltages, depending on application I load and/or R load.

<sup>&</sup>lt;sup>2</sup> Slope at rising/falling edge.

<sup>&</sup>lt;sup>3</sup> Data based on characterization results, not tested in production.



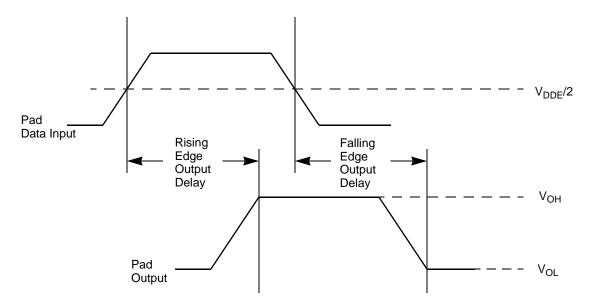


Figure 11. Pad output delay

# 3.19 Reset sequence

This section shows the duration for different reset sequences. It describes the different reset sequences and it specifies the start conditions and the end indication for the reset sequences.

# 3.19.1 Reset sequence duration

Table 31 specifies the minimum and the maximum reset sequence duration for the five different reset sequences described in Section 3.19.2, Reset sequence description.

No.	Symbo	ol.	Parameter	Conditions		Unit			
NO.	Syllib	OI .	raiametei	Conditions	Min	Тур	Max <sup>1</sup>		
1	T <sub>DRB</sub>	СС	Destructive Reset Sequence, BIST enabled		28	34	39	ms	
2	T <sub>DR</sub>	СС	Destructive Reset Sequence, BIST disabled	_	500	4200	5000	μS	
3	T <sub>ERLB</sub>	СС	External Reset Sequence Long, BIST enabled		28	32	37	ms	
4	T <sub>FRL</sub>	СС	Functional Reset Sequence Long	_	35	150	400	μS	
5	T <sub>FRS</sub>	СС	Functional Reset Sequence Short	_	1	4	10	μS	

Table 31. RESET sequences

# 3.19.2 Reset sequence description

The figures in this section show the internal states of the chip during the five different reset sequences. The doted lines in the figures indicate the starting point and the end point for which the duration is specified in Table 31. The start point and end point

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The maximum value is applicable only if the reset sequence duration is not prolonged by an extended assertion of RESET by an external reset generator.



conditions as well as the reset trigger mapping to the different reset sequences is specified in Section 3.19.3, Reset sequence trigger mapping.

With the beginning of DRUN mode the first instruction is fetched and executed. At this point application execution starts and the internal reset sequence is finished.

The figures below show the internal states of the chip during the execution of the reset sequence and the possible states of the signal pin  $\overline{\text{RESET}}$ .

### **NOTE**

RESET is a bidirectional pin. The voltage level on this pin can either be driven low by an external reset generator or by the chip internal reset circuitry. A high level on this pin can only be generated by an external pull up resistor which is strong enough to overdrive the weak internal pull down resistor. The rising edge on RESET in the following figures indicates the time when the device stops driving it low. The reset sequence durations given in table Table 31 are applicable only if the internal reset sequence is not prolonged by an external reset generator keeping RESET asserted low beyond the last PHASE3.

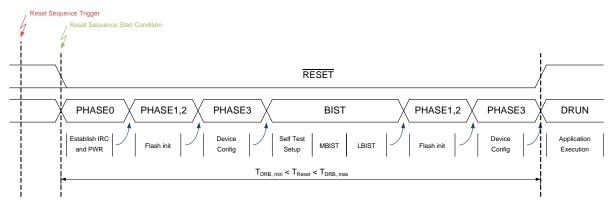


Figure 12. Destructive Reset Sequence, BIST enabled

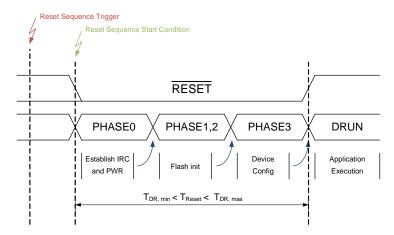


Figure 13. Destructive Reset Sequence, BIST disabled

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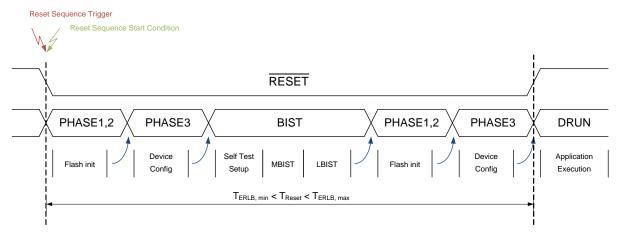


Figure 14. External Reset Sequence Long, BIST enabled

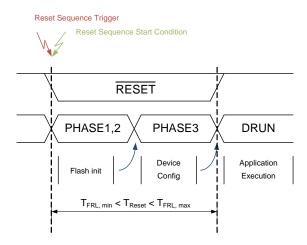
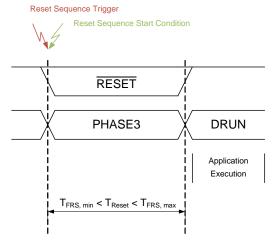


Figure 15. Functional Reset Sequence Long



**Figure 16. Functional Reset Sequence Short** 

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The reset sequences shown in Figure 15 and Figure 16 are triggered by functional reset events.  $\overline{\text{RESET}}$  is driven low during these two reset sequences *only if* the corresponding functional reset source (which triggered the reset sequence) was enabled to drive  $\overline{\text{RESET}}$  low for the duration of the internal reset sequence<sup>1</sup>.

# 3.19.3 Reset sequence trigger mapping

The following table shows the possible trigger events for the different reset sequences. It specifies the reset sequence start conditions as well as the reset sequence end indications that are the basis for the timing data provided in Table 31.

Table 32. Reset sequence trigger — reset sequence

				Re	set Sequenc	е	
Reset Sequence Trigger	Reset Sequence Start Condition	Reset Sequence End Indication	Destructiv e Reset Sequence, BIST enabled <sup>1</sup>	Destructiv e Reset Sequence, BIST disabled <sup>1</sup>	External Reset Sequenc e Long, BIST enabled	Functiona I Reset Sequenc e Long	Functiona I Reset Sequenc e Short
All internal destructive reset sources (LVDs or internal HVD during power-up and during operation)	Section 3.1 9.4.1, Destructive reset	Release of RESET <sup>2</sup>	trigg	gers	cannot trigger	cannot trigger	cannot trigger
Assertion of RESET <sup>3</sup>	Section 3.1 9.4.2, External reset via RESET		cannot	trigger	triggers <sup>4</sup>	triggers <sup>5</sup>	triggers <sup>6</sup>
All internal functional reset sources configured for long reset	Sequence starts with internal reset trigger	Release of RESET <sup>7</sup>	cannot trigger		cannot trigger	triggers	cannot trigger
All internal functional reset sources configured for short reset			cannot	cannot trigger		cannot trigger	triggers

Whether BIST is executed or not depends on the chip configuration data stored in the shadow sector of the NVM.

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End of the internal reset sequence (as specified in Table 31) can only be observed by release of RESET if it is not held low externally beyond the end of the internal sequence which would prolong the internal reset PHASE3 till RESET is released externally.

The assertion of RESET can only trigger a reset sequence if the device was running (RESET released) before.

RESET does not gate a *Destructive Reset Sequence*, *BIST enabled* or a *Destructive Reset Sequence*, *BIST disabled*. However, it can prolong these sequences if RESET is held low externally beyond the end of the internal sequence (beyond PHASE3).

<sup>1.</sup>See RGM\_FBRE register for more details.



- <sup>4</sup> If RESET is configured for long reset (default) and if BIST is enabled via chip configuration data stored in the shadow sector of the NVM.
- If RESET is configured for long reset (default) and if BIST is disabled via chip configuration data stored in the shadow sector of the NVM.
- <sup>6</sup> If RESET is configured for short reset
- <sup>7</sup> Internal reset sequence can only be observed by state of RESET if bidirectional RESET functionality is enabled for the functional reset source which triggered the reset sequence.

# 3.19.4 Reset sequence — start condition

The impact of the voltage thresholds on the starting point of the internal reset sequence are becoming important if the voltage rails / signals ramp up with a very slow slew rate compared to the overall reset sequence duration.

### 3.19.4.1 Destructive reset

Figure 17 shows the voltage threshold that determines the start of the *Destructive Reset Sequence*, *BIST enabled* and the start for the *Destructive Reset Sequence*, *BIST disabled*.

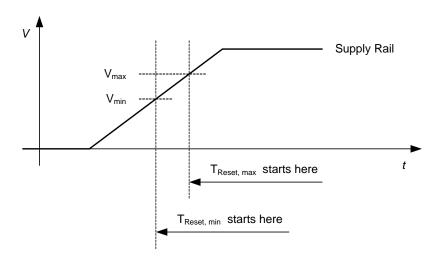


Figure 17. Reset sequence start for Destructive Resets

**Table 33. Voltage Thresholds** 

Variable name	Value
V <sub>min</sub>	Refer to Table 18
V <sub>max</sub>	Refer to Table 18
Supply Rail	VDD_HV_PMU

## 3.19.4.2 External reset via RESET

Figure 18 shows the voltage thresholds that determine the start of the reset sequences initiated by the assertion of  $\overline{RESET}$  as specified in Table 32.

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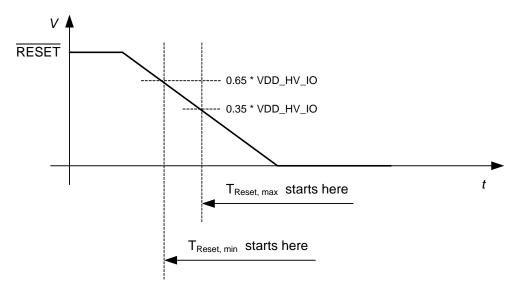


Figure 18. Reset sequence start via RESET assertion

# 3.19.5 External watchdog window

If the application design requires the use of an external watchdog the data provided in Section 3.19, Reset sequence can be used to determine the correct positioning of the trigger window for the external watchdog. Figure 19 shows the relationships between the minimum and the maximum duration of a given reset sequence and the position of an external watchdog trigger window.

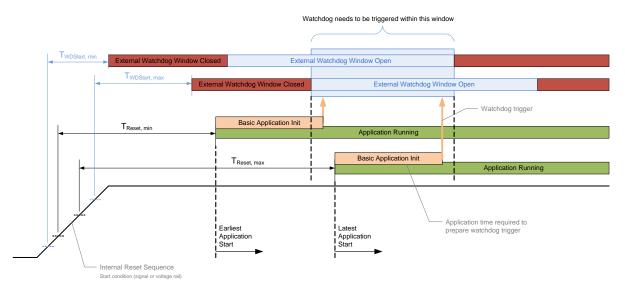


Figure 19. Reset sequence - External watchdog trigger window position

# 3.20 AC timing characteristics

AC Test Timing Conditions: Unless otherwise noted, all test conditions are as follows:

- TJ = -40 to 150 C
- Supply voltages as specified in Table 9

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Input conditions: All Inputs: tr, tf = 1 ns
Output Loading: All Outputs: 50 pF

# 3.20.1 RESET pin characteristics

The MPC5643L implements a dedicated bidirectional  $\overline{RESET}$  pin.

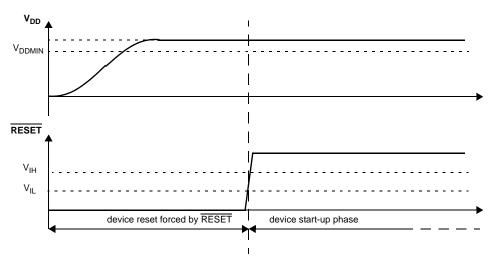


Figure 20. Start-up reset requirements

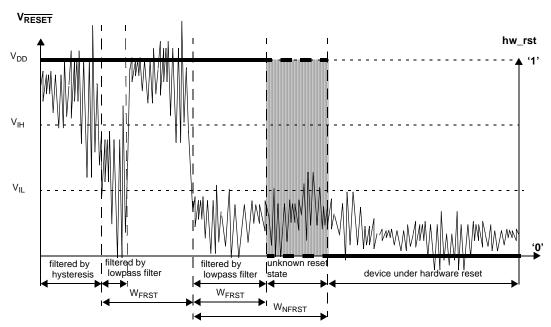


Figure 21. Noise filtering on reset signal

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Table 34.	RESET	electrical	charac	teristics

No.	Symbol		Symbol		Symbol		Parameter	Conditions <sup>1</sup>	Min	Тур	Max	Unit
1	T <sub>tr</sub>	D	Output transition time output pin <sup>2</sup>	C <sub>L</sub> = 25pF	_	_	12	ns				
				C <sub>L</sub> = 50pF	_	_	25					
				C <sub>L</sub> = 100pF	_	_	40					
2	W <sub>FRST</sub>	Р	nRESET input filtered pulse	_	_	_	40	ns				
3	W <sub>NFRST</sub>	Р	nRESET input not filtered pulse	_	500	_	_	ns				

 $<sup>^{1}</sup>$  V<sub>DD</sub> = 3.3 V ± 10%, T<sub>J</sub> = -40 to +150 °C, unless otherwise specified  $^{2}$  C<sub>L</sub> includes device and package capacitance (C<sub>PKG</sub> < 5 pF).

### **WKUP/NMI** timing 3.20.2

Table 35. WKUP/NMI glitch filter

No.	o. Symbol		Parameter	Min	Тур	Max	Unit
1	$W_{FNMI}$	D	NMI pulse width that is rejected	_	_	45	ns
2	$W_{NFNMI}$	D	NMI pulse width that is passed	205	_	_	ns

### 3.20.3 **IEEE 1149.1 JTAG interface timing**

Table 36. JTAG pin AC electrical characteristics

No.	o. Symbol		Symbol Parameter		Min	Max	Unit
1	t <sub>JCYC</sub>	D	TCK cycle time	_	62.5	_	ns
2	t <sub>JDC</sub>	D	TCK clock pulse width (measured at V <sub>DDE</sub> /2)	<del>-</del>	40	60	%
3	t <sub>TCKRISE</sub>	D	TCK rise and fall times (40%–70%)	_	_	3	ns
4	$t_{\text{TMSS}}, t_{\text{TDIS}}$	D	D TMS, TDI data setup time —		5	_	ns
5	$t_{TMSH}, t_{TDIH}$	D	TMS, TDI data hold time	_	25	_	ns
6	t <sub>TDOV</sub>	D	TCK low to TDO data valid	_	_	20	ns
7	t <sub>TDOI</sub>	D	TCK low to TDO data invalid	_	0	_	ns
8	t <sub>TDOHZ</sub>	D	TCK low to TDO high impedance	_	_	20	ns
11	t <sub>BSDV</sub>	D	TCK falling edge to output valid	_	_	50	ns
12	t <sub>BSDVZ</sub>	D	TCK falling edge to output valid out of high impedance	_	_	50	ns
13	t <sub>BSDHZ</sub>	D	TCK falling edge to output high impedance	<del>-</del>	_	50	ns
14	t <sub>BSDST</sub>	D	Boundary scan input valid to TCK rising edge	_	50	_	ns
15	t <sub>BSDHT</sub> D TCK rising edge to boundary scan input invalid —		_	50		ns	

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### **Electrical characteristics**

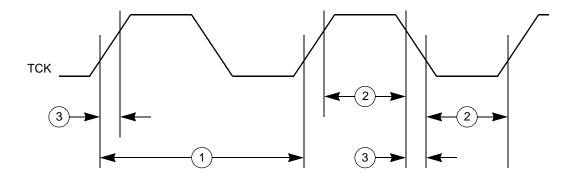


Figure 22. JTAG test clock input timing

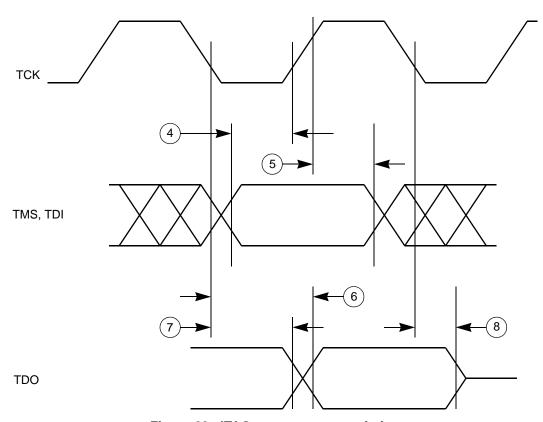


Figure 23. JTAG test access port timing



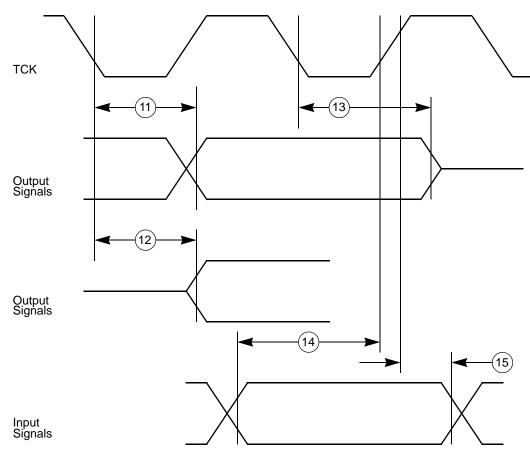


Figure 24. JTAG boundary scan timing

## 3.20.4 Nexus timing

Table 37. Nexus debug port timing<sup>1</sup>

No.	Symbol		Parameter	Conditions	Min	Max	Unit
1	t <sub>MCYC</sub>	D	MCKO Cycle Time	_	15.6	_	ns
2	t <sub>MDC</sub>	D	MCKO Duty Cycle	_	40	60	%
3	t <sub>MDOV</sub>	D	MCKO Low to MDO, MSEO, EVTO Data Valid <sup>2</sup>	_	-0.1	0.25	$t_{MCYC}$
4	t <sub>EVTIPW</sub>	D	EVTI Pulse Width	_	4.0	_	t <sub>TCYC</sub>
5	t <sub>EVTOPW</sub>	D	EVTO Pulse Width	_	1		$t_{MCYC}$
6	t <sub>TCYC</sub>	D	TCK Cycle Time <sup>3</sup>	_	62.5	_	ns
7	t <sub>TDC</sub>	D	TCK Duty Cycle	_	40	60	%
8	t <sub>NTDIS</sub> , t <sub>NTMSS</sub>	D	TDI, TMS Data Setup Time	_	8	_	ns
9	t <sub>NTDIH</sub> , t <sub>NTMSH</sub>	D	TDI, TMS Data Hold Time		5	_	ns
10	t <sub>JOV</sub>	D	TCK Low to TDO/RDY Data Valid		0	25	ns

JTAG specifications in this table apply when used for debug functionality. All Nexus timing relative to MCKO is measured from 50% of MCKO and 50% of the respective signal.

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<sup>&</sup>lt;sup>2</sup> For all Nexus modes except DDR mode, MDO, MSEO, and EVTO data is held valid until next MCKO low cycle.



### **Electrical characteristics**

 $^{3}\,$  The system clock frequency needs to be four times faster than the TCK frequency.

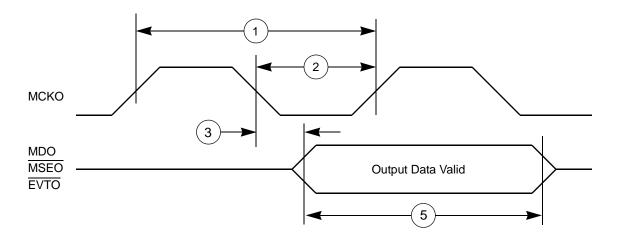


Figure 25. Nexus output timing

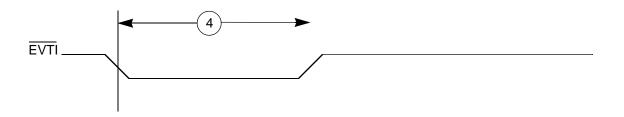
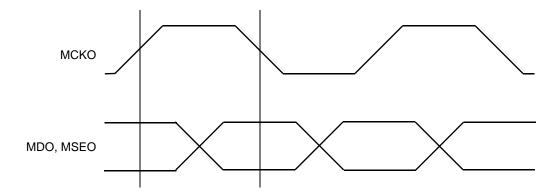


Figure 26. Nexus EVTI Input Pulse Width





MDO/MSEO data are valid during MCKO rising and falling edge

Figure 27. Nexus Double Data Rate (DDR) Mode output timing



## **Electrical characteristics**

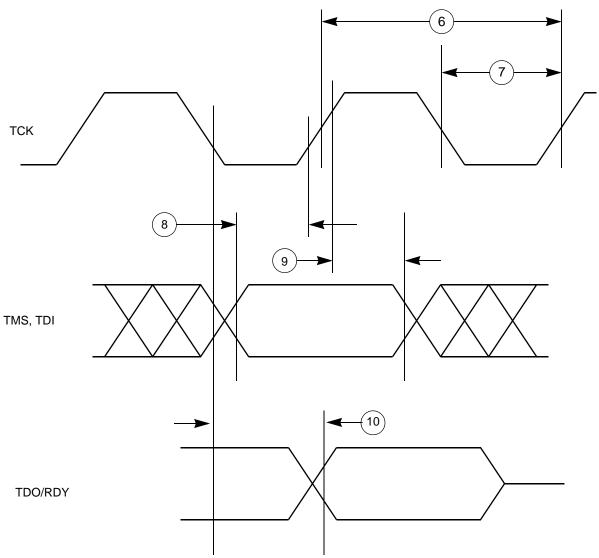


Figure 28. Nexus TDI, TMS, TDO timing

# 3.20.5 External interrupt timing (IRQ pin)

Table 38. External interrupt timing

No.	Symbol		Parameter	Conditions	Min	Max	Unit
1	t <sub>IPWL</sub>	D	IRQ pulse width low	_	3	_	$t_{\text{CYC}}$
2	t <sub>IPWH</sub>	D	IRQ pulse width high	_	3	_	$t_{\text{CYC}}$
3	t <sub>ICYC</sub>	D	IRQ edge to edge time <sup>1</sup>	_	6	_	$t_{CYC}$

<sup>&</sup>lt;sup>1</sup> Applies when IRQ pins are configured for rising edge or falling edge events, but not both.

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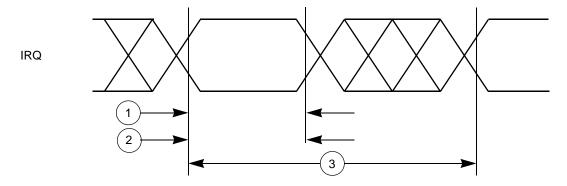


Figure 29. External interrupt timing

# 3.20.6 DSPI timing

Table 39. DSPI timing

No.	Symbol		Parameter Conditions		Min	Max	Unit
1	t <sub>SCK</sub>	D	DSPI cycle time	Master (MTFE = 0)	62	_	ns
		D		Slave (MTFE = 0)	62	_	•
		D		Slave Receive Only Mode <sup>1</sup>	16	_	
2	t <sub>CSC</sub>	D	PCS to SCK delay	_	16	_	ns
3	t <sub>ASC</sub>	D	After SCK delay	_	16	_	ns
4	t <sub>SDC</sub>	D	SCK duty cycle	_	t <sub>SCK</sub> /2 - 10	t <sub>SCK</sub> /2 + 10	ns
5	t <sub>A</sub>	D	Slave access time	SS active to SOUT valid	_	40	ns
6	t <sub>DIS</sub>	D	Slave SOUT disable time	SS inactive to SOUT High-Z or invalid	_	10	ns
7	t <sub>PCSC</sub>	D	PCSx to PCSS time	_	13	_	ns
8	t <sub>PASC</sub>	D	PCSS to PCSx time	_	13	_	ns
9	t <sub>SUI</sub>	D	Data setup time for inputs	Master (MTFE = 0)	20	_	ns
				Slave	2	_	
				Master (MTFE = 1, CPHA = 0)	5	_	
				Master (MTFE = 1, CPHA = 1)	20	_	
10	t <sub>HI</sub>	D	Data hold time for inputs	Master (MTFE = 0)	<b>-</b> 5	_	ns
				Slave	4	_	
				Master (MTFE = 1, CPHA = 0)	11	_	
				Master (MTFE = 1, CPHA = 1)	<b>-</b> 5	_	
11	t <sub>SUO</sub>	D	Data valid (after SCK edge)	Master (MTFE = 0)	_	4	ns
				Slave	_	23	
				Master (MTFE = 1, CPHA = 0)	_	12	
				Master (MTFE = 1, CPHA = 1)	_	4	

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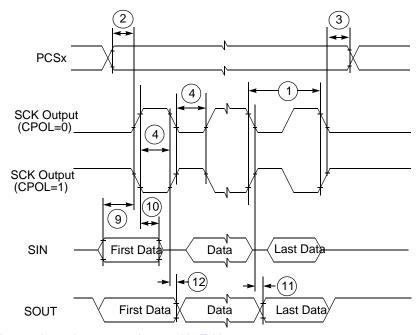


### **Electrical characteristics**

Table 39. DSPI timing (continued)

No.	Symbol		Parameter	Conditions	Min	Max	Unit
12	t <sub>HO</sub>	D	Data hold time for outputs	Master (MTFE = 0)	-2	_	ns
				Slave	6	_	
				Master (MTFE = 1, CPHA = 0)	6	_	
				Master (MTFE = 1, CPHA = 1)	-2	_	

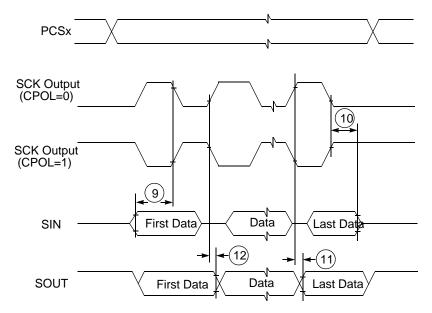
Slave Receive Only Mode can operate at a maximum frequency of 60 MHz. In this mode, the DSPI can receive data on SIN, but no valid data is transmitted on SOUT.



Note: The numbers shown are referenced in Table 39.

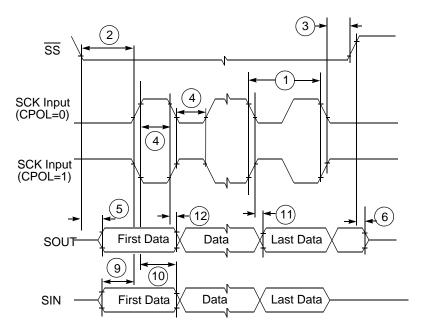
Figure 30. DSPI classic SPI timing — master, CPHA = 0





Note: The numbers shown are referenced in Table 39.

Figure 31. DSPI classic SPI timing — master, CPHA = 1

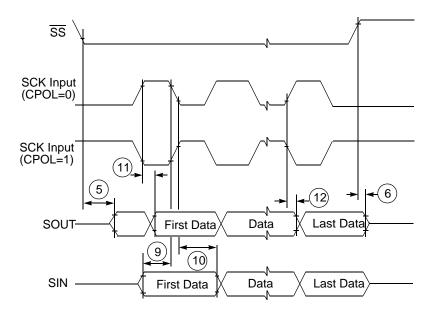


Note: The numbers shown are referenced in Table 39.

Figure 32. DSPI classic SPI timing — slave, CPHA = 0

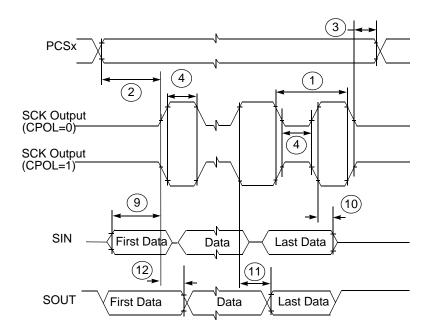


### **Electrical characteristics**



Note: The numbers shown are referenced in Table 39.

Figure 33. DSPI classic SPI timing — slave, CPHA = 1

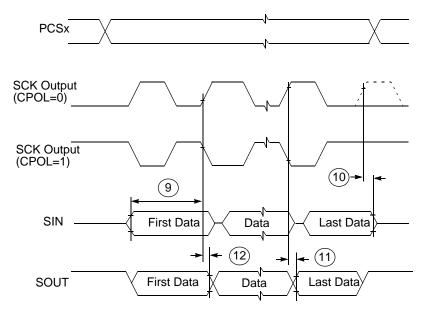


Note: The numbers shown are referenced in Table 39.

Figure 34. DSPI modified transfer format timing — master, CPHA = 0

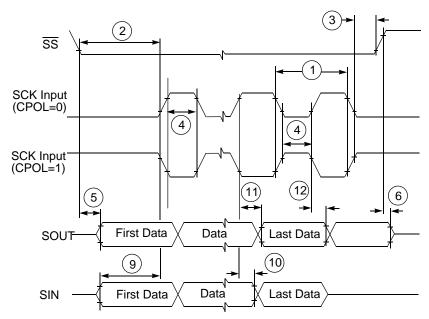
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Note: The numbers shown are referenced in Table 39.

Figure 35. DSPI modified transfer format timing — master, CPHA = 1

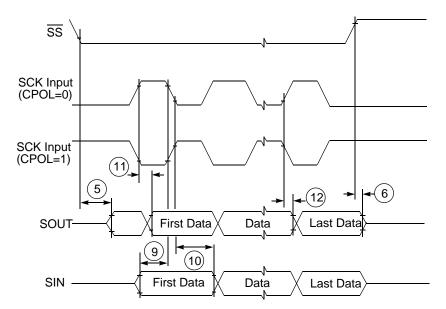


Note: The numbers shown are referenced in Table 39.

Figure 36. DSPI modified transfer format timing - slave, CPHA = 0



### Package characteristics



Note: The numbers shown are referenced in Table 39.

Figure 37. DSPI modified transfer format timing — slave, CPHA = 1



Note: The numbers shown are referenced in Table 39.

Figure 38. DSPI PCS strobe (PCSS) timing

# 4 Package characteristics

# 4.1 Package mechanical data



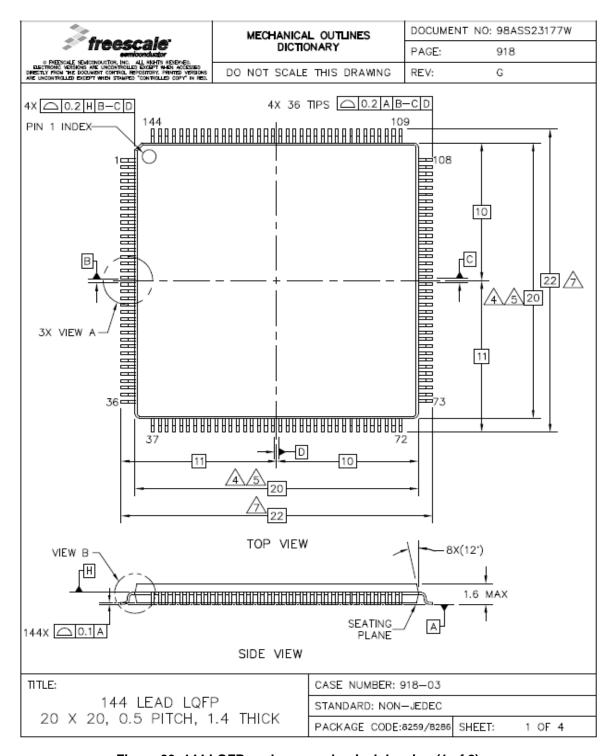


Figure 39. 144 LQFP package mechanical drawing (1 of 2)



#### Package characteristics

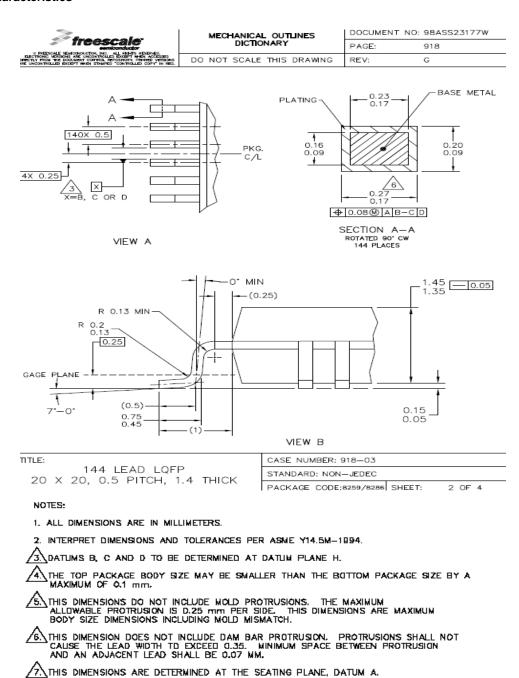


Figure 40. 144 LQFP package mechanical drawing (2 of 2)

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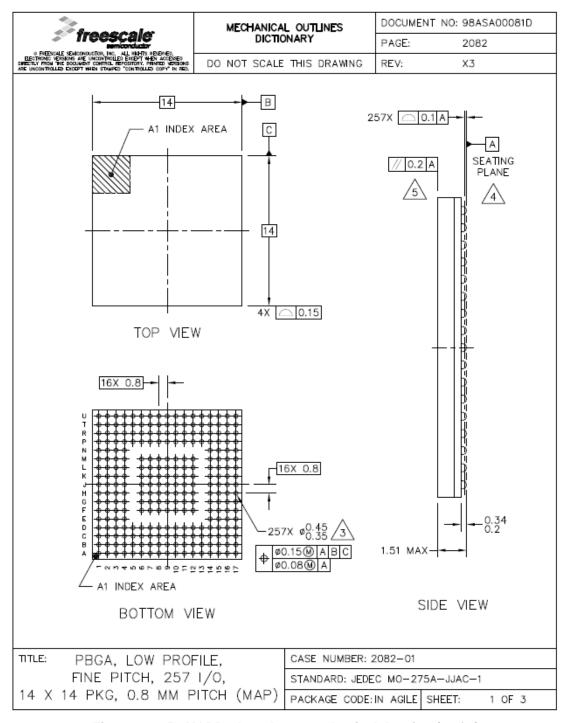


Figure 41. 257 MAPBGA package mechanical drawing (1 of 2)

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#### Package characteristics

#### NOTES:

1. ALL DIMENSIONS IN MILLIMETERS.

2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

3. MAXIMUM SOLDER BALL DIAMETER MEASURED PARALLEL TO DATUM A.

DATUM A, THE SEATING PLANE, IS DETERMINED BY THE SPHERICAL CROWNS OF THE SOLDER BALLS.

PARALLELISM MEASUREMENT SHALL EXCLUDE ANY EFFECT OF MARK ON TOP SURFACE OF PACKAGE.

TITLE: PBGA, LOW PROFILE, CASE NUMBER: 2082-01

FINE PITCH, 257 I/O, STANDARD: JEDEC MO-275A-JJAC-1

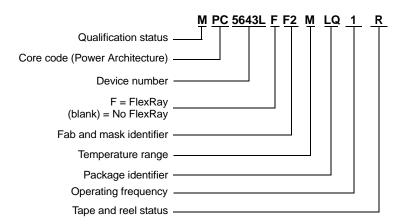
14 X 14 PKG, 0.8 MM PITCH (MAP) PACKAGE CODE: IN AGILE SHEET: 2

Figure 42. 257 MAPBGA package mechanical drawing (2 of 2)

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# 5 Ordering information



Temperature range Package identifier Operating frequency Tape and reel status  $M = -40 \,^{\circ}\text{C}$  to 125  $\,^{\circ}\text{C}$  LQ = 144 LQFP 1 = 120 MHz R = Tape and reel (blank) = Trays R = Tape and reel (blank) = Trays

**Qualification status** 

P = Pre-qualification

**Note:** Not all options are available on all devices. See Table 40. M = Fully spec. qualified, general market flow S = Fully spec. qualified, automotive flow

Figure 43. Commercial product code structure

Table 40. Orderable part number summary

Part number <sup>1</sup>	Flash/SRAM	Package	Speed (MHz) <sup>2</sup>	Other features
SPC5643LFF2MLQ1	1 MB/128 KB	144 LQFP (Pb free)	120	FlexRay -40-125 °C
SPC5643LFF2MMM1	1 MB/128 KB	257 MAPBGA (Pb free)	120	FlexRay -40-125 °C
SPC5643LF2MLQ1	1 MB/128 KB	144 LQFP (Pb free)	120	No FlexRay -40-125 °C
SPC5643LF2MMM1	1 MB/128 KB	257 MAPBGA (Pb free)	120	No FlexRay -40-125 °C
SPC5643LFF2VLQ1	1 MB/128 KB	144 LQFP (Pb free)	120	FlexRay -40-105 °C
SPC5643LFF2VMM1	1 MB/128 KB	257 MAPBGA (Pb free)	120	FlexRay -40-105 °C
SPC5643LF2VLQ1	1 MB/128 KB	144 LQFP (Pb free)	120	No FlexRay -40-105 °C
SPC5643LF2VMM1	1 MB/128 KB	257 MAPBGA (Pb free)	120	No FlexRay -40-105 °C
SPC5643LFF2MLQ8	1 MB/128 KB	144 LQFP (Pb free)	80	FlexRay -40-125 °C
SPC5643LFF2MMM8	1 MB/128 KB	257 MAPBGA (Pb free)	80	FlexRay -40-125 °C

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### **Document revision history**

Table 40. Orderable part number summary (continued)

Part number <sup>1</sup>	Flash/SRAM	Package	Speed (MHz) <sup>2</sup>	Other features
SPC5643LF2MLQ8	1 MB/128 KB	144 LQFP (Pb free)	80	No FlexRay -40-125 °C
SPC5643LF2MMM8	1 MB/128 KB	257 MAPBGA (Pb free)	80	No FlexRay -40-125 °C
SPC5643LFF2VLQ8	1 MB/128 KB	144 LQFP (Pb free)	80	FlexRay -40-105 °C
SPC5643LFF2VMM8	1 MB/128 KB	257 MAPBGA (Pb free)	80	FlexRay -40-105 °C
SPC5643LF2VLQ8	1 MB/128 KB	144 LQFP (Pb free)	80	No FlexRay -40-105 °C
SPC5643LF2VMM8	1 MB/128 KB	257 MAPBGA (Pb free)	80	No FlexRay -40-105 °C

All packaged devices are SPC, rather than MPC or SPC, until product qualifications are complete. The unpackaged device prefix is PCC, rather than SCC, until product qualification is complete. Not all configurations are available in the SPC parts.

# 6 Document revision history

Table 41 summarizes revisions to this document.

Table 41. Revision history

Revision	Date	Description of changes
1	2 Mar 2009	Initial release.
2	5 May 2009	Updated, Advance Information.  —Revised SINAD/SNR specifications.  — Updated pinout and pin multiplexing information.
3	5 Oct 2009	Updated, Advance Information, Public release.  — Throughout this document, added information for 257 MAPBGA package.  — Updated Table 1, MPC5643L device summary.  — Updated Section 1.3, Feature Details.  — Updated pin-out and pin multiplexing tables.  — In Section 3, Electrical characteristics, added symbols for signal characterization methods.  — In Table 8, updated maximum ratings.  — In Table 10 and Table 11, removed moving-air thermal characteristics.  — Updated Section 3.8, Voltage regulator electrical characteristics.  — Updated Section 3.14, ADC electrical characteristics.  — Updated Section 3.15, Flash memory electrical characteristics.  — Updated Section 3.17.1, RESET pin characteristics.  — Removed External interrupt timing (IRQ pin) timing specifications.  — Updated Section 5, Ordering information.

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<sup>&</sup>lt;sup>2</sup> This speed rating does not include the ±2% for frequency modulation.



## Table 41. Revision history (continued)

Revision	Date	Description of changes
4	2 Mar 2010	Editorial changes and improvements. Revised the 257-pin package pin pitch (was 1.4 mm, is 0.8 mm). In the Overview section:  Renamed the peripheral bridge to "PBRIDGE".  Revised the information for FlexRay.  Revised the "Clock, reset, power, mode and test control module" section.  Revised the "Platform memory access time summary" table and replaced TBDs by meaningful values.  Extensive revisions to signal descriptions and pin muxing information. In the "conditions (3.3 V)" table, changed the specification for V <sub>DD_HV_ADR0</sub> and V <sub>DD_HV_ADR1</sub> (was "3.3 V", is "3.6 V").  Revised the "EMI testing specifications" table. In the "HPREG1, HPREG2, Main LVDs, Digital HVD, and Digital LVD electrical specifications" table, added a specification for the digital low voltage detector upper threshold.  Revised the "FMPLL electrical characteristics" table. In the "Main oscillator electrical characteristics" table, changed the maximum specification for g <sub>mXOSCHS</sub> (was 11 mA/V, is 11.8 mA/V).  Revised the "ADC electrical characteristics" section. In the "ADC conversion characteristics" table:  Changed the t <sub>ADC_S</sub> specification (was TBD, is minimum of 383 ns).  Added the footnote "No missing codes" to the DNL specification.  Added specifications for SNR, THD, SINAD, and ENOB.  Revised the "Ordering information" section.



## **Document revision history**

**Table 41. Revision history (continued)** 

Revision	Date	Description of changes
S 5	Date 31 Aug 2010	Editorial changes and improvements. Revised the Overview section. Replaced references to PowerPC with references to Power Architecture. In the feature summary, changed "As much as 128 KB on-chip SRAM" to "128 KB on-chip SRAM". In the "Feature details" section: In the "Feature details" section: In the "On-chip SRAM with ECC" section, added information about required RAM wait states. In the PIT section, deleted "32-bit counter for real time interrupt, clocked from main external oscillator" (not supported on this device). In the flash-memory section, changed "16 KB Test" to "16 KB test sector", revised the wait state information, and deleted the associated Review_Q&A content. In the 144-pin pinout diagram: Renamed pin 58 (was VDD_HV_ADV0_ADV1, is VDD_HV_ADV). Renamed pin 58 (was VDD_HV_ADV0_ADV1, is VDD_HV_ADV). Renamed pin 59 (was VSS_HV_ADV0_ADV1, is VSS_HV_ADV). In the "144 LQFP pin function summary" table, for pin 39, changed V <sub>SS_LV_COR</sub> to V <sub>DD_LV_COR</sub> . In the "Supply pins" table: Changed the description for V <sub>DD_HV_COR</sub> (was "Voltage regulator supply voltage", is "Core logic supply"). Changed the description for V <sub>DD_HV_PMU</sub> (was "Core regulator supply", is "Voltage regulator supply" is "Voltage regulator supply", is "Voltage regulator clear core in the "Pad speed" column headings, changed "SRC = 0" to "SRC = 1" and "SRC = 1" to "SRC = 0" For port B[6], changed the pad speed for SRC=0 (was M, is F). In the "Thermal characteristics" section, added meaningful values to the thermal-characteristics tables. Added the "SWG electrical specifications" section. In the "Voltage regulator electrical characteristics" section, changed the table title (was "HPREG1, HPREG2, Main LVDs, Digital HVD, and Digital LVD electrical specifications", is "Voltage regulator electrical characteristics") and revised the ta
		In the 'RC oscillator electrical characteristics" table, deleted the specification for $\Delta_{\text{RCMTRIM}}$ . Revised the "ADC conversion characteristics" table.
5 (cont.)	31 Aug 2010 (cont.)	In the "RESET pin characteristics" section, changed "nRSTIN" to "RESET".  Added the "Reset sequence" section.  Revised the footnotes in the "Nexus debug port timing" table.  In the "Orderable part number summary" table, added a footnote about frequency modulation to the "Speed (MHz)" column heading.

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## Table 41. Revision history (continued)

Revision	Date	Description of changes
6	11 Mar 2011	Editorial changes.
		In the "Document overview" section, added information about how content specific to silicon versions ("cut1" and "cut2") is presented.
		In the isometric miniature package drawings on the front page, removed the third dimension.
		Changed Symbol from P to D for "Conversion Time" in "ADC conversion characteristics" table.
		Added classification symbol "D" to seven entries in "Voltage regulator electrical specifications" table.
		Removed irrelevant Flexcan specs.
		Updated Table "Voltage Thresholds" to reference values specified in Table "Voltage Regulator Electrical Specifications".
		RDY pin added for cut2.
		In the "System pins" table, added a footnote about the MDO0 pad speed.
		Updated Rsw1 values.
		Added TUE-related spec information for single and double ADC channels.
		Added AC Test Timing Conditions to the "AC timing characteristics" section.
		Added a statement on the first page describing cut1 versus cut2.
		Moved the first paragraph from the "Description" section to the beginning of the "Document overview" section.
		Changed pad speed from "M" to "SYM" for FlexRay pins in the "Pin Muxing" table and added this pad type to the footnote.
		Moved the newly added device current specification entries from the "DC electrical characteristics" table into a newly created "Supply current characteristics" table.
		Added symbol "CC" to the description in the "Introduction" section.
		Updated "Input leakage current" specs in the "DC electrical characteristics" table.
		Changed T <sub>ADC_S</sub> to T <sub>sample</sub> and T <sub>ADC_C</sub> to T <sub>conv</sub> in the "ADC conversion characteristics" table and footnotes.
		Removed "IINJ" from the "ADC conversion characteristics" table as this is included in
		IS1WIKNJ and IS1WWiNJ.
		Changed RESET_B to RESET in the "Reset sequence" section.
		Added the "Flash memory timing" table.
		Added cut2 specs for T <sub>DRB</sub> and T <sub>ERLB</sub> to the "Reset sequences" table.



## **Document revision history**

**Table 41. Revision history (continued)** 

Revision	Date	Description of changes
6	11 Mar 2011	Added "WKUP/NMI Timing" subsection and "WKUP/NMI Glitch Filter" table to the "AC
(cont.)	(cont.)	timing characteristics" section.
, ,	, ,	Added "Nexus DDR Mode output timing" table to the "Nexus timing" section.
		Removed the "CLKOUT" diagram from the "External interrupt timing (IRQ pin)" section as
		it is not relevant.
		Corrected an error in the IRQ timing in the "External interrupt timing" figure.
		Updated the t <sub>SDC</sub> parameters in the "DSPI timing" table.
		Renamed the "Electromagnetic Interference (EMI) characteristics" section (is
		"Electromagnetic Interference (EMI) characteristics (cut1)") and revised all information
		in that section.
		In the "Voltage regulator electrical characteristics" section, added the BCX68 from
		Infineon to the list of supported transistors.
		Revised the "Voltage regulator electrical specifications" table to include cut1 and cut2
		information.
		Renamed the "Supply current characteristics" section (is "Supply current characteristics
		(cut2)") and revised it to show meaningful data.
		In the footnotes of the "Main oscillator electrical characteristics" table, changed
		SELMARGIN to XOSC_MARGIN.
		In the "ADC conversion characteristics" table:
		Changed "LSB" to "Counts".
		Created separate rows for the TUE specifications.
		Added bullet regarding HALT and STOP in the "Clock, reset, power, mode and test control
		modules (MC_CGM, MC_RGM, MC_PCU, and MC_ME)" subsection of the "Features
		section.
		In the "Analog-to-Digital Converter module" subsection of the "Feature Details" section,
		changed "Motor control mode" to "CTU mode" to be consistent with the nomenclature used in the Reference Manual.
		Updated the JCOMP entries in the "Pin function summary" table.
		Added footnotes regarding pad pull devices to NMI, TMS, TCK, and JCOMP in the
		"System pins" table.
		Added "Time constant of RC filter at LVD input" parameters to the "Main supply LVD (LVD
		Main) specifications" table.
		In the "Supply current characteristics (cut2)" table:
		Changed "I <sub>DD_LV_MAX</sub> " to "I <sub>DD_LV_MAX</sub> ";
		Removed all "40-120 MHz" frequency ranges from the "Conditions" column;
		Updated the "Max" values column;
		Added parameter "I <sub>DD LV TYP</sub> + I <sub>DD LV PLL</sub> " with "P" classification and special footnote
		• Changed all "25°C" temperature conditions to "ambient";
		• Added "T <sub>J</sub> = 150 °C" condition to parameters I <sub>DD_HV_ADC</sub> , I <sub>DD_HV_AREF</sub> ., I <sub>DD_HV_OSC</sub>
		and I <sub>DD_HV_FLASH</sub> .
		Changed the timing diagram in the "Main oscillator electrical characteristics" section to
		reference MTRANS assertion instead of V <sub>DDMIN</sub> .
		Updated the jitter specs in the "FMPLL electrical characteristics" table.
		In the "ADC conversion characteristics" table, changed all parameters with units of
		"counts" to units of "LSB" and updated Min/Max values.
		Changed I <sub>DD_LV_BIST</sub> + I <sub>DD_LV_PLL</sub> operating current (for both cases) to TBD.
		In the "Supply current characteristics (cut2)" section, added a footnote that I <sub>DD HV ADC</sub>
		and I <sub>DD HV AREF</sub> represent the total current of both ADCs in the "Current consumption
		characteristics" table.

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## Table 41. Revision history (continued)

Revision	Date	Description of changes
6 (cont.)	11 Mar 2011 (cont.)	In the "ADC conversion characteristics" table:  • Changed DNL min from -2 to -1.  • Changed OFS min from -2 to -6.  • Changed OFS max from 2 to 6.  • Changed GNE min from -2 to -6.  • Changed GNE max from 2 to 6.  • Changed SNR min from 69 to 67.  • Changed TUE min (without current injection) from -6 to -8.  • Changed TUE max (without current injection) from 6 to 8.  • Changed TUE min (with current injection) from -8 to -10.  • Changed TUE max (with current injection) from 8 to 10.
7	25 Mar 2011	In the "Description" section, changed the first paragraph and its bullets to paragraph form only.  In the "Voltage regulator electrical specifications" table, changed the C <sub>V1V2</sub> Min value from "—" to 300 nF, and changed the Max value from 300 nF to 900 nF.  In the "Supply current characteristics (cut2)" table, corrected the "I <sub>DD_LV_TYP</sub> + I <sub>DD_LV_PLL</sub> " values as follows:  • Changed the maximum value for "T <sub>J</sub> = ambient" from "279 mA+ 2.10 mA*f <sub>CPU</sub> " to "279 mA".  • Changed the maximum value for "T <sub>J</sub> = 150 °C" from "318 mA+ 2.30 mA*f <sub>CPU</sub> " to 318 mA.  • Changed the frequency multiplier "f <sub>CPU</sub> " in the max value to read "f <sub>CPU</sub> [MHz]" for "I <sub>DD_LV_FULL</sub> + I <sub>DD_LV_PLL</sub> " and "I <sub>DD_LV_TYP</sub> + I <sub>DD_LV_PLL</sub> ".  In the "JTAG pin AC electrical characteristics" table:  • Changed t <sub>JCYC</sub> min from 100ns to 62.5ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5ns.  • Changed t <sub>TCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>TCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5 ns.  • Changed t <sub>JCYC</sub> min from 40ns to 62.5 ns.



## **Document revision history**

## Table 41. Revision history (continued)

Revision Date	Description of changes
Revision Date  8 27 April 2	<u> </u>

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Table 41. Revision history (continued)

Revision	Date	Description of changes
Revision	Date	<ul> <li>In Section 1.5.31, "eTimer module" changed text from "The MPC5643L provides three eTimer modules on the 257 MAPBGA device, and two eTimer modules on the 144 LQFP package" to "The MPC5643L provides three eTimer modules on the LQFP package eTimer_2 is available internally only without any external I/O access)".</li> <li>In Section 3.5, "Electromagnetic Interference (EMI) characteristics",added additional information at the end of this section.</li> <li>In Section 3.8, Voltage regulator electrical characteristics, added text related to external ballast transistor.</li> <li>In Table 3 and Table 4 (257 MAPBGA pin function summary), moved EVTI from output function to input function.</li> <li>In Table 6 (System pins), changed the direction for EXTAL from "Output Only" to "Input/Output".</li> <li>In Table 6, added table footnote for symbol "EXTAL".</li> <li>Changed the row (TVdd) in Table 8 (Absolute maximum ratings).</li> <li>In Table 8, Maximum value for "V<sub>DD_HV_IOX</sub>" and "V<sub>DD_HV_FLA</sub>" changed from "3.6" to "4.0".</li> <li>In Table 20 (Current consumption characteristics), added max value 250 and 290 mA for symbol I<sub>DD_LV_BIST+I<sub>DD_LV_PLL</sub>.</sub></li> <li>Added five additional RunIDD parameters in Table 20 (Current consumption characteristics).</li> <li>In Table 21 (Temperature sensor electrical characteristics), changed condition for parameter "Accuracy" from "-40°C to 25°C" to "-40°C to 150°C"</li> <li>In Table 23 (FMPLL electrical characteristics), added "150' to the max value for "f<sub>SCM</sub>" In Table 24 (16 MHz RC oscillator electrical characteristics), changes done are: f<sub>RC</sub> symbol- Added min value '15.04' and max value '16.96'.Removed condition "T<sub>J</sub>=25°C" Removed references to Cut1 and Cut2: Renamed Section "Electromagnetic Interference (EMI) characteristics (cut1)" to "Electromagnetic Interference (EMI) characteristics </li></ul>
		<ul> <li>Changed min value to '-72' for symbol 'THD'.</li> <li>In Table 25 (ADC conversion characteristics), changed ADC specification parameter 'THD' minimum limit from -72 to -65dB.</li> <li>In Table 26 (Flash memory program and erase electrical specifications), changes done</li> </ul>
		are as follows:  T <sub>DWPROGRAM</sub> , changed typical value from '39' to '38'.  T <sub>PPROGRAM</sub> , changed typical value from '48' to '45' and intial max value from '100' to '160'.  T <sub>16KPPERASE</sub> , inserted typical value '270' and factory avg '1000'.  T <sub>48KPPERASE</sub> , inserted typical value '625' and factory avg '1500'.  T <sub>64KPPERASE</sub> , inserted typical value '800' and factory avg '1800'.  T <sub>128KPPERASE</sub> , inserted typical value '1500' and factory avg '2600'.  T <sub>256KPPERASE</sub> , inserted typical value '3000' and factory avg '5200'.
		<ul> <li>Updated table footnote and removed min column in Table 26 (Flash memory program and erase electrical specifications)</li> <li>In Table 27 (Flash memory timing), added symbol T<sub>PSRT</sub>, T<sub>ESRT</sub> and added table footnote for T<sub>PSRT</sub>, T<sub>ESRT</sub>.</li> </ul>

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## **Document revision history**

**Table 41. Revision history (continued)** 

Revision	Date	Description of changes
		<ul> <li>Added Table 29 (MPC5643L SWG Specifications)</li> <li>In Table 29 (MPC5643L SWG Specifications)</li> <li>Added table footnote for Common Mode.</li> <li>Changed text from "internal device pad resistance" to "internal device routing resistance".</li> <li>Added Figure 26 in Section 3.20.4, "Nexus timing".</li> <li>In Table 30 (Pad AC specifications (3.3 V , IPP_HVE = 0 )), removed the row of pad "Pull Up/Downc(3.6 V max)".</li> <li>In Table 40 (Orderable part number summary) and Figure 43, updated part numbers (changed 'PPC' to 'SPC' and 'F0' to 'F2').</li> <li>Replaced Figure 39, Figure 40, Figure 41, Figure 42 with the new versions.</li> <li>InTable 18 (Voltage regulator electrical specifications), changed the symbol of spec external decoupling capacitor from SR to C<sub>ext</sub>.</li> <li>In Figure 4, changed the ESR range in note text to 1 mW to 100 mW from 30 mW to 150 mW.</li> <li>In Section 1.5.32, "Sine Wave Generator (SWG)" removed the following text: Frequency range from 1kHz to 50kHz.</li> <li>Sine wave amplitude from 0.47 V to 2.26 V.</li> <li>In Table 20 (Current consumption characteristics)", changed symbol from 'C' to 'T', added "operating current" to the parameter and updated the maximum value for five additional RunIDD parameters.</li> <li>In Table 20 (Current consumption characteristics), changed "Conditions" from '1.2 V supplies' to '1.2 V supplies during LBIST (full LBIST configuration)' for all the parameters.</li> <li>Removed Table "SWG electrical characteristics".</li> <li>In Table 18 (Voltage regulator electrical specifications), changed the "Digital supply high voltage detector upper threshold low limit (After a destructive reset initialization phase completion)" from 1.43V to 1.38V.</li> <li>Added Table 17 (Recommended operating characteristics).</li> <li>Updated the IDD values in Table 20 (Current consumption characteristics). Changed conditions text from "1.2 supplies during LBIST (full LBIST configuration)" to "1.2 V supplies" for all the IDD parameters except I<sub>DD_LV_BIST</sub>+I<sub>DD_LV_PL</sub></li></ul>
8.1	07 May 2012	Deleted the Footer "Preliminary-Subject to Change Without Notice" label.



## Table 41. Revision history (continued)

Revision	Date	Description of changes
9	12 June 2013	Updated Table 18  — added Digital supply low voltage detector lower threshold and Digital supply low voltage detector upper threshold  — Updated Main High Voltage Power-Low Voltage Detection value to 2.93 V  Replaced IEC with ISO26262 in Section 1.1, "Document overview  Table 1-removed KGD  Table 24 modified fRC values  Updated Table 26  Updated Table 25-tconv to teval and associated footnote  Updated Table 19  — added V <sub>IH</sub> footnote  — Updated Table 31-TDRB and TELRB  Updated Table 31-TDRB and TELRB  Updated Table 18-combined ESR of external capacitor values  Updated Section 3.15.1, "Input Impedance and ADC Accuracy -replaced fc by fs  Table 6-added footnote to RESET pin about weak pull down  Updated Injection current information in Table 19-I <sub>INJ</sub> , Table 8-footnote 4  Updated Table 20 for the following:  — specified oscillator bypass mode and crystal oscillator mode  — Updated STOP and HALT mode values  — Added IDD_HV_PMU  — footnote 2, footnote 3  Added footnote vDD_HV_ADRx must always be applied and should be stable before LBIST starts. to Table 9  Added footnote to Section 5, "Ordering information  Edit changes to Section 3.5, "Electromagnetic Interference (EMI) characteristics  Updated Equation 16



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